

UNITED STATES PATENT AND TRADEMARK OFFICE

BEFORE THE PATENT TRIAL AND APPEAL BOARD

SAMSUNG ELECTRONICS CO., LTD, MICRON TECHNOLOGY, INC.,
MICRON SEMICONDUCTOR PRODUCTS, INC., and
MICRON TECHNOLOGY TEXAS LLC
Petitioner,

v.

NETLIST, INC.,
Patent Owner.

IPR2022-00996 (US11,016,918)

IPR2022-00999 (US11,232,054)



TOPICS

GROUND 1-3

Harris Does Not Receive Power Via Edge Connections

Harris Does Not Receive The Recited Signals From the Host

A POSITA Would Not Have Used the Required # of (Buck) Converters

Ground 2 ASSUMES Separate Converters To Supply Each FBDIMM-Required Voltage

A POSITA Would Not Have Replaced Harris' Redundant Power

Additional Reasons Why Dependent Claims Are Not Obvious

GROUND 4-5

The Recited "Memory Module" Means A Main Memory Module

Spiers' PCI Card Is Not a Main Memory Module

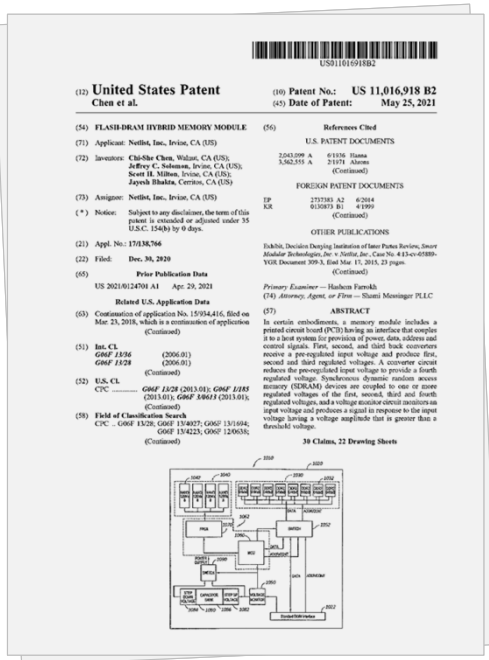
POSITA Would Not Use DDR2/DDR3 or Recited # of (Buck) Converters

Additional Reasons Why Dependent Claims Are Not Obvious

The Challenged Claims Recite PCB Interface to the Host System Memory Slot

The '918/'054 Patents

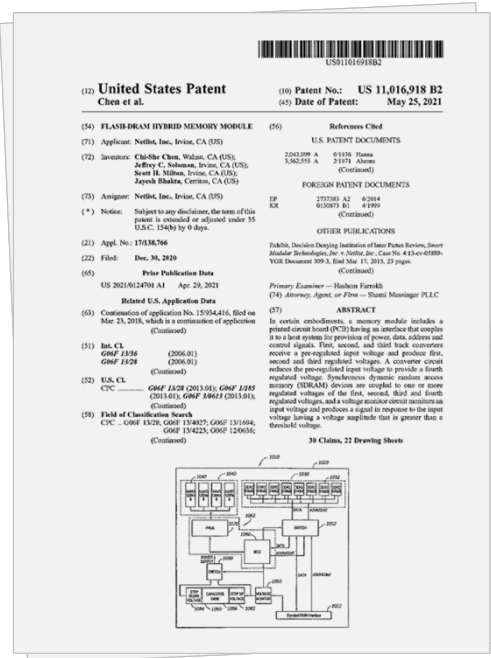
1. A memory module comprising:
a printed circuit board (PCB) having an interface configured to fit into a corresponding slot connector of a host system, the interface including a plurality of edge connections configured to couple power, data, address and control signals between the memory module and the host system;



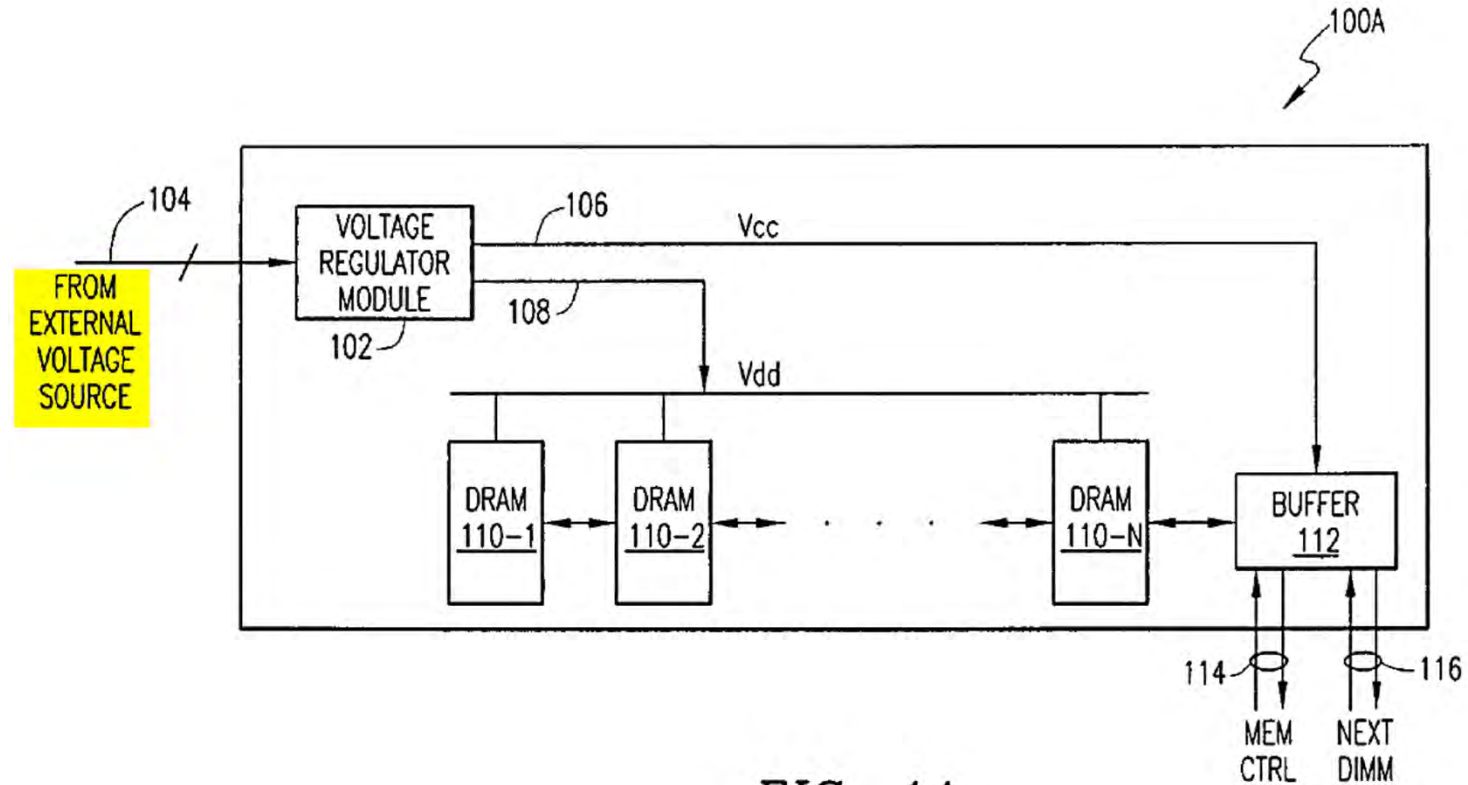
The PCB Interface (to Host Memory Slot) Has Edge Connections Coupling Power/Data/Address/Control From Host to the Memory Module

The '918/'054 Patents

1. A memory module comprising: a printed circuit board (PCB) having an interface configured to fit into a corresponding slot connector of a host system, the interface including a plurality of edge connections configured to couple power, data, address and control signals between the memory module and the host system;



Harris's Memory Module

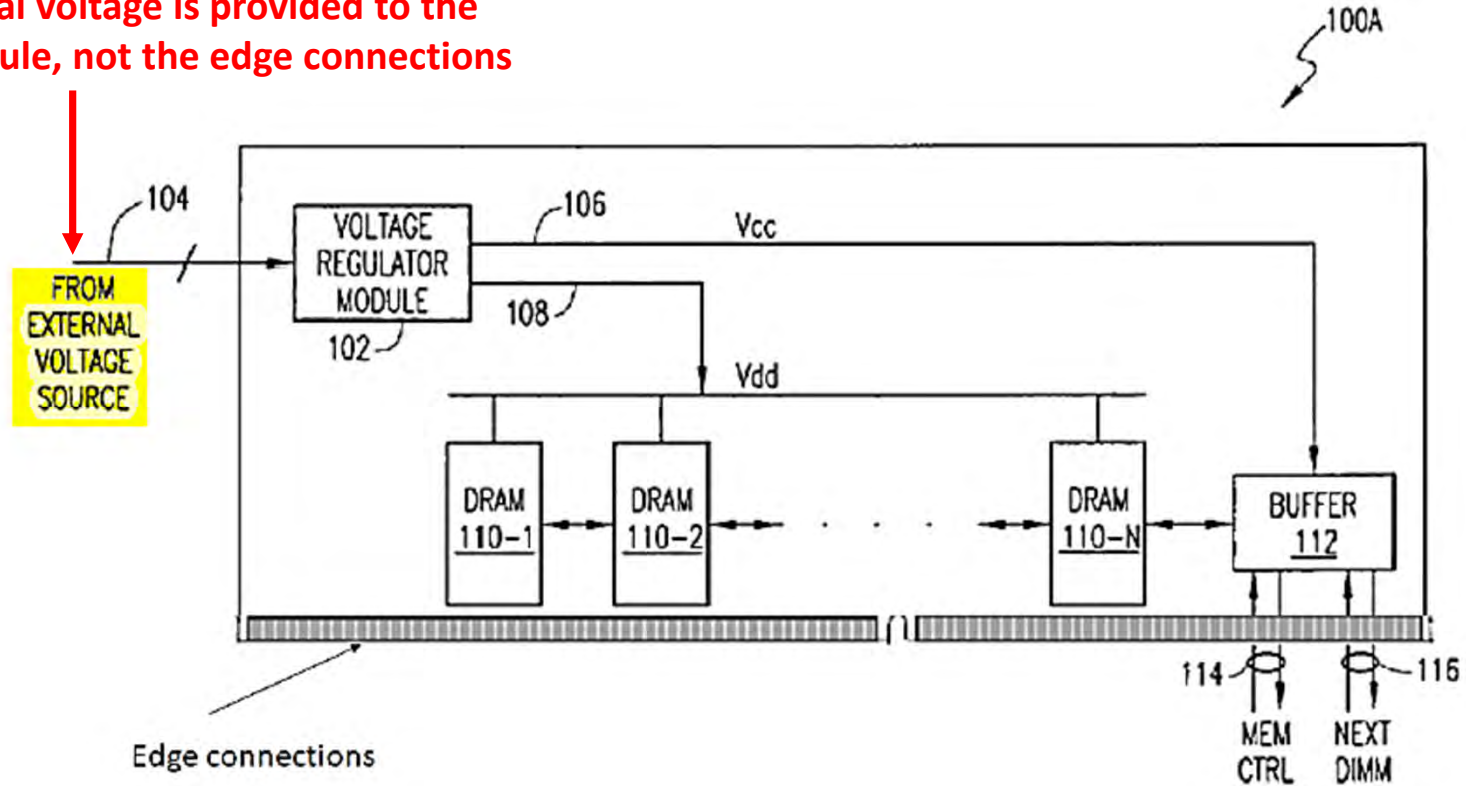


EX1023 (Harris), FIG. 1A.

FIG. 1A

Harris Does Not Provide Power to the Memory Module Via Memory Slot Edge Connections

Harris' external voltage is provided to the side of the module, not the edge connections



EX1023 (Harris), FIG. 1A (modified/annotated).

Petitioner Admits Location of Control/Data/Address Edge Connections on Harris

Harris, below, illustrates memory boards 306 coupled to the host system *only* through their edge connections (red), meaning power would also come from those edge connections:

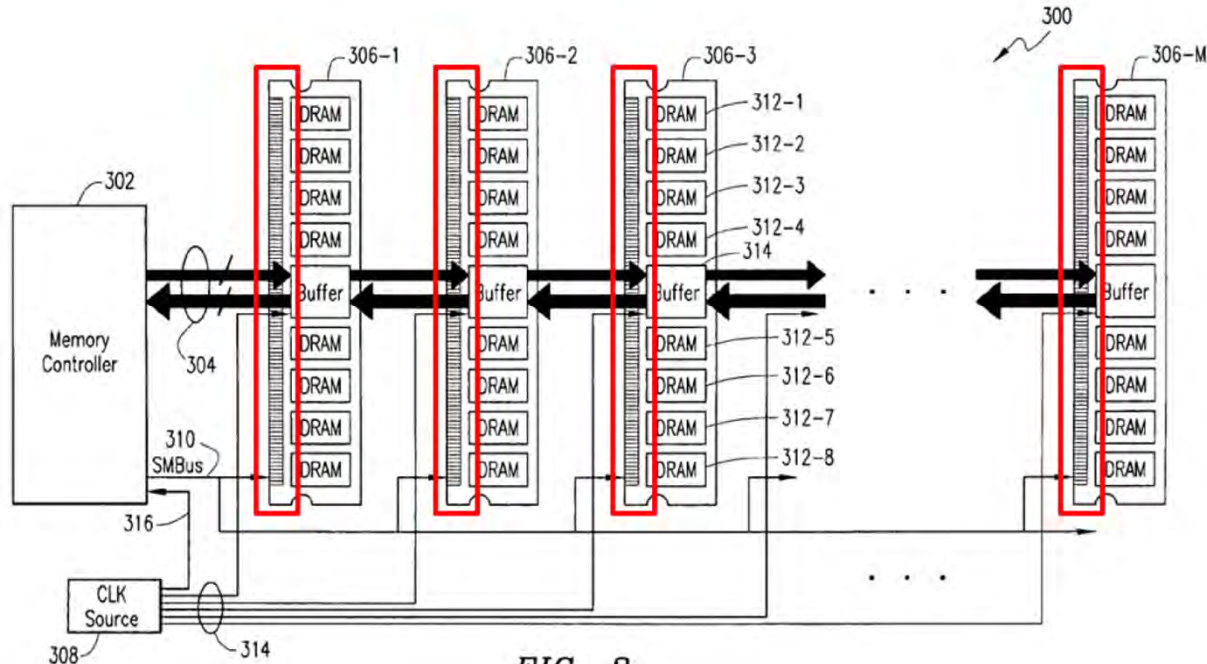
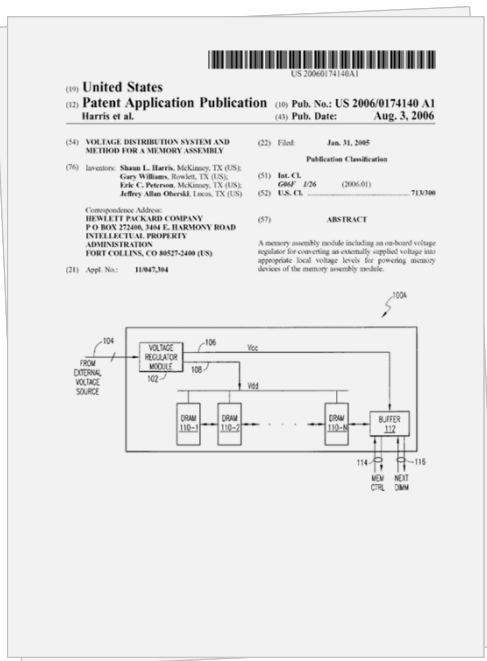


FIG. 3

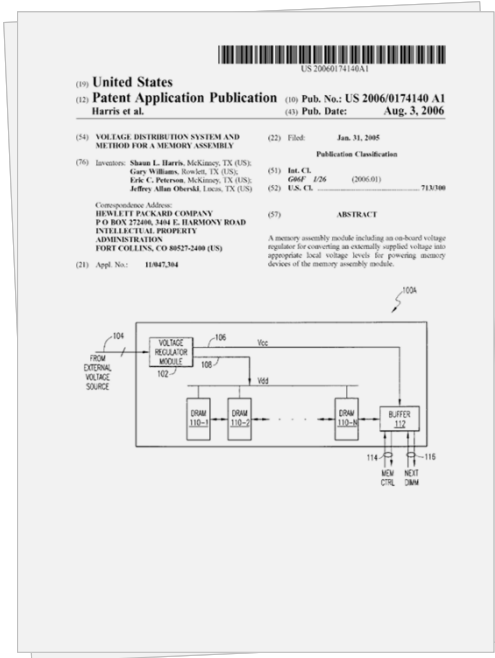
Harris Expressly Replaces The Power Supply Pins On The Edge Connection Interface



[0012] By way of example, a standard FBD module requires 28 V_{dd} pins (for DRAM devices) and 8 V_{cc} pins (for buffer and logic) and associated Ground returns, resulting in a total of 72 pins that provide a power supply interface for up to two x4 DRAM ranks (36 devices) and buffer logic. A voltage-independent FBD design incorporating the embodiment of FIG. 1A is capable of replacing these power supply interface pins with as few as six +12V pins (from an external voltage source), with local conversion to V_{dd} (to DRAM) and V_{cc} (to buffer/logic) being added. Alternatively, using

EX1023 (Harris), [0012]

Harris Expressly Replaces The Power Supply Interface Pins On The Edge Connections

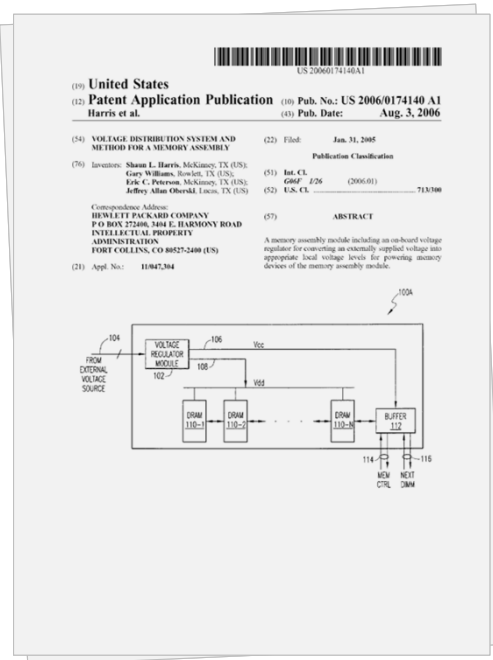


[0012] By way of example, a standard FBD module requires 28 V_{dd} pins (for DRAM devices) and 8 V_{cc} pins (for buffer and logic) and associated Ground returns, resulting in a total of 72 pins that provide a power supply interface for up to two x4 DRAM ranks (36 devices) and buffer logic. A voltage-independent FBD design incorporating the embodiment of FIG. 1A is capable of replacing these power supply interface pins with as few as six +12V pins (from an external voltage source), with local conversion to V_{dd} (to DRAM) and V_{cc} (to buffer/logic) being added. Alternatively, using

EX1023 (Harris), [0012]

Not “interface” pins

Harris Expressly Eliminates System Board Power Supply



[0019] Based on the foregoing Detailed Description, it should be appreciated that an implementation of the embodiments described herein thus provides a **technology-independent voltage distribution scheme for memory devices wherein system board power supply and associated voltage plane(s) are eliminated.** Accordingly, power supply design's complexity as well as the cost of memory-specific power distribution are reduced. Cost savings may include, for example, **elimination of system-board-specific power supply or regulator output,** associated bypass capacitor arrangements, heavy etch or power planes. Also, under the tech-

EX1023 (Harris), [0019]

If 12V were supplied from the motherboard, it would also be “system-board-specific power supply”

12V is “Unregulated”; Unregulated Voltage Never Routed Through Interface

respectively. Preferably, a high-frequency switching voltage converter capable of generating tightly-controlled voltage levels may be implemented as the on-board VRM 102 for purposes of the present patent disclosure. For instance, multi-phase synchronous Pulse-Width Modulated (PWM) controllers, Low Drop-Out (LDO) controllers, et cetera, that are capable of accepting unregulated supply voltages in a broad range may be configured to operate as a local voltage supply for the memory module 100A.

EX1023 (Harris), [0010]

Dr. Mangione-Smith:

- Unregulated voltage never provided through interface pins or system board
- Harris does not describe alternative locations for unregulated or regulated voltage pins

Ex. 2031, ¶ 64

12V is “Unregulated”; Unregulated Voltage Never Routed Through Interface

[0016] FIG. 2 is a flowchart of a voltage distribution method for a memory module according to one embodiment. As set forth at block 202, voltage is supplied to a memory board assembly from an external source, e.g., an unregulated source generating fairly high voltages (illustratively, at +12V) with a wide tolerance. The voltage distribution method then involves locally converting the supply voltage using an on-board VRM to generate appropriate levels of voltage for powering on-board memory devices. As pointed out earlier, the local voltage levels preferably depend on the application, e.g., DRAM type and technology. Optionally, a redundant VRM may be provided as part of the voltage distribution methodology, wherein the redundant VRM is operable to power a redundant voltage path with respect to the on-board memory devices and associated buffer/logic components (block 206).

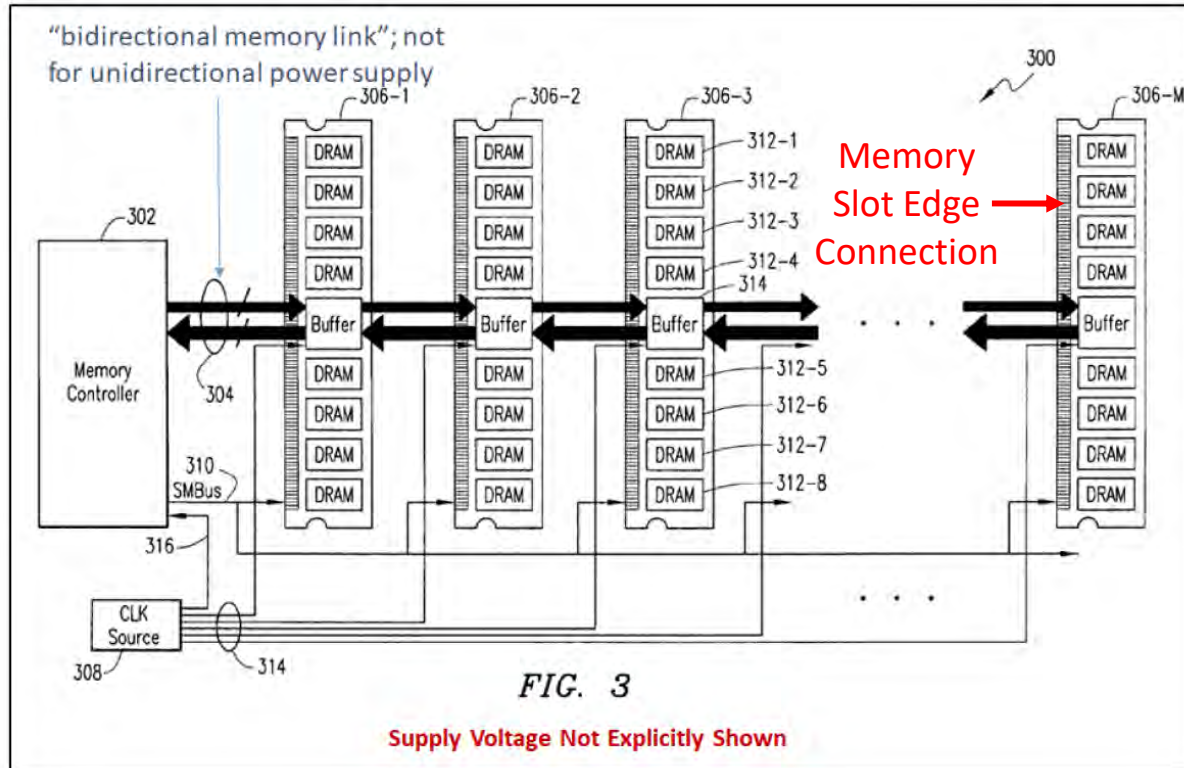
EX1023 (Harris), [0016]

Dr. Mangione-Smith:

- Unregulated voltage never provided through interface pins or system board
- Harris does not describe alternative locations for unregulated or regulated voltage pins

Ex. 2031, ¶ 64

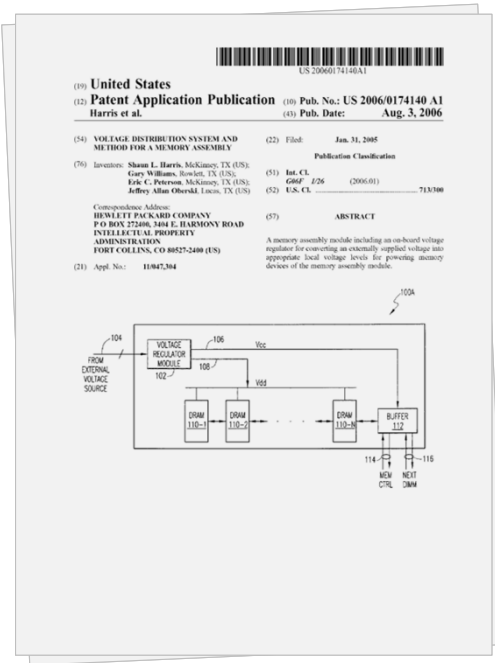
Harris Does Not Provide Power to the Memory Module Via Memory Slot Edge Connections



EX1023 (Harris), Fig. 3 (annotated).

Wolfe: “Figure 3 is a block diagram and it does not show the power supplies”.

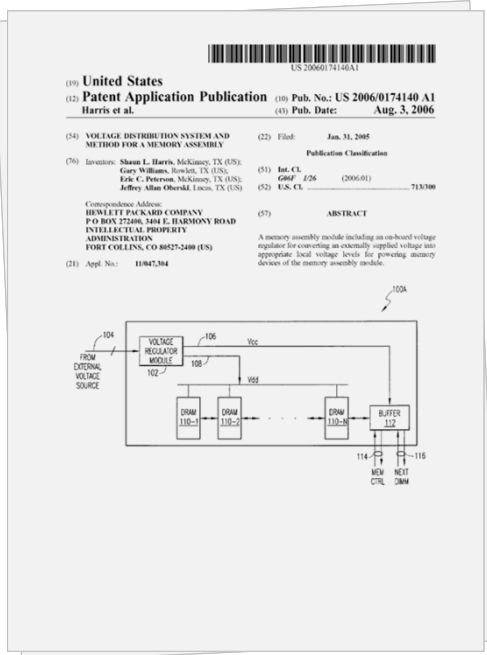
If Interface Pins Supplied Power in Harris, Figure 3 Would Depict



[0017] FIG. 3 is a block diagram of an exemplary memory assembly 300 according to one embodiment. A memory controller 302 is operable to drive a bidirectional memory link 304 to which a plurality of memory boards 306-1 through 306-M are coupled in a daisy-chain fashion at their respective buffers. As exemplified by the memory board 306-3, each memory board includes eight DRAM devices 312-1 through 312-8, with a buffer component 314. A clock source 308 is operable to drive a plurality of clock signals to the memory boards via a clock bus 314. Additionally, the clock source 308 is also operable to drive a clock signal 316 to the memory controller 302 for providing a time base with respect to its operations. A system management bus (SM bus) 310 coupled to the memory boards 306-1 through 306-M is driven by the memory controller 302. Although not explicitly shown in this FIGURE, each memory board also receives a supply voltage that is locally converted by an on-board VRM for powering the DRAM and buffer components therein. In one arrangement, the supply voltage may be sourced from the memory controller 302 or from a separate voltage source.

EX1023 (Harris), [0017]

Harris Touts the Benefits of Eliminating System-Board Power Supply (*i.e.*, an Internal Voltage Source)



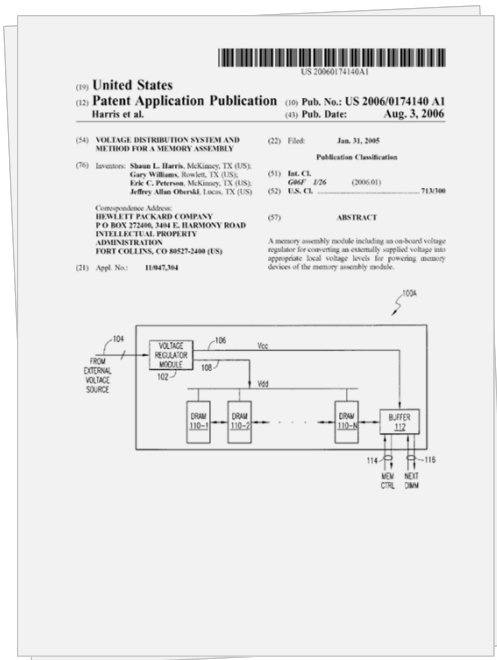
[0019] Based on the foregoing Detailed Description, it should be appreciated that an implementation of the embodiments described herein thus provides a technology-independent voltage distribution scheme for memory devices wherein system board power supply and associated voltage plane(s) are eliminated. Accordingly, power supply design's complexity as well as the cost of memory-specific power distribution are reduced. Cost savings may include, for example, elimination of system-board-specific power supply or regulator output, associated bypass capacitor arrangements, heavy etch or power planes. Also, under the tech-

EX1023 (Harris), [0019]

[0020] Because voltage-independent embodiments disclosed herein can provide upgradeability and extensibility without changing system board power distribution, transitioning to newer DRAM technologies (e.g., at lower operating voltages) is more cost-effective as well as simpler to implement. Further, the embodiments are amenable to dual

EX1023 (Harris), [0020]

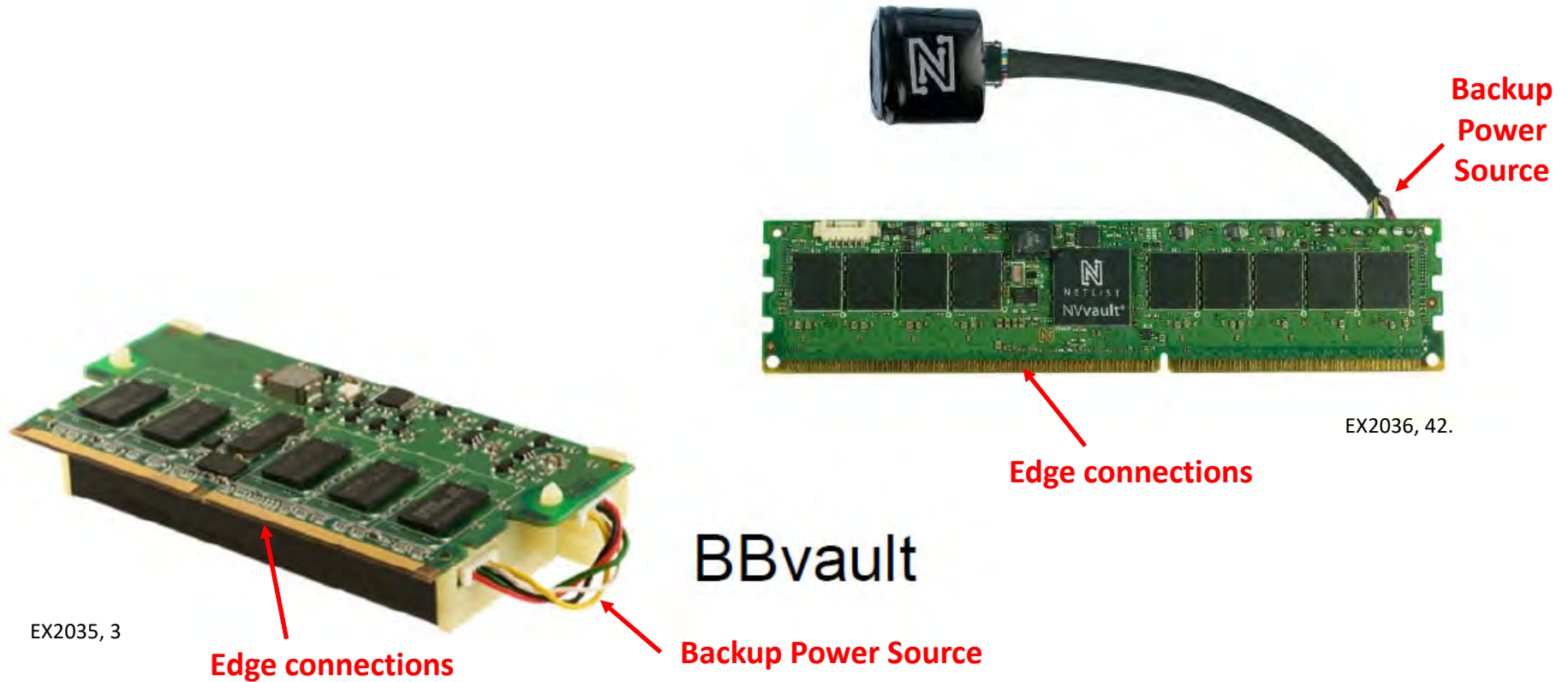
Avoiding Interface Pins for Voltage Allows System Board to Host Evolving Technology



[0002] Such power supply concerns assume particular significance in advanced memory designs currently being implemented. Additionally, rising bus and processing speeds are also demanding newer memory architectures that deliver improved performance by increasing clock frequencies and available bandwidth without pushing up power consumption. To cope with power requirements, industry standard memory modules, e.g., Dual In-line Memory Modules (DIMMs) populated with dynamic random access memory (DRAM) devices, are provided with power supply rails (on a relatively large number of pins) that are powered from system board or main board voltage sources, and are specific to the memory technology. As the performance of the DRAM technology goes up, and timing margins shrink, it is becoming increasingly more difficult for the system board sources to provide tightly regulated power for the DRAM cores as well as input/output (I/O) interface buffers. Furthermore, each generation of DIMM/DRAM technology requires a different power supply which keeps getting lower (e.g., 3.3V, 2.5V, 1.8V, 1.5V and beyond), thereby making it difficult to mix memory technologies on a system board, or provide upgrades to next generation DRAM technology in a cost-effective manner. One skilled in the art will recognize, in addition, that these issues are particularly significant for systems that are deployed in infrastructure with an expected product life of over five years or so since it is difficult to accurately design a system that will be optimized over such a long life span.

EX1023 (Harris), [0002]

Providing Power to Memory Modules Via Non-Edge Connections Was Known



The Claims Are Not Satisfied By Merely Supplying Power from the Host



reformulate its challenge now. Thus, Samsung must show that Harris expressly or inherently discloses a memory module receiving power via its edge connections.

Samsung has not made such a showing, or even that it would be obvious, given Harris's rejection of conventional approaches by eliminating system-board-specific power supply and associated power planes, in order to improve upgradeability and extensibility, and to lower costs. EX1023, [0002], [0019]-[0020]; EX2031, ¶¶26-27, 58, 61-62, 68.

TOPICS

GROUND 1-3

Harris Does Not Receive Power Via Edge Connections

Harris Does Not Receive The Recited Signals From the Host

A POSITA Would Not Have Used the Required # of (Buck) Converters

Ground 2 ASSUMES Separate Converters To Supply Each FBDIMM-Required Voltage

A POSITA Would Not Have Replaced Harris' Redundant Power

Additional Reasons Why Dependent Claims Are Not Obvious

GROUND 4-5

The Recited "Memory Module" Means A Main Memory Module

Spiers' PCI Card Is Not a Main Memory Module

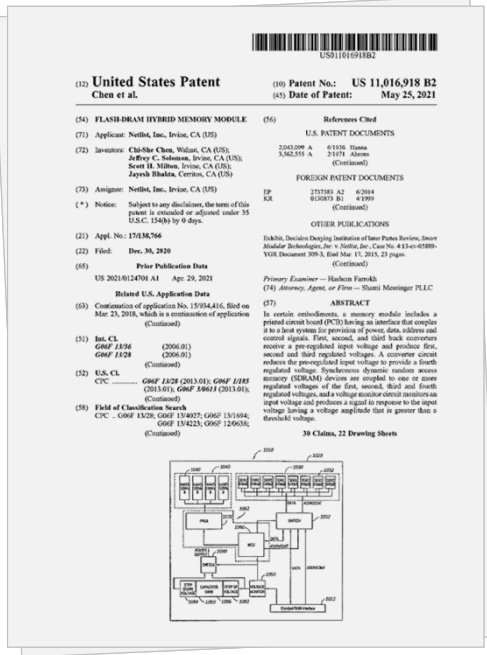
POSITA Would Not Use DDR2/DDR3 or Recited # of (Buck) Converters

Additional Reasons Why Dependent Claims Are Not Obvious

Claimed PCB Interface Receives Data, Address, and Control Signals From the Host

The '918/'054 Patents

1. A memory module comprising:
a printed circuit board (PCB) having an interface configured to fit into a corresponding slot connector of a host system, the interface including a plurality of edge connections configured to couple power, data, address and control signals between the memory module and the host system;



FBDIMM – Advanced Memory Buffer (AMB)

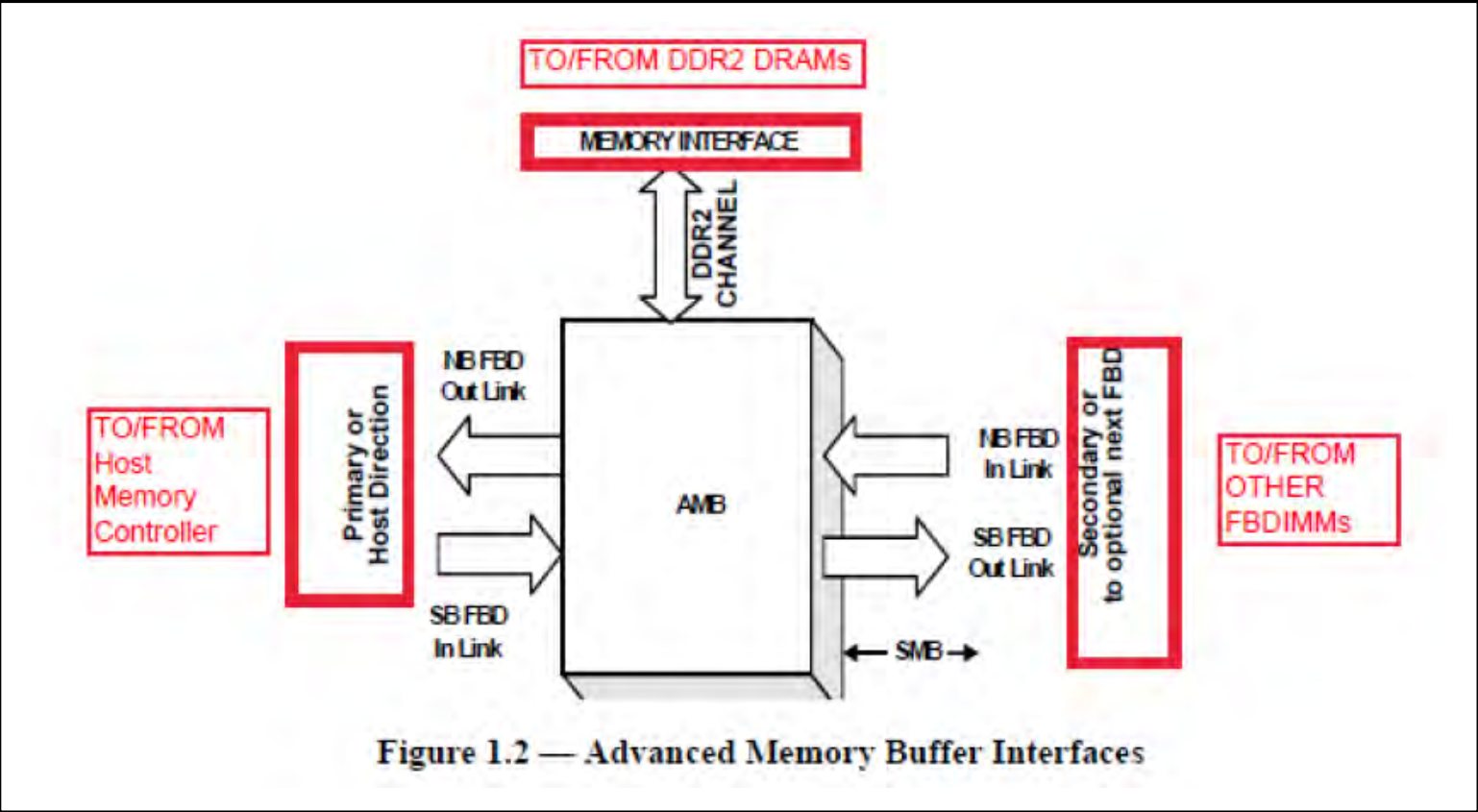


Figure 1.2 — Advanced Memory Buffer Interfaces

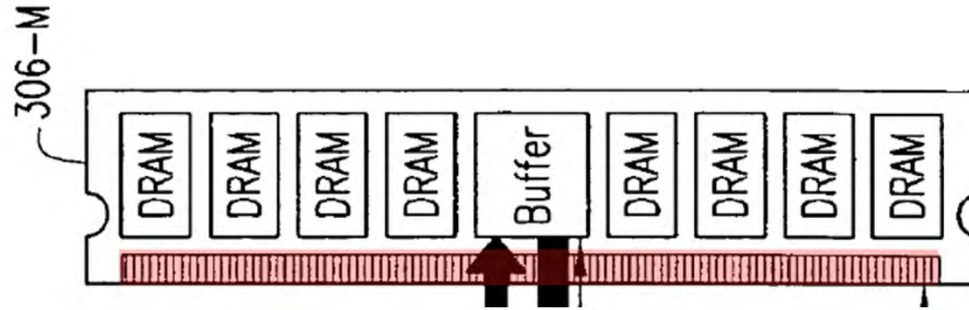
EX1027 at 4 (annotated).

The Petition Relies on Signals Generated On-Module By The AMB, Not Signals Received From The Host

The Petition

SAMSUNG

Grounds 1A-1C teach the PCB “having an interface configured to fit into a corresponding slot connector of a host system, the interface including a plurality of edge connections” (sometimes called “pins”) as shown above for [1.a] and reprinted below from Harris’s Figure 3, EX1023, ¶¶[0002, 12-13, 19], Figs. 3-4; EX1028, pp.38, 84; EX1003, ¶¶226-227.



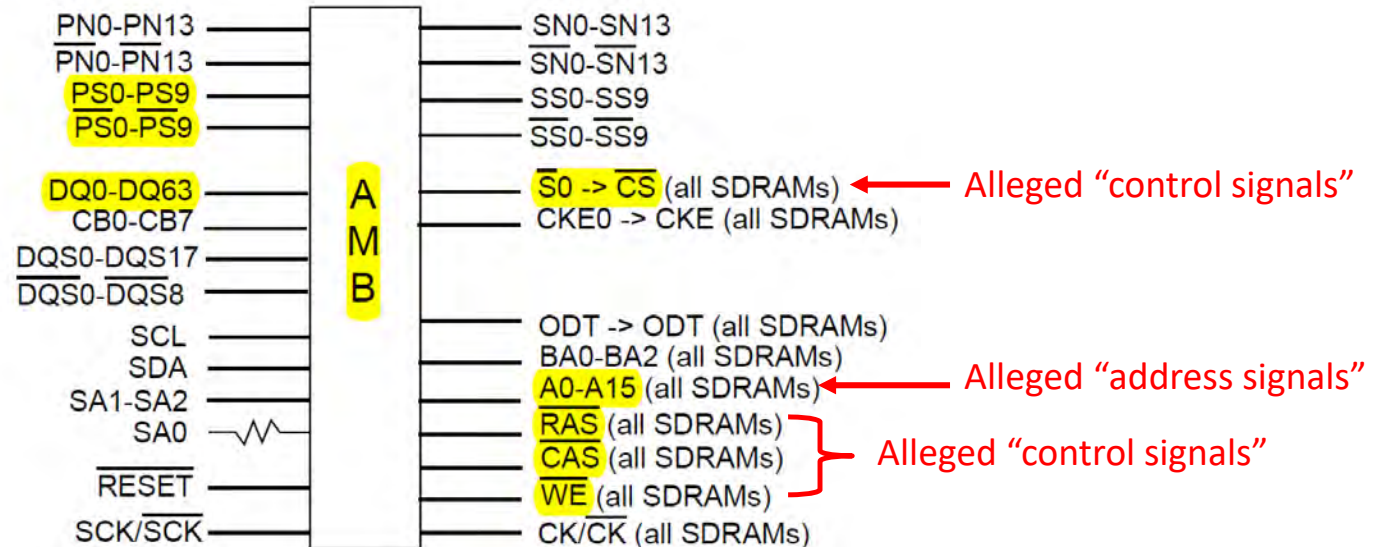
Grounds 1A-1C teach the edge connections in Harris, consistent with JEDEC’s FBDIMM Standards, are “configured to couple power, data, address and control signals between the memory module and the host system”:

The Petition Relies on Signals Generated On-Module By The AMB, Not Signals Received From The Host

The Petition

SAMSUNG

- “address”: e.g., **A0-A15 (below)**; *id.* (“address”)
- “control”: e.g., **RAS, CAS, WE, CS (below)**; *id.* & Fig.1A (114, “CTRL”). These “control” signals together can form a “command.”



AMB Specification Distinguishes Data from Signals

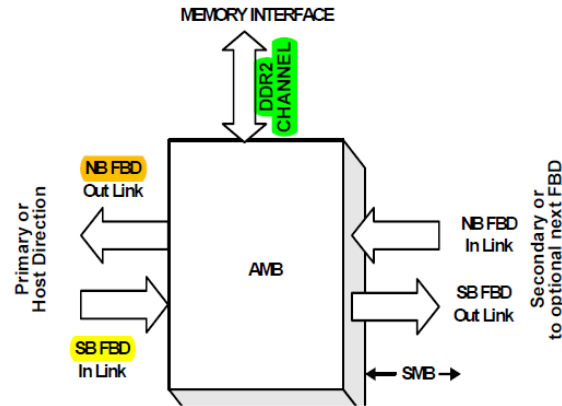


Figure 1.2 — Advanced Memory Buffer Interfaces

1.4.1 FBD High-Speed Differential Point-to-Point Link (at 1.5 V) Interfaces

The Advanced Memory Buffer supports one FBD Channel consisting of two bidirectional link interfaces using high-speed differential point-to-point electrical signaling.

The southbound input link is 10 lanes wide and carries commands and write data from the host memory controller or the adjacent DIMM in the host direction. The southbound output link forwards this same data to the next FBD.

The northbound input link is 13 to 14 lanes wide and carries read return data or status information from the next FB DIMM in the chain back towards the host. The northbound output link forwards this information back towards the host and multiplexes in any read return data or status information that is generated internally.

1.4.2 DDR2 Channel

The DDR2 channel on the Advanced Memory Buffer supports direct connection to DDR2 SDRAMs. The DDR2 channel supports two ranks of eight banks with 16 row/column request, 64 data signals, and eight check-bit signals. There are two copies of address and command signals to support DIMM routing and electrical requirements. Four-transfer bursts are driven on the data and check-bit lines at 800 MHz.

“Data” from controller to interface

“Signal” from AMB to DRAM

Harris+FBDIMM Module Receives Serialized Encoded Information

No pins on
FBDIMM
module to
receive address
or control
signals from
host

Pin Name	Pin Description	Count
	FB-DIMM Channel Signals	99
SCK	System Clock Input, positive line	1
$\overline{\text{SCK}}$	System Clock Input, negative line	1
PN[13:0]	Primary Northbound Data, positive lines	14
$\overline{\text{PN}}[13:0]$	Primary Northbound Data, negative lines	14
PS[9:0]	Primary Southbound Data, positive lines	10
$\overline{\text{PS}}[9:0]$	Primary Southbound Data, negative lines	10
SN[13:0]	Secondary Northbound Data, positive lines	14
$\overline{\text{SN}}[13:0]$	Secondary Northbound Data, negative lines	14
SS[9:0]	Secondary Southbound Data, positive lines	10
$\overline{\text{SS}}[9:0]$	Secondary Southbound Data, negative lines	10
FBDRES	To an external precision calibration resistor connected to Vcc	1

EX1027, 4.

Harris+FBDIMM Module Generates The Relied-on Address and Control Signals On-Module

Address and Control Signals Relied On By Petitioner Are Generated by AMB

DDR2 Interface Signals		175
DQS[8:0]	Data Strobes, positive lines	9
$\overline{\text{DQS}}[8:0]$	Data Strobes, negative lines	9
DQS[17:9]/DM[8:0]	Data Strobes (x4 DRAM only), positive lines. These signals are driven low to x8 DRAM on writes.	9
$\overline{\text{DQS}}[17:9]$	Data Strobes (x4 DRAM only), negative lines	9
DQ[63:0]	Data	64
CB[7:0]	Checkbits	8
A[15:0]A, A[15:0]B	Addresses. A10 is part of the pre-charge command	32
BA[2:0]A, BA[2:0]B	Bank Addresses	6
$\overline{\text{RASA}}$, $\overline{\text{RASB}}$	Part of command, with $\overline{\text{CAS}}$, $\overline{\text{WE}}$, and $\overline{\text{CS}}[1:0]$.	2
$\overline{\text{CASA}}$, $\overline{\text{CASB}}$	Part of command, with $\overline{\text{RAS}}$, $\overline{\text{WE}}$, and $\overline{\text{CS}}[1:0]$.	2
$\overline{\text{WEA}}$, $\overline{\text{WEB}}$	Part of command, with $\overline{\text{RAS}}$, $\overline{\text{CAS}}$, and $\overline{\text{CS}}[1:0]$.	2
ODTA, ODTB	On-die Termination Enable	2
CKE[1:0]A, CKE[1:0]B	Clock Enable (one per rank)	4
$\overline{\text{CS}}[1:0]A$, $\overline{\text{CS}}[1:0]B$	Chip Select (one per rank)	4
CLK[3:0]	CLK[1:0] used on 9 and 18 device DIMMs, CLK[3:0] used on 36 device DIMMs. CLK[3:2] should be output disabled when not in use.	4
$\overline{\text{CLK}}[3:0]$	Negative lines for CLK[3:0]	4
DDRC_C14	DDR Compensation: Common return pin for DDRC_B18 and DDRC_C18.	1
DDRC_B18	DDR Compensation: Resistor connected to common return pin DDRC_C14	1
DDRC_C18	DDR Compensation: Resistor connected to common return pin DDRC_C14	1
DDRC_B12	DDR Compensation: Resistor connected to V_{SS}	1
DDRC_C12	DDR Compensation: Resistor connected to V_{DD}	1

Fully-Buffered DIMM Memory Architectures: Understanding Mechanisms, Overheads and Scaling

Brinda Ganesh[†], Aamer Jaleel[‡], David Wang[†], and Bruce Jacob[†]

[†]University of Maryland, College Park, MD

[‡]VSSAD, Intel Corporation, Hudson, MA

{brinda, blj}@eng.umd.edu

systems, which we shall refer to as DDRx systems. The serial interface is split into two uni-directional buses, one for read traffic (northbound channel) and another for write and command traffic (southbound channel), as shown in Fig 1. FBDIMMs adopts a packet-based protocol that bundles commands and data into frames that are transmitted on the channel and then converted to the DDRx protocol by the AMB.

EX2040 at 1.

Dr. Wolfe Testified That The AMB Receives Address/Control Information

Andrew Wolfe
Samsung's Expert



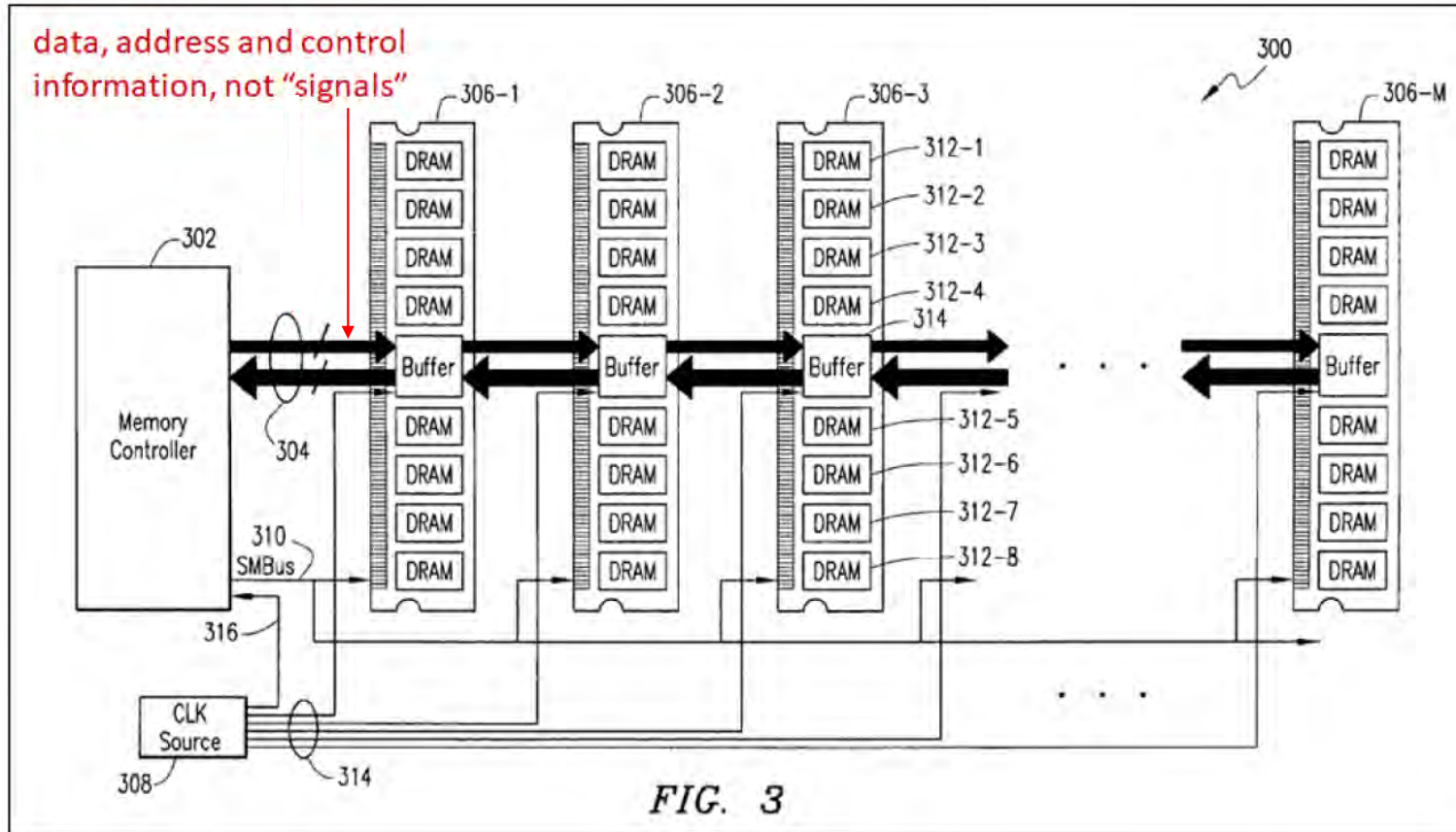
SAMSUNG

Q. And the address and the control information are sent as serialized packets; is that correct?

A. Serialized packets? They -- yes. They are -- the information is sent to the advanced memory buffer in the form of serialized packets.

EX2030, 10:7-11.

Harris+FBDIMM Module Received Data, Address, and Control Information



TOPICS

GROUND 1-3

Harris Does Not Receive Power Via Edge Connections

Harris Does Not Receive The Recited Signals From the Host

A POSITA Would Not Have Used the Required # of (Buck) Converters

Ground 2 ASSUMES Separate Converters To Supply Each FBDIMM-Required Voltage

A POSITA Would Not Have Replaced Harris' Redundant Power

Additional Reasons Why Dependent Claims Are Not Obvious

GROUND 4-5

The Recited "Memory Module" Means A Main Memory Module

Spiers' PCI Card Is Not a Main Memory Module

POSITA Would Not Use DDR2/DDR3 or Recited # of (Buck) Converters

Additional Reasons Why Dependent Claims Are Not Obvious

Petitioner's Proposed Voltage Mappings for '918 Patent Based on Harris+FBDIMM

Recited Voltages of Claim 1

a first buck converter configured to provide a first regulated voltage having a first voltage amplitude;
 a second buck converter configured to provide a second regulated voltage having a second voltage amplitude;
 a third buck converter configured to provide a third regulated voltage having a third voltage amplitude;
 a converter circuit configured to provide a fourth regulated voltage having a fourth voltage amplitude; and

Voltage Mappings (Grounds 1-3)			
	<u>A</u>	<u>B</u>	<u>C</u>
<i>“first”</i> :	V_{DD} or $V_{DDQ} = 1.8V$	V_{DD} , V_{DDQ} , or $V_{DDL} = 1.8V$	V_{DD} , V_{DDQ} , or $V_{DDL} = 1.8V$
<i>“second”</i> :	V_{CC} or $V_{CCFBD} = 1.5V$	$V_{CC} = 1.5V$	V_{CC} or $V_{CCFBD} = 1.5V$
<i>“third”</i> :	$V_{DDL} = 1.8V$	$V_{CCFBD} = 1.5V$	$V_{TT} = 0.9V$
<i>“fourth”</i> :	$V_{DDSPD} = 3.3V$	$V_{DDSPD} = 3.3V$	$V_{DDSPD} = 3.3V$

Petitioner's Proposed Voltage Mappings for '054 Patent Based on Harris+FBDIMM

Recited Voltages of Claim 1

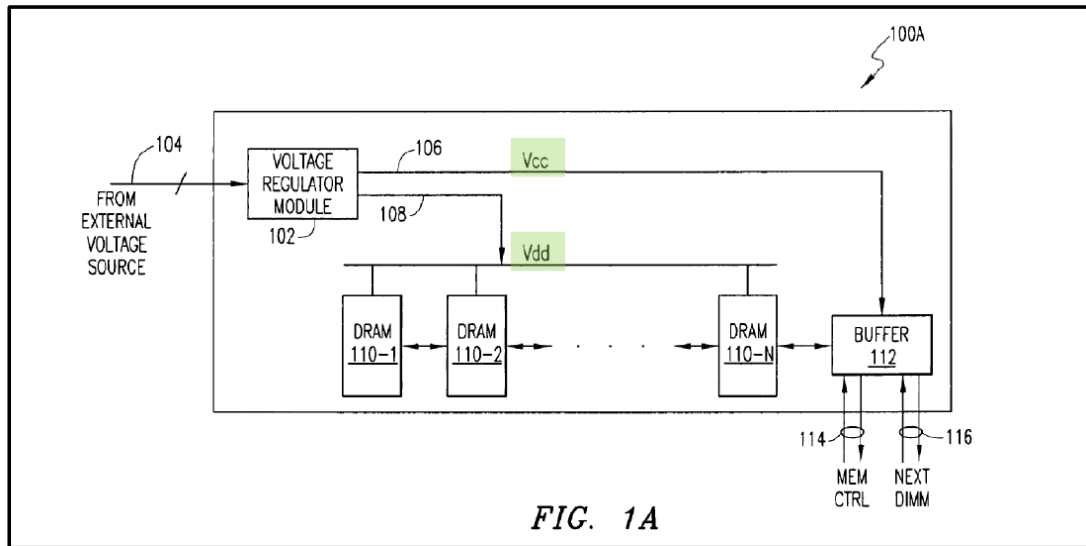
a voltage conversion circuit coupled to the PCB and configured to provide at least three regulated voltages, wherein the voltage conversion circuit includes at least three buck converters each of which is configured to produce a regulated voltage of the at least three regulated voltages;

Voltage Mappings (Grounds 1-3)			
	<u>A</u>	<u>B</u>	<u>C</u>
<i>"first"</i> :	V_{DD} or $V_{DDQ} = 1.8V$	V_{DD} or $V_{DDQ} = 1.8V$	V_{DD} or $V_{DDQ} = 1.8V$
<i>"second"</i> :	V_{CC} or $V_{CCFBD} = 1.5V$	$V_{CC} = 1.5V$	V_{CC} or $V_{CCFBD} = 1.5V$
<i>"third"</i> :	$V_{DDL} = 1.8V$	$V_{CCFBD} = 1.5V$	$V_{TT} = 0.9V$

Harris Proposed Only Two Voltages Generated On-Module In Face of DDR Specifications, Including FBDIMMs

“Harris further discloses that when implemented as the on-board VRM 102, the single “high-frequency switching voltage converter” converts the externally supplied voltage “into appropriate local voltage levels that power ... the V_{dd} and V_{cc} paths 108, 106, respectively.”

EX2031 (Mangione-Smith Declaration), ¶179.



[0009] In the drawings, like or similar elements are designated with identical reference numerals throughout the several views thereof, and the various elements depicted are not necessarily drawn to scale. Referring now in particular to FIG. 1A, depicted therein is a block diagram of a voltage distribution system for a memory module 100A according to one embodiment. At the outset, those skilled in the art should appreciate that although the voltage distribution system is exemplified with respect to memory module 100A which may be embodied as a memory board assembly operable in a computer system, the teachings of the present patent disclosure may be implemented in any electronic system as will be set forth in detail hereinbelow. One or more memory devices 110-1 through 110-N are provided as part of the memory module 100A, each receiving a first voltage path 108, typically referred to as a V_{dd} path, that may be energized to appropriate voltage levels depending on the type, functionality, and design of the memory devices, e.g., from about 0.5V to 3.5V or more. In one configuration, the memory module 100A may be implemented as a Dual In-line Memory Module (DIMM) wherein each of the memory devices 110-1 through 110-N comprises a Double Data Rate (DDR) dynamic random access memory (DRAM) device having a particular density, e.g., 256 Mb, 512 Mb, 1 Gb or 2 Gb, etc. Also, the memory devices can be of any known or heretofore unknown DDR type, e.g., DDR2 (operable with 1.8 V), DDR3 (operable with 1.35V to 1.5V), and the like. Further, the DIMM configuration of an exemplary memory module may include unbuffered DIMMs, registered DIMMs (RDIMMs), or fully buffered DIMMs (FBDs), and may be configured as having one or more ranks (e.g., 2, 4, 8, or more). In the illustrated embodiment of FIG. 1A, for instance, the DIMM configuration of the memory module 100A is exemplified as a fully buffered DIMM wherein a buffer/logic component 112 is provided for buffering command/address (C/A) space as well as data space at least for a portion of the memory devices 110-1 through 110-N. A bidirectional memory controller interface path 114 as well as a second voltage path 106, typically referred to as a V_{cc} path, are provided with respect to the buffer component 112, wherein the V_{cc} path may be energized to appropriate voltage levels depending on the buffer and DIMM technology, e.g., from about 0.5V to 3.5V or more. In addition, where multiple memory assemblies are daisy-chained on a single memory controller channel, a suitable daisy-chain interface 116 is provided for coupling the buffer component 112 to a next memory module.

V_{dd} on board

Targets DDR-Standardized Devices

V_{cc} on board

Petitioner's Expert Confirms That a POSA Reading Harris Would Understand And Comply With JEDEC Standards

158. A Skilled Artisan would have been familiar with memory systems and corresponding standards, including the JEDEC standards for memory devices and memory modules already standardized, or in the process of being standardized, at the time. For example, Harris discloses Double Data Rate (DDR) memory devices, including DDR2 and DDR3 memories. *See* Ex. 1023 at [0009], [0011]. A Skilled Artisan would have understood that these memories were already standardized. *Supra* ¶139 (DDR SDRAM), ¶140 (DDR2 SDRAM), ¶141 (FBDIMM), ¶142 (DDR3 SDRAM). Harris also discloses Dual In-Line Memory Modules (DIMMs), including unbuffered DIMMs (UDIMMs), registered DIMMs (RDIMMs), and fully-buffered DIMMs (FBDIMMs). *See* Ex. 1023 at [0009]. A Skilled Artisan would have understood that these memory modules were already standardized,

EX1003 (Wolfe), ¶158

161. In my view, a Skilled Artisan would have been familiar with the relevant JEDEC memory standards, including the FBDIMM Standards. Even if one were to argue that Harris does not sufficiently disclose a memory module in accordance with the teachings of these JEDEC memory standards or that a Skilled Artisan would not be familiar with the FBDIMM Standards, it would have been obvious to a Skilled Artisan, who would have been motivated to implement Harris's module using memory devices and/or buffer devices standardized by JEDEC, including the FBDIMM Standards, as explained below.

EX1003 (Wolfe), ¶161

In FBDIMM Specification, One Source For VCC/VCCFD; One Source For VDD, VDDQ, VDDL

DIMM Connector Pin Description

Pin Name	Pin Description	Count
SCK	System Clock Input, positive line ¹	1
SCR	System Clock Input, negative line ¹	1
PN[13:0]	Primary Northbound Data, positive lines	14
PN[13:0]	Primary Northbound Data, negative lines	14
PS[9:0]	Primary Southbound Data, positive lines	10
PS[9:0]	Primary Southbound Data, negative lines	10
SN[13:0]	Secondary Northbound Data, positive lines	14
SN[13:0]	Secondary Northbound Data, negative lines	14
SS[9:0]	Secondary Southbound Data, positive lines	10
SS[9:0]	Secondary Southbound Data, negative lines	10
SCL	Serial Presence Detect (SPD) Clock Input	1
SDA	SPD Data Input / Output	1
SA[2:0]	SPD Address Inputs, also used to select the DIMM number in the AMB	3
VID[1:0]	Voltage ID: These pins must be unconnected for DDR2-based Fully Buffered DIMMs VID[0] is V _{DD} value: OPEN = 1.8 V, GND = 1.5 V; VID[1] is V _{CC} value: OPEN = 1.5 V, GND = 1.2 V	2
RESET	AMB reset signal	1
RFU	Reserved for Future Use ²	16
V _{CC} and V _{CCFB}	V _{CC} AMB Core Power and AMB Channel Interface Power (1.5 Volt)	8
V _{DD}	DRAM Power and AMB DRAM I/O Power (1.8 Volt)	24
V _{TT}	DRAM Address/Command/Clock Termination Power (V _{DD} /2)	4
V _{DDSPD}	SPD Power	1
V _{SS}	Ground	80

V_{CC} and V_{CCFB}
V_{DD}, V_{DDQ} and V_{DDL}

88. It was also generally known that, for the “VDD (VDD, VDDL, VDDQ)” power supply, “[t]he DDR2 device requires a single power source for primary supply voltages in order to ensure that all voltage levels track each other, especially during the power ramp.” EX2006 ([Micron TN-47-05](#)), 4. It was known that “VDD (device core), VDDL (device DLL), and VDDQ (device I/O) share a single power plane with the interconnecting pins labeled as VDD,” and that “[a]t the initial power-up, all supply power should be stable and meet specification within ≤10ms.” Id. Meeting such stability and timing specifications is made possible when the voltages (e.g., V_{DD}, V_{DDL} and V_{DDQ}) are driven from a single power converter instead of from separate converters.

EX2031 (Mangione-Smith Declaration), ¶188.

EX2031 (Mangione-Smith Declaration), ¶188.

FBDIMM Uses Single Source For VDD/VDDQ/VDDL and VCC/VCCFBD

DDR2 SDRAM Fully Buffered DIMM Design Specification

Architecture

Architecture

DIMM Connector Pin Description

Pin Name	Pin Description	Count
SCK	System Clock Input, positive line ¹	1
$\overline{\text{SCK}}$	System Clock Input, negative line ¹	1
PN[13:0]	Primary Northbound Data, positive lines	14
$\overline{\text{PN}}$ [13:0]	Primary Northbound Data, negative lines	14
PS[9:0]	Primary Southbound Data, positive lines	10
$\overline{\text{PS}}$ [9:0]	Primary Southbound Data, negative lines	10
SN[13:0]	Secondary Northbound Data, positive lines	14
$\overline{\text{SN}}$ [13:0]	Secondary Northbound Data, negative lines	14
SS[9:0]	Secondary Southbound Data, positive lines	10
$\overline{\text{SS}}$ [9:0]	Secondary Southbound Data, negative lines	10
SCL	Serial Presence Detect (SPD) Clock Input	1
SDA	SPD Data Input / Output	1
SA[2:0]	SPD Address Inputs, also used to select the DIMM number in the AMB	3
VID[1:0]	Voltage ID: These pins must be unconnected for DDR2-based Fully Buffered DIMMs VID[0] is V _{DD} value: OPEN = 1.8 V, GND = 1.5 V; VID[1] is V _{CC} value: OPEN = 1.5 V, GND = 1.2 V	2
$\overline{\text{RESET}}$	AMB reset signal	1
RFU	Reserved for Future Use ²	16
V _{CC}	AMB Core Power and AMB Channel Interface Power (1.5 Volt)	8
V _{DD}	DRAM Power and AMB DRAM I/O Power (1.8 Volt)	24
V _{TT}	DRAM Address/Command/Clock Termination Power (V _{DD} /2)	4
V _{DDSPD}	SPD Power	1
V _{SS}	Ground	80

FBDIMM Standard provides a single set of VCC pins for VCC/VCCFBD

FBDIMM Standard provides a single set of VDD pins for VDD/VDDQ/VDDL

EX1028 (JEDEC FBDIMM Specification), 11

DEMONSTRATIVE EXHIBIT – NOT EVIDENCE

The FBDIMM Standard Uses A Single Converter For VDD/VDDQ/VDDL

2.3.1 Power-up and initialization sequence

The following sequence is required for POWER UP and Initialization.

a) Apply power and attempt to maintain CKE below $0.2 \cdot VDDQ$ and ODT^{*1} at a low state (all other inputs may be undefined.) The power voltage ramp time must be no greater than 20mS; and during the ramp, $VDD > VDDL > VDDQ$ and $VDD - VDDQ < 0.3$ volts.

- VDD, VDDL and VDDQ are driven from a single power converter output, AND
- VTT is limited to 0.95 V max, AND
- Vref tracks $VDDQ/2$.

or

- Apply VDD without any slope reversal before or at the same time as VDDL.
- Apply VDDL without any slope reversal before or at the same time as VDDQ.
- Apply VDDQ without any slope reversal before or at the same time as VTT & Vref.

at least one of these two sets of conditions must be met.

FBDIMM Standard provides for a single converter for VDD/VDDQ/VDDL

Petitioner's Reliance on an Alleged "Option 2" Fails To Motivate Using Separate Buck Converters For VDD/VDDQ/VDDL

2.3.1 Power-up and initialization sequence

The following sequence is required for POWER UP and Initialization.

- a) Apply power and attempt to maintain CKE below $0.2 * VDDQ$ and ODT^{*1} at a low state (all other inputs may be undefined.) The power voltage ramp time must be no greater than 20mS; and during the ramp, $VDD > VDDL > VDDQ$ and $VDD - VDDQ < 0.3$ volts.

- VDD, VDDL and VDDQ are driven from a single power converter output, AND
- VTT is limited to 0.95 V max, AND
- Vref tracks VDDQ/2.

or

- Apply VDD without any slope reversal before or at the same time as VDDL.
 - Apply VDDL without any slope reversal before or at the same time as VDDQ.
 - Apply VDDQ without any slope reversal before or at the same time as VTT & Vref.
- at least one of these two sets of conditions must be met.

Option 1

Option 2

Petitioner's Alleged "Option 2" Are Actually Alternatives to Vref Tracking

2.3.1 Power-up and initialization sequence

The following sequence is required for POWER UP and Initialization.

a) Apply power and attempt to maintain CKE below $0.2 \cdot VDDQ$ and ODT^{*1} at a low state (all other inputs may be undefined.) The power voltage ramp time must be no greater than 20mS; and during the ramp, $VDD > VDDL > VDDQ$ and $VDD - VDDQ < 0.3$ volts.

- VDD, VDDL and VDDQ are driven from a single power converter output, AND
- VTT is limited to 0.95 V max, AND
- Vref tracks $VDDQ/2$.

or

- Apply VDD without any slope reversal before or at the same time as VDDL.
- Apply VDDL without any slope reversal before or at the same time as VDDQ.
- Apply VDDQ without any slope reversal before or at the same time as VTT & Vref.

at least one of these two sets of conditions must be met.

"Options" end in periods, not "ANDs"

Turning Voltages On Or Off Separately Does Not Motivate Separate Converters

- Apply VDD without any slope reversal before or at the same time as VDDL.
- Apply VDDL without any slope reversal before or at the same time as VDDQ.
- Apply VDDQ without any slope reversal before or at the same time as VTT & Vref.

EX1026 (JEDEC DDR2 SDRAM Specification), 9

The Experts Agree: The Industry Rejected Using Multiple Converters in FBDIMMs for VDD/VDDQ/VDDL

Andrew Wolfe
Samsung's Expert

SAMSUNG

Q. As far as you know for the FB-DIMM designs, which option did the designers choose?

A. The unmodified FB-DIMMs that I'm aware of connect VDD, VDDL and VDDQ to a single power converter output.

EX2030 (Wolfe Deposition), 133:5-9

POSITAs consistently supplied all three voltages using a single power converter.

EX2031 (Mangione-Smith Declaration), ¶90.



William Mangione-Smith
Netlist's Expert

NETLIST

The Industry Rejected Using Multiple Converters To Supply VDD/VDDQ/VDDL or VCC/VCCFBD For Good Reasons



TN-47-05 DDR2 POWER SOLUTIONS FOR NOTEBOOKS
Overview

Technical Note

Power Solutions for DDR2 Notebook PCs

Supply

V_{DD} (V_{DD} , V_{DDL} , V_{DDQ})

The DDR2 device requires a single power source for primary supply voltages in order to ensure that all voltage levels track each other, especially during the power ramp. At the module level, V_{DD} (device core), V_{DDL} (device DLL), and V_{DDQ} (device I/O) share a single power plane with the interconnecting pins labeled as V_{DD} . Likewise, V_{SS} , V_{SSL} , and V_{SSQ} share a common ground plane labeled as V_{SS} .

The memory supply voltage is specified as $V_{DD} = V_{DDQ} = 1.8V$ with a DC tolerance of $\pm 100mV$. DC is defined as any signal ≤ 20 MHz. At the initial power-up, all supply power should be stable and meet specification within $\leq 10ms$.

EX2006 (Micron Technical Note), 4

The Industry Rejected Using Multiple Converters To Supply VDD/VDDQ/VDDL or VCC/VCCFBD For Good Reasons



William Mangione-Smith
Netlist's Expert



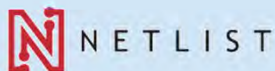
88. It was also generally known that, for the “VDD (VDD, VDDL, VDDQ)” power supply, “[t]he DDR2 device requires a single power source for primary supply voltages in order to ensure that all voltage levels track each other, especially during the power ramp.” EX2006 ([Micron TN-47-05](#)), 4. It was known that “VDD (device core), VDDL (device DLL), and VDDQ (device I/O) share a single power plane with the interconnecting pins labeled as VDD,” and that “[a]t the initial power-up, all supply power should be stable and meet specification within $\leq 10\text{ms}$.” Id. Meeting such stability and timing specifications is made possible when the voltages (e.g., VDD, VDDL and VDDQ) are driven from a single power converter instead of from separate converters.

EX2031 (Mangione-Smith Declaration), ¶88.

The Industry Rejected Using Multiple Converters To Supply VDD/VDDQ/VDDL or VCC/VCCFBD For Good Reasons



**William
Mangione-Smith**
Netlist's Expert



that the timing requirements are met. Independent voltage sources for different voltages would require specific control circuitry to delay and more precisely control each voltage source's ramping rate, adding complexity and cost. The fact is that POSITAs consistently supplied all three voltages using a single power converter. I note that Dr. Wolfe agrees. See EX2030, 133:5-134:6, 39:11-40:24. To me, this is a

EX2031 (Mangione-Smith Declaration), ¶190.

Petitioner's Evidence of Alleged Motivations to Use Separate Converters Are Untethered to Harris

No evidence
of analog
voltages

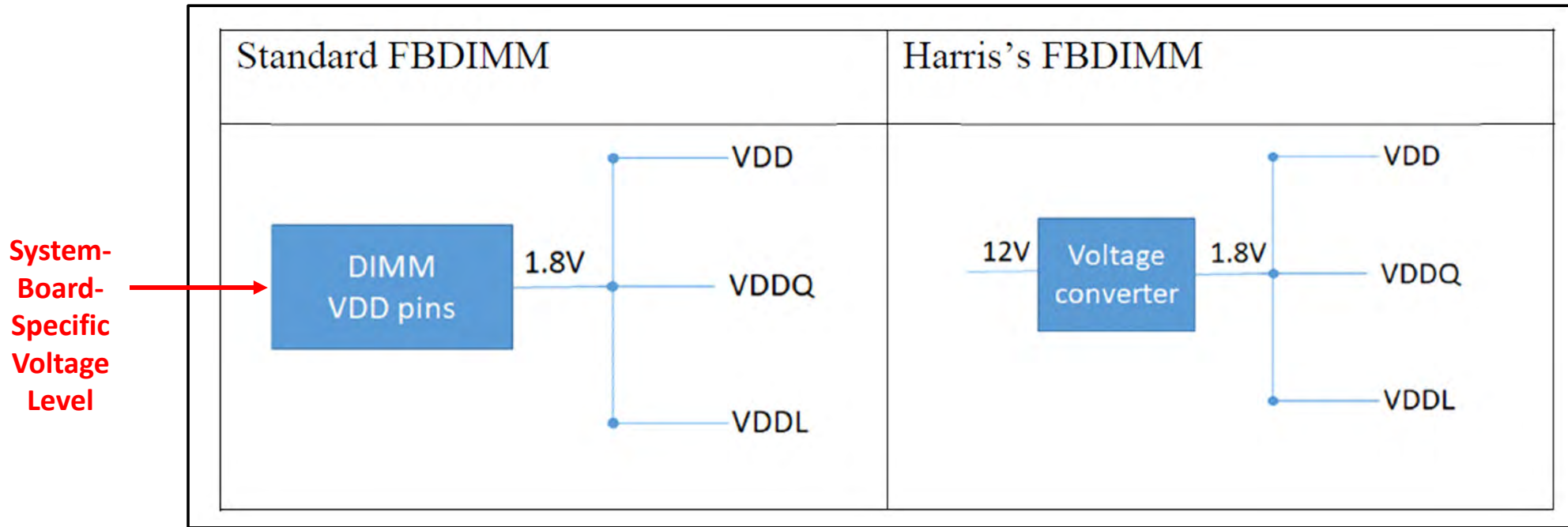
FBDIMM
does not run
at hundreds
of amperes

Many devices share standard voltage levels (such as 3.3 V), while others may require device-specific voltages. In addition, a particular standard voltage level may have to be independently furnished in numerous places. For example, separate analog- and digital supplies, such as 3.3 V_{ANALOG} and 3.3 V_{DIGITAL}, may be required. Generating the same voltage numerous times may be necessary to improve efficiency (e.g., memory rails running at hundreds of amperes) or to meet sequencing requirements (3.3 V_A and 3.3 V_B needed by separate devices at different times). All of

EX1062 (Power-Supply Management—Principles, Problems, and Parts) at 13.

VDD, VDDL, and VDDQ are each
supplied to the same devices

Petitioner Has Not Established A POSITA Would Have Used Separate Buck Converters For VDD/VDDQ/VDDL or VCC/VCCFBD

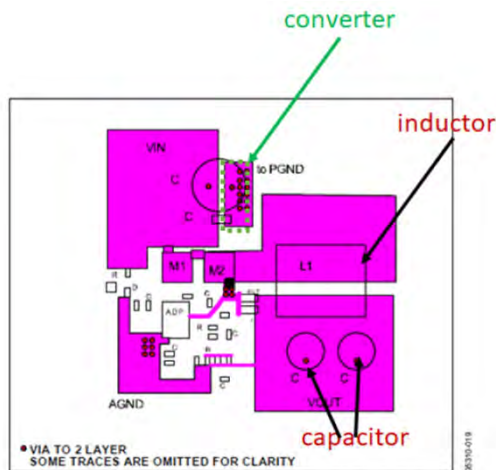


EX1028, 11

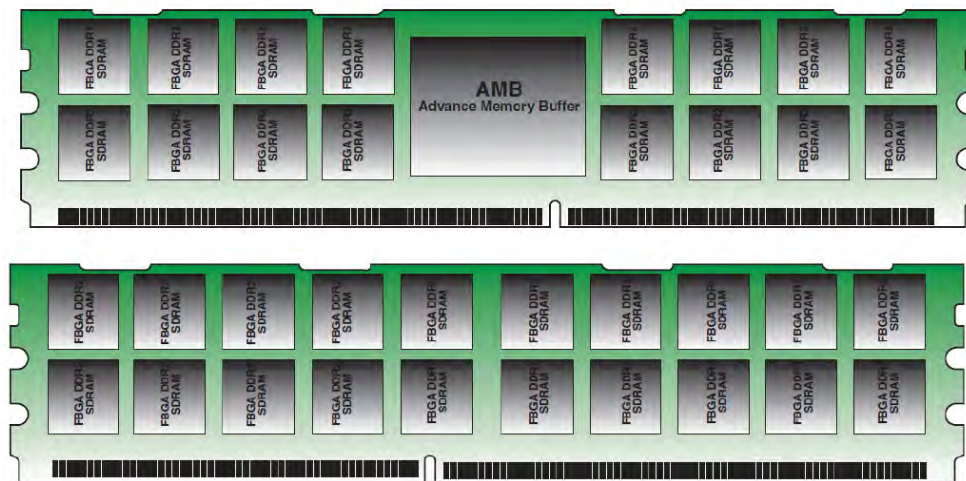
Petitioner Has Not Established A POSITA Would Have Further Modified Harris+FBDIMM With Separate Buck Converters Given Space Constraints

[0013] It is contemplated that local supply voltage conversion for double-rank DIMMs can be accommodated with a form factor design of approximately about one square inch (both sides of the printed circuit board), and at a component

EX1026 (Harris), [0010]



X 4 →



EX2042, 7.

- EX1078, 23

Petitioner Has Not Established A POSITA Would Have Used Separate Buck Converters For VDD/VDDQ/VDDL or VCC/VCCFBD

The 918 Petition

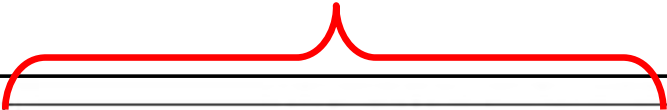
Voltage mappings that require using separate converters for the same voltage level under Petitioner's theory

Voltage Mappings (Grounds 1-3)			
	<u>A</u>	<u>B</u>	<u>C</u>
"first":	V _{DD} or V _{DDQ} = 1.8V	V _{DD} , V _{DDQ} , or V _{VDDL} = 1.8V	V _{DD} , V _{DDQ} , or V _{VDDL} = 1.8V
"second":	V _{CC} or V _{CCFBD} = 1.5V	V _{CC} = 1.5V	V _{CC} or V _{CCFBD} = 1.5V
"third":	V _{VDDL} = 1.8V	V _{CCFBD} = 1.5V	V _{TT} = 0.9V
"fourth":	V _{DDSPD} = 3.3V	V _{DDSPD} = 3.3V	V _{DDSPD} = 3.3V

Petitioner Has Not Established A POSITA Would Have Used Separate Buck Converters For VDD/VDDQ/VDDL or VCC/VCCFBD

The 054 Petition

Voltage mappings that require using separate converters for the same voltage level under Petitioner's theory



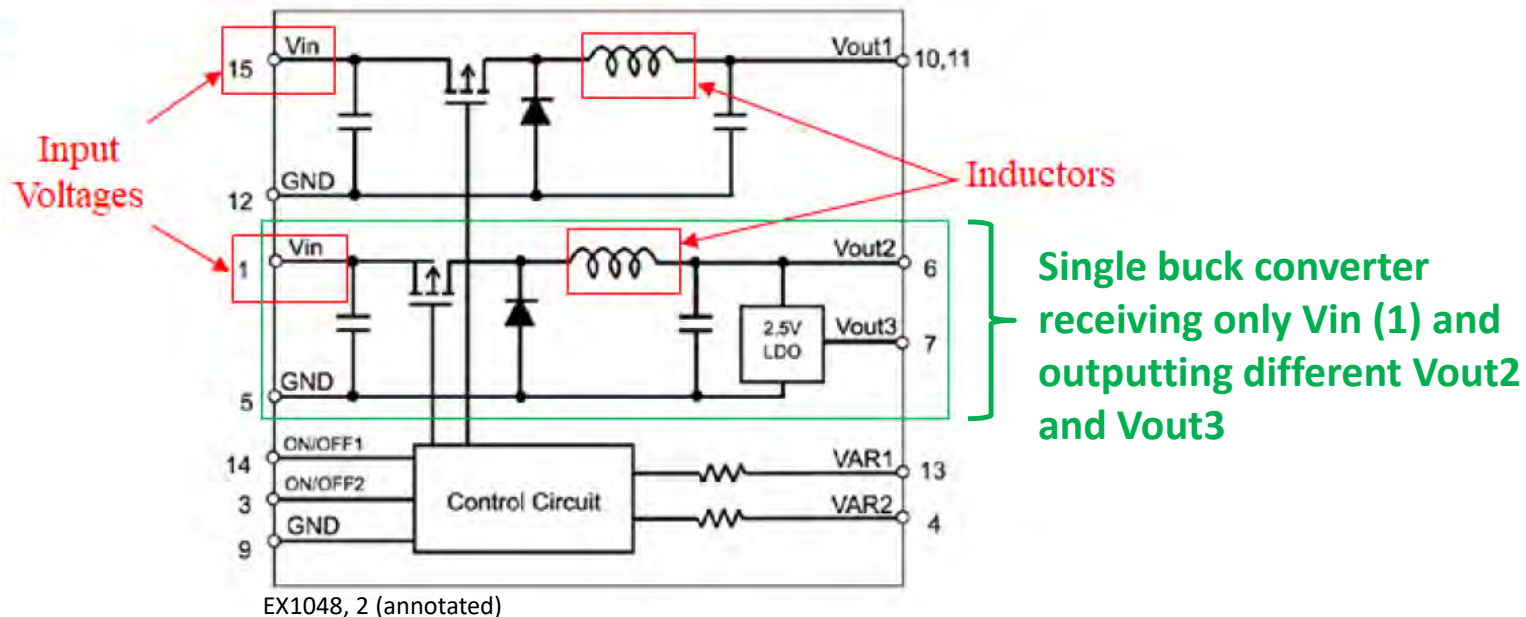
Voltage Mappings (Grounds 1-3)			
	<u>A</u>	<u>B</u>	<u>C</u>
<i>"first"</i> :	V _{DD} or V _{DDQ} = 1.8V	V _{DD} or V _{DDQ} = 1.8V	V _{DD} or V _{DDQ} = 1.8V
<i>"second"</i> :	V _{CC} or V _{CCFBD} = 1.5V	V _{CC} = 1.5V	V _{CC} or V _{CCFBD} = 1.5V
<i>"third"</i> :	V _{DDL} = 1.8V	V _{CCFBD} = 1.5V	V _{TT} = 0.9V

Petitioner's Own Evidence Shows that Single Buck Converter Outputting Multiple Voltages Were Known

DC-DC Converter Specification(DRAFT) MPD4S014S

5. Pin Number and Function

Pin No.	Function
1.	Vin
2.	N.C.(Internally Used)
3.	ON/OFF2
4.	VAR2
5.	GND
6.	Vout2(1.8V-3.6V)
7.	Vout3(2.5V)



Single Buck Converters Can Generate Multiple Voltages

24.6 A 4-Output Single-Inductor DC-DC Buck Converter with Self-Boosted Switch Drivers and 1.2A Total Output Current

M. Belloni¹, E. Bonizzoni¹, E. Kiseliovas², P. Malcovati¹, F. Maloberti¹, T. Peltola², T. Teppo²

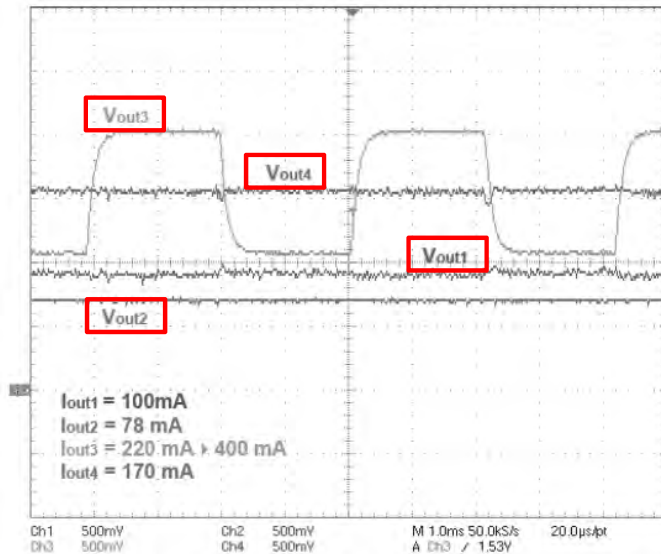


Figure 24.6.5: Measured regulated output voltages ($V_{out1} = 0.9\text{V}$ ch. 1, $V_{out2} = 0.7\text{V}$ ch. 2, $V_{out3} = 1.1$ to 2V ch. 3, $V_{out4} = 1.6\text{V}$ ch. 4)

EX2003 at 2.

Single-Inductor Multiple-Output Switching Converters With Time-Multiplexing Control in Discontinuous Conduction Mode

Dongsheng Ma, *Student Member, IEEE*, Wing-Hung Ki, *Member, IEEE*, Chi-Ying Tsui, *Member, IEEE*, and Philip K. T. Mok, *Senior Member, IEEE*

TABLE II
PERFORMANCE SUMMARY

Supply voltage range	1.3~2.85V	
Inductor	1 μH (nominal)	
Oscillator frequency	1MHz (nominal)	
Chip area	2.4mm ²	
Process	0.5 μm CMOS, n-well, 3AL, 1PS	
Output voltages	3.0V	3.6V

EX2004 at 99 (pdf page 11)

Harris Expressly Discloses Using a Single Converter to Provide Multiple Voltages

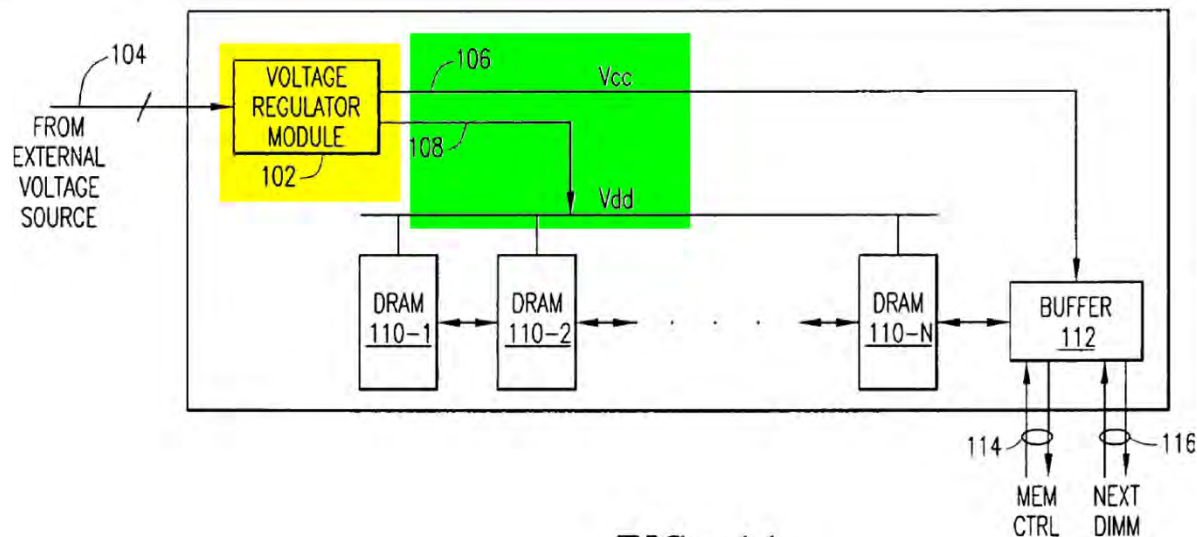


FIG. 1A

respectively. Preferably, a high-frequency switching voltage converter capable of generating tightly-controlled voltage levels may be implemented as the on-board VRM 102 for purposes of the present patent disclosure. For instance,

EX1023 (Harris), [0010]

Harris' Claims Confirm a Single Module Can Supply Multiple Voltages

What is claimed is:

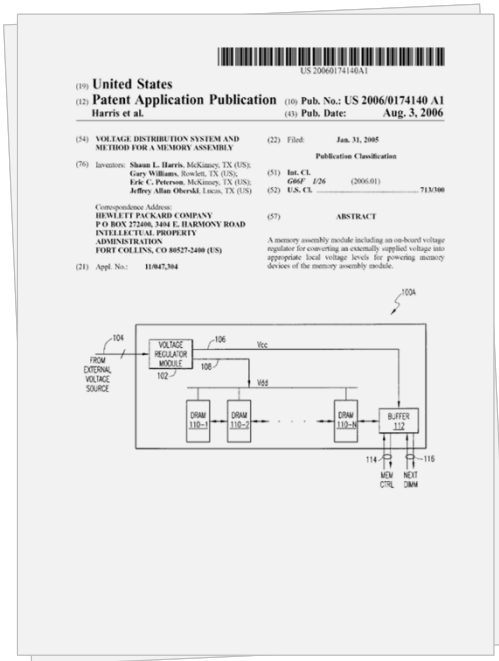
1. A memory board assembly, comprising:

a plurality of memory devices, each receiving a first voltage path;

a buffer for buffering data in at least a portion of said plurality of memory devices, said buffer receiving a second voltage path and a bidirectional memory controller path; and

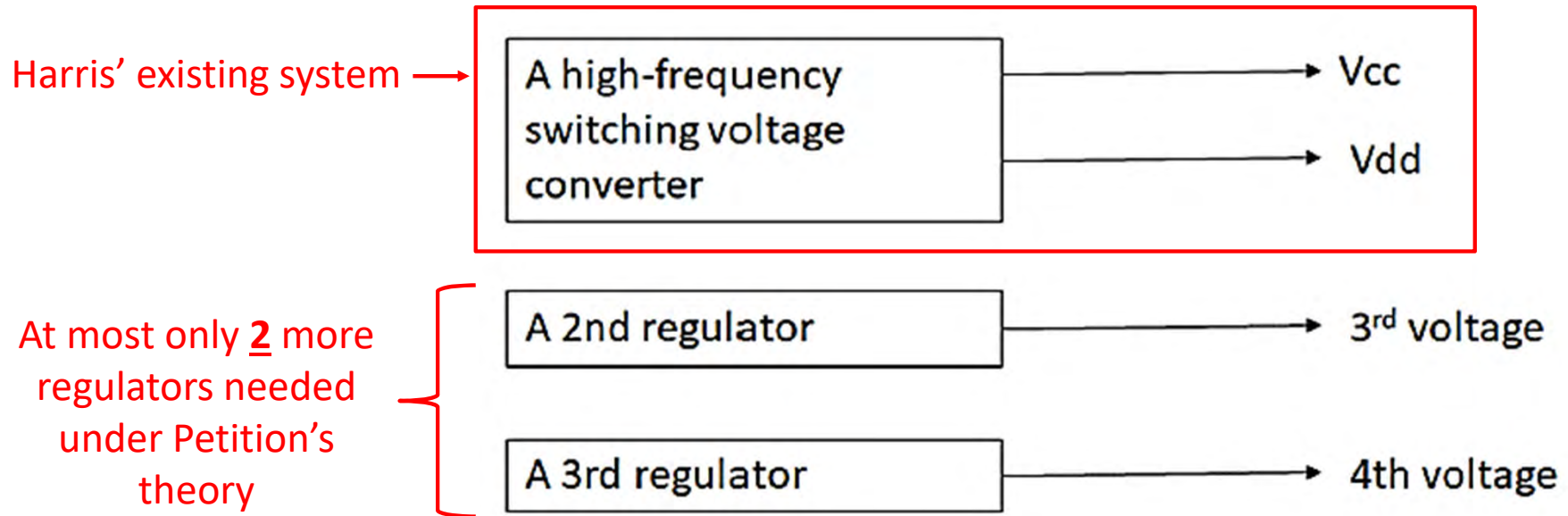
at least one voltage regulator module for converting an externally supplied voltage level into appropriate voltage levels that power said first and second voltage paths, respectively.

EX1023 (Harris), Claim 1



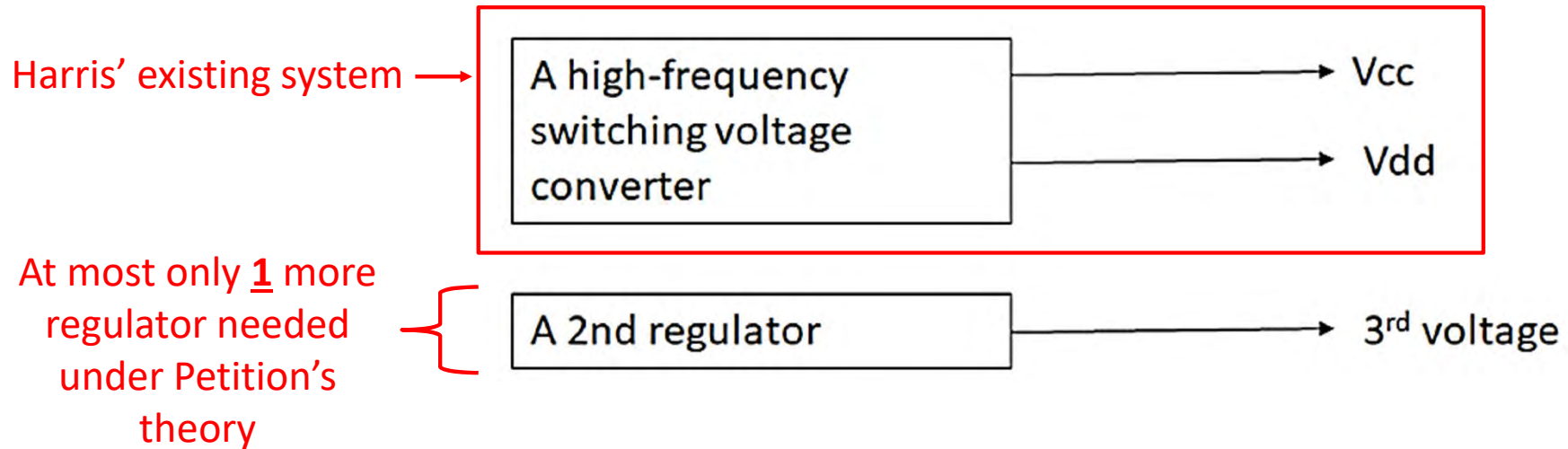
Absent Further Modification, Harris+FBDIMM Would Not Use Separate Converters For Each Voltage

'918 IPR



Absent Further Modification, Harris+FBDIMM Would Not Use Separate Converters For Each Voltage

'054 IPR



Voltage Mapping C Fails: Harris Does Not Generate VTT On-Module And A POSA Would Not Be Motivated to Modify Harris To Do So

The 918 Petition

Voltage Mappings (Grounds 1-3)			
	<u>A</u>	<u>B</u>	<u>C</u>
<i>“first”</i> :	V_{DD} or $V_{DDQ} = 1.8V$	V_{DD} , V_{DDQ} , or $V_{DDL} = 1.8V$	V_{DD} , V_{DDQ} , or $V_{DDL} = 1.8V$
<i>“second”</i> :	V_{CC} or $V_{CCFBD} = 1.5V$	$V_{CC} = 1.5V$	V_{CC} or $V_{CCFBD} = 1.5V$
<i>“third”</i> :	$V_{DDL} = 1.8V$	$V_{CCFBD} = 1.5V$	$V_{TT} = 0.9V$
<i>“fourth”</i> :	$V_{DDSPD} = 3.3V$	$V_{DDSPD} = 3.3V$	$V_{DDSPD} = 3.3V$

Voltage Mapping C Fails: Harris Does Not Generate VTT On-Module And A POSA Would Not Be Motivated to Modify Harris To Do So

The 054 Petition

Voltage Mappings (Grounds 1-3)			
	<u>A</u>	<u>B</u>	<u>C</u>
<i>“first”</i> :	V_{DD} or $V_{DDQ} = 1.8V$	V_{DD} or $V_{DDQ} = 1.8V$	V_{DD} or $V_{DDQ} = 1.8V$
<i>“second”</i> :	V_{CC} or $V_{CCFBD} = 1.5V$	$V_{CC} = 1.5V$	V_{CC} or $V_{CCFBD} = 1.5V$
<i>“third”</i> :	$V_{DDL} = 1.8V$	$V_{CCFBD} = 1.5V$	$V_{TT} = 0.9V$

Harris Does Not Teach Or Suggest Generating VTT On-Module

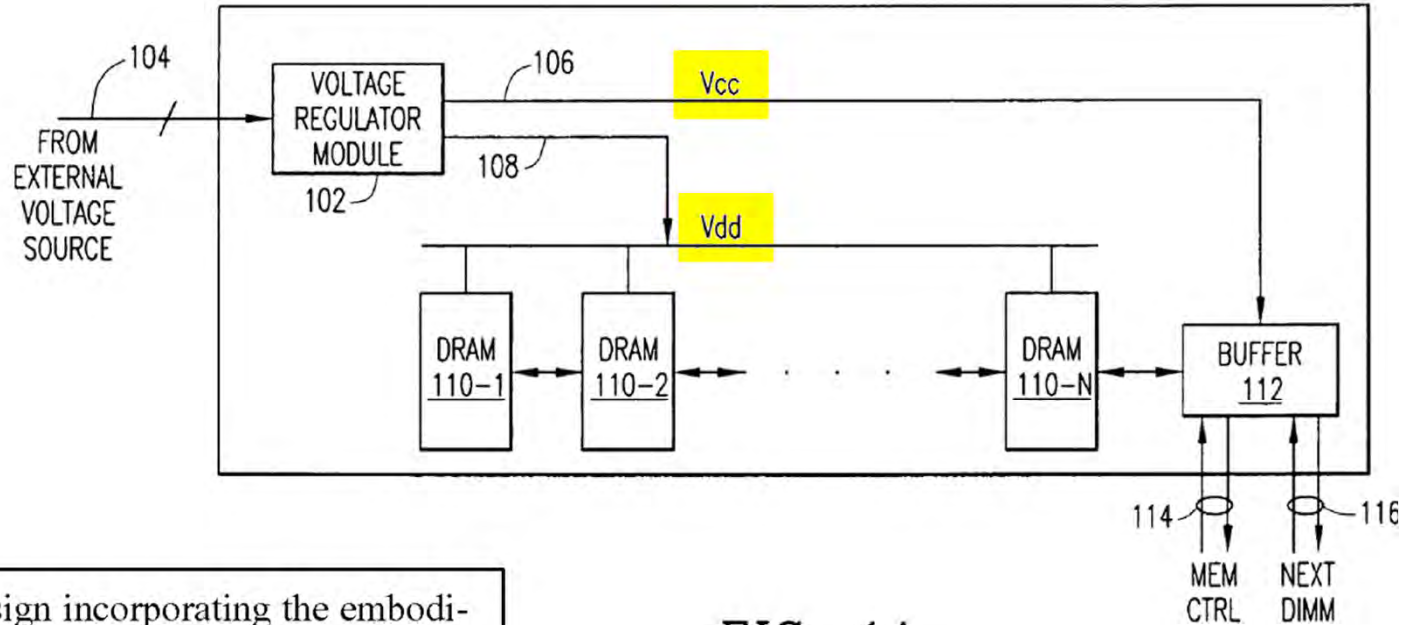


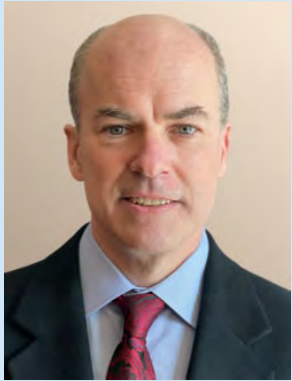
FIG. 1A

EX102 (Harris), FIG. 1A.

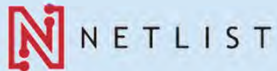
voltage-independent FBD design incorporating the embodiment of FIG. 1A is capable of replacing these power supply interface pins with as few as six +12V pins (from an external voltage source), with local conversion to V_{dd} (to DRAM) and V_{cc} (to buffer/logic) being added. Alternatively, using

EX1023 (Harris), [0012]

A POSA Would Have Had Specific Reasons Not to Generate VTT On-Module



**William
Mangione-Smith**
Netlist's Expert



“[S]upplying VTT from the motherboard would ensure that all DIMMs connected to the same memory controller would have the same termination voltages This would also ***eliminate undesirable ground loops*** between the DIMMs, on the one hand, and between the DIMM and the motherboard, on the other hand.”

EX2031 (Mangione-Smith Declaration), ¶196

“VTT supply must sink and source current.... The design complexity would favor having a single regulator for a group of DIMMs rather than one regulator per DIMM.”

EX2031 (Mangione-Smith Declaration), ¶197

A POSA Would Not Generate VTT Using A Buck Converter

VTT was typically generated by an LDO



TN-47-05 DDR2 POWER SOLUTIONS FOR NOTEBOOKS
Overview

Technical Note

Power Solutions for DDR2 Notebook PCs

TPS51116: A Solution for Complete DDR2 Power Management

Figure 6 on page 8 shows a typical application schematic for the TPS51116 and how it integrates into the complete DDR2 power-management solution with:

- Synchronous current mode DC/DC controller to power V_{DD}
- Buffered reference to provide V_{REF} (V_{REF} tracks one-half V_{DD})
- 3A sink/source LDO to power V_{TT} (V_{TT} tracks V_{REF})
- S3/S5 sleep-state controls

EX2006 (Micron Technical Note), at 7.

See also EX2007-2010, EX2050 (linear VTT regulators that generate VTT from VDDQ).

There Are Specific Reasons To Use An LDO To Generate VTT



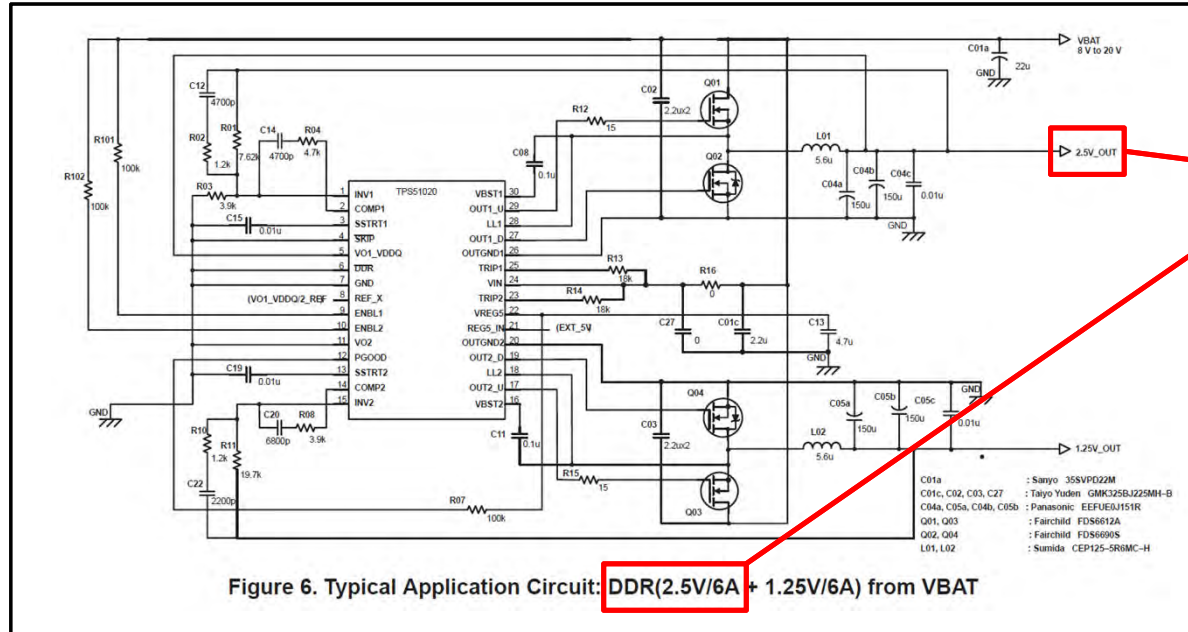
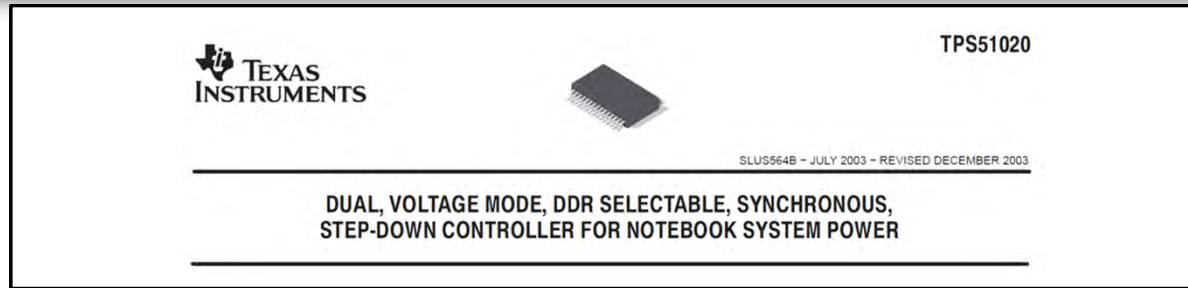
**William
Mangione-Smith**
Netlist's Expert



regulators that generate V_{TT} from V_{DDQ}). Indeed, LDOs are much smaller than buck converters, which requires a controller and discrete components including a larger inductor. This makes an LDO preferable in space constrained environments. LDO are also preferred when the current load is below 1A. See EX2047 [SMTsg5127fb225652] at 21 (V_{TT} current is typically 500mA and no more than 700mA); EX0248 [MT18HTF1282FDY], p.23 (same); EX2049 [SS_143851], 20 (same); EX1040, pp.23-24, Figs.22-25 (efficiency decreases at lower currents and lower output voltage).

EX2031 (Mangione-Smith Declaration), ¶199

Petitioner's VTT Examples are for DDR1, not DDR2



VDDQ of 2.5V
is for DDR1*

Petitioner's VTT Examples are for DDR1, not DDR2



FAN5026 Dual DDR/Dual-Output PWM Controller

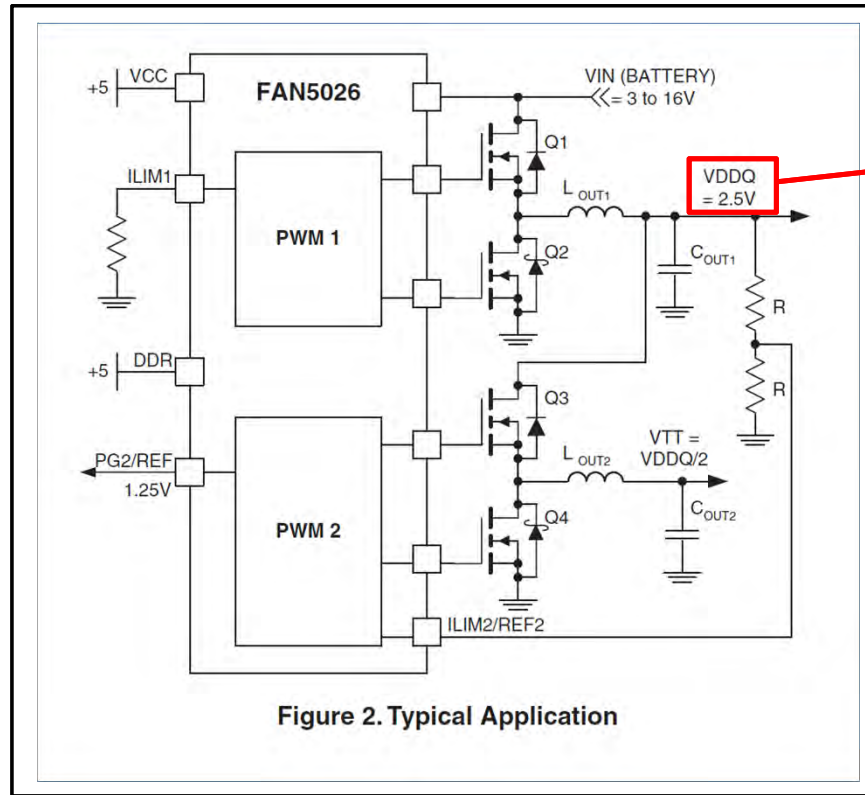
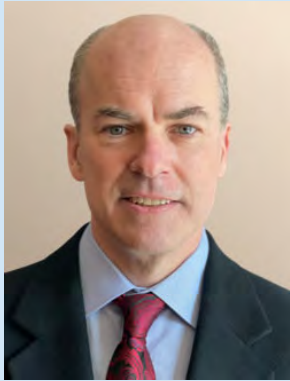


Figure 2. Typical Application

**VDDQ of 2.5V
is for DDR1***

EX1041, p. 2

EX1040 and EX1041 Do Not Suggest Using Buck Converters in FBDIMMs



**William
Mangione-Smith**
Netlist's Expert



100. Dr. Wolfe relies on EX1040 and EX1041 as evidence that buck converters were used to generate V_{TT} . EX1003, ¶¶ 340-341. I have confirmed that Figures 6-7 of Exhibit 1040 and Figures 2 and 4 of Exhibit 1041 depict generation of V_{DDQ} and V_{TT} of DDR1, not DDR2. Unlike DDR2, DDR1 uses motherboard termination, and no on-die termination. EX2012, 71. Hence, DDR1 termination involves higher current, which might have made a buck converter more suitable. I

EX2031 (Mangione-Smith Declaration), ¶100

A POSA Would Not Use A Buck Converter To Generate VDDSPD, As Required By All Voltage Mappings

The 918 Petition

Voltage Mappings (Grounds 1-3)			
	<u>A</u>	<u>B</u>	<u>C</u>
<i>“first”</i> :	V_{DD} or $V_{DDQ} = 1.8V$	V_{DD} , V_{DDQ} , or $V_{DDL} = 1.8V$	V_{DD} , V_{DDQ} , or $V_{DDL} = 1.8V$
<i>“second”</i> :	V_{CC} or $V_{CCFBD} = 1.5V$	$V_{CC} = 1.5V$	V_{CC} or $V_{CCFBD} = 1.5V$
<i>“third”</i> :	$V_{DDL} = 1.8V$	$V_{CCFBD} = 1.5V$	$V_{TT} = 0.9V$
<i>“fourth”</i> :	$V_{DDSPD} = 3.3V$	$V_{DDSPD} = 3.3V$	$V_{DDSPD} = 3.3V$

Harris Does Not Teach Or Suggest Generating VDDSPD On-Module

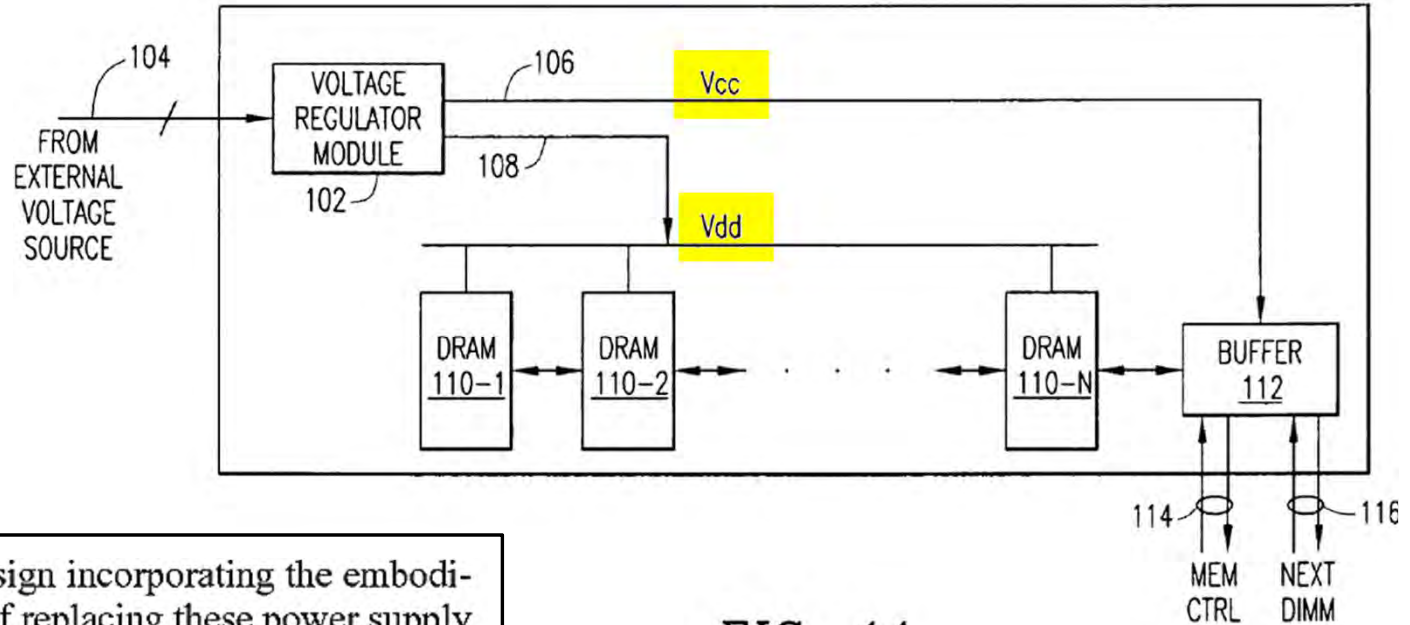


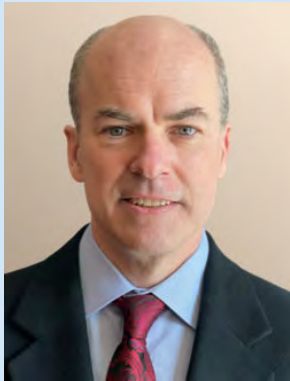
FIG. 1A

EX102 (Harris), FIG. 1A.

voltage-independent FBD design incorporating the embodiment of FIG. 1A is capable of replacing these power supply interface pins with as few as six +12V pins (from an external voltage source), with local conversion to V_{dd} (to DRAM) and V_{cc} (to buffer/logic) being added. Alternatively, using

EX1023 (Harris), [0012]

A POSA Would Not Use An On-Module Buck Converter To Generate VDDSPD, As Required By All Voltage Mappings

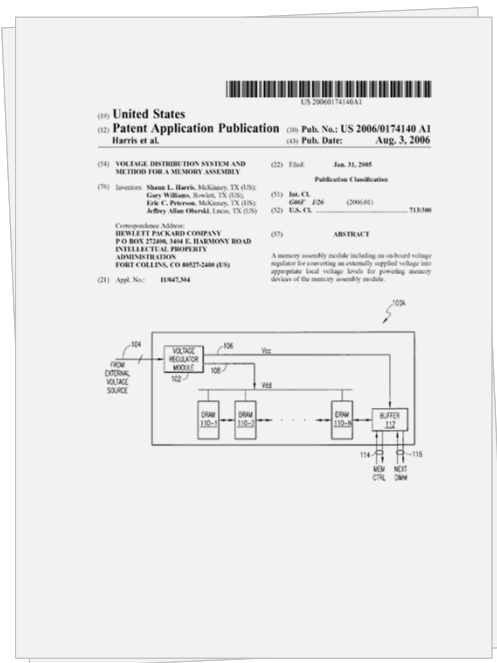


**William
Mangione-Smith**
Netlist's Expert



- Petitioner fails to explain why a POSA would add an on-module converter for 3.3V VDDSPD when there is already a 3.3V power rail available on the motherboard.
 - “3.3V is a common power rail on the motherboard such that it can be supplied to FBDIMMs without the increased cost and problems associated with providing a regulator for each of Harris’ modified FBDIMM memory boards” EX2031, ¶102.
- A POSA would understand there are reasons not to have multiple 3.3V regulators because the SMBus controller on the motherboard uses the same SMBus to communicate with the SPD of each FBDIMM.
 - “[I]f VDDSPD voltages are supplied by different regulators to the SMBus controller on the motherboard and individual DIMMs, they cannot track each other and would lead to communication problems when they are actually at different voltage potentials.” *Id.*
- A POSA would not use a buck converter which is less efficient than an LDO.
 - “[T]he low current level required by components using VDDSPD means that buck converters would be very inefficient.” EX2031, ¶103.
 - Buck converter: “efficiency less than 20% at 10mA current” *Id.*
 - LDO: “An LDO with a12V-input-3.3V-output would be 26% efficient.” *Id.*

Use of Buck Converters Is Entirely Hindsight



respectively. Preferably, a high-frequency switching voltage converter capable of generating tightly-controlled voltage levels may be implemented as the on-board VRM 102 for purposes of the present patent disclosure. For instance, multi-phase synchronous Pulse-Width Modulated (PWM) controllers, Low Drop-Out (LDO) controllers, et cetera, that are capable of accepting unregulated supply voltages in a broad range may be configured to operate as a local voltage supply for the memory module 100A.

EX1023 (Harris), [0010].

Petitioner Argues That General References to Step Converters Does Not Inherently Disclose Buck Converters

53. A Skilled Artisan would have understood at the time that a “buck converter” is different from a “step-down transformer” described in the 586 Provisional. To the extent the term “transformer” is meant to cover changing the voltage by any means which produces a regulated voltage, a Skilled Artisan would have understood that a step-down regulated voltage can also be provided by means other than a “buck converter,” e.g., by a linear regulator, such as a low-dropout regulator (LDO). A Skilled Artisan would have understood that an LDO is different from the claimed “buck converter.” *See, e.g.,* Ex. 1059 at 5:23-30 (“Switch mode buck converters have become popular due to two attractive features: first, they are more efficient than traditional low drop out regulators (LDO) (e.g., up to 95%) and second, they can provide relatively high currents with lower power dissipation on chip than an LDO can.”).

TOPICS

GROUND 1-3

Harris Does Not Receive Power Via Edge Connections

Harris Does Not Receive The Recited Signals From the Host

A POSITA Would Not Have Used the Required # of (Buck) Converters

Ground 2 ASSUMES Separate Converters To Supply Each FBDIMM-Required Voltage

A POSITA Would Not Have Replaced Harris' Redundant Power

Additional Reasons Why Dependent Claims Are Not Obvious

GROUND 4-5

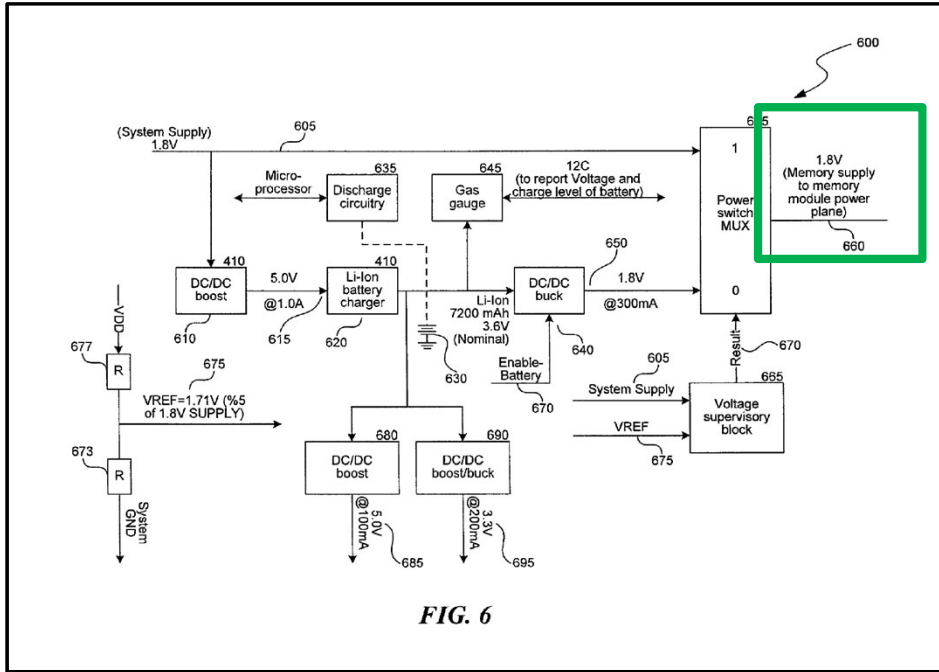
The Recited "Memory Module" Means A Main Memory Module

Spiers' PCI Card Is Not a Main Memory Module

POSITA Would Not Use DDR2/DDR3 or Recited # of (Buck) Converters

Additional Reasons Why Dependent Claims Are Not Obvious

Amidi Does Not Use Separate On Board Converters for DDR2 Required Voltages: VDD, VCC, VTT



EX1024 (Amidi) at FIG. 6.

While a general approach to a clock and power fault detection system provides much insight, a truth table for a specific implementation may also be useful. FIG. 13 illustrates an embodiment of a truth table. Truth table 1300 represents the values of signals to memory components of a DDR2 SDRAM memory module as would be generated to control the clock and power fault detection system and the actual memory (for write protection and refresh purposes).

EX1024 (Amidi) at 7:52-59.

Ground 2 Still Assumes Motivation to Use Separate Converters For Each FBDIMM Required Voltage

Ground 2: Ground 1 and Battery Backup of Amidi

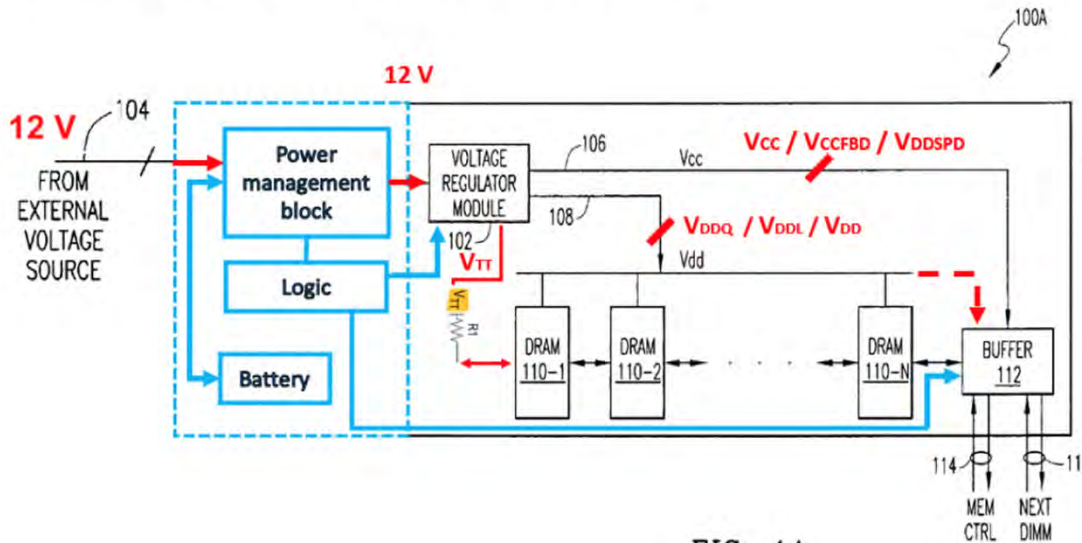


FIG. 1A

Voltage Mapping (A)

- 1st : $V_{DD} / V_{DDQ} = 1.8V$
- 2nd : $V_{CC} / V_{CCFBD} = 1.5V$
- 3rd : $V_{DDL} = 1.8V$
- 4th : $V_{DDSPD} = 3.3V$

Voltage Mapping (B)

- 1st : $V_{DD} / V_{DDQ} / V_{DDL} = 1.8V$
- 2nd : $V_{CC} = 1.5V$
- 3rd : $V_{CCFBD} = 1.5V$
- 4th : $V_{DDSPD} = 3.3V$

Voltage Mapping (C)

- 1st : $V_{DD} / V_{DDQ} / V_{DDL} = 1.8V$
- 2nd : $V_{CC} / V_{CCFBD} = 1.5V$
- 3rd : $V_{TT} = 0.9V$
- 4th : $V_{DDSPD} = 3.3V$

TOPICS

GROUND 1-3

Harris Does Not Receive Power Via Edge Connections

Harris Does Not Receive The Recited Signals From the Host

A POSITA Would Not Have Used the Required # of (Buck) Converters

Ground 2 ASSUMES Separate Converters To Supply Each FBDIMM-Required Voltage

A POSITA Would Not Have Replaced Harris' Redundant Power

Additional Reasons Why Dependent Claims Are Not Obvious

GROUND 4-5

The Recited "Memory Module" Means A Main Memory Module

Spiers' PCI Card Is Not a Main Memory Module

POSITA Would Not Use DDR2/DDR3 or Recited # of (Buck) Converters

Additional Reasons Why Dependent Claims Are Not Obvious

Harris Already Provides Redundant Power to the Memory Module

that the voltage distribution system for memory module 100B is essentially similar to the system shown in FIG. 1A, but for the redundancy implementation of local voltage conversion. A plurality of on-board VRMs 122-K, K=1, 2, . . . , N, are provided as part of the memory assembly/module 100B wherein each VRM is operable with an independent voltage supply path for locally converting an external supply voltage into appropriate local voltage levels. Reference

EX1023 (Harris), [0014]

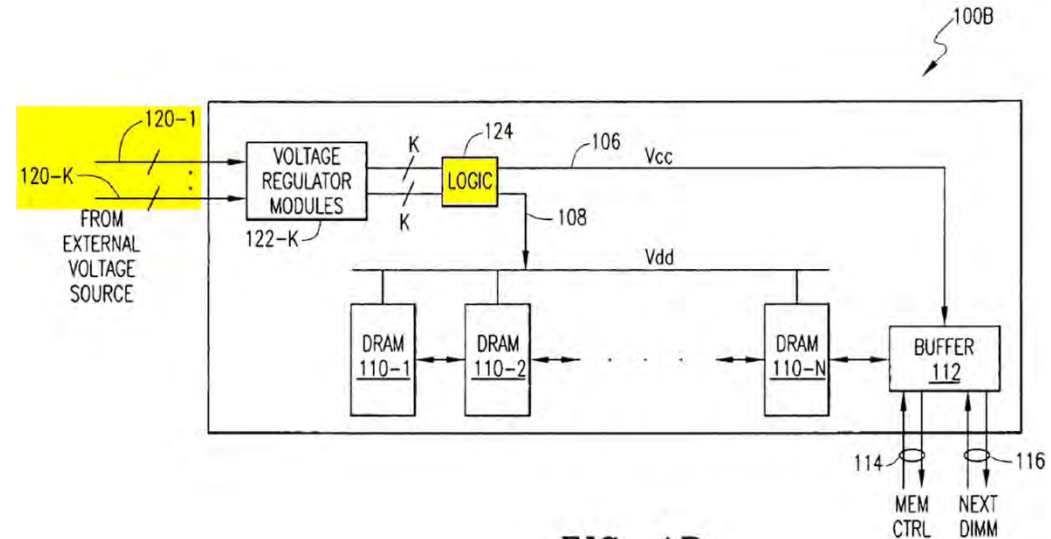


FIG. 1B

EX1023 (Harris), FIG. 1B.

Harris' Redundancy Implementation Provides Backup Power Using Redundant Input Voltages



**William
Mangione-Smith**
Netlist's Expert



107. A POSITA would understand that the purpose of Harris' redundant power sources is to switch to an alternative voltage source in response to a power loss, in a very similar manner as Amidi. Dr. Wolfe agrees. EX1003, ¶170 (“Similar

EX2031 (Mangione-Smith Declaration), ¶107

Dr. Wolfe Agrees: Harris' Existing Redundancy Implementation is Functionally Similar to Amidi's Backup Power Supply

Andrew Wolfe
Samsung's Expert



Harris

power sources. *See* Ex. 1023 at [0014] (describing a “redundancy implementation”), [0016] (describing a “redundant VRM” to “power a redundant voltage path”), Figs. 1B, 2. Similar to the redundant implementation in Harris, Amidi teaches a redundant power source. *See, e.g.*, Ex. 1024 at Abstract. Amidi

EX1003 (Wolfe Declaration), ¶170.

Petition: Amidi's Backup Power Supply Is Functioning "In the Same Way" As Harris' Redundant Implementation

The Petition

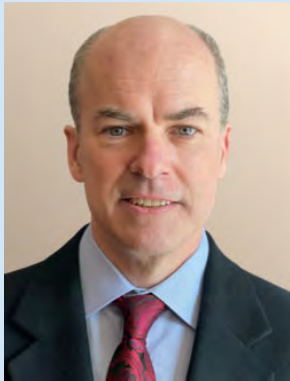
backup when needed. EX1003, ¶¶170-174. This straightforward modification of Harris's memory module in view of Amidi and the knowledge of a POSITA simply uses a known technique (e.g., Amidi's battery backup techniques) to improve a similar device (e.g., Harris's memory module) in the same way (e.g., to provide a backup power supply using a battery). *Id.*, ¶175. In addition, the

Petition (918) at 55.



SAMSUNG

A POSA Would Not Have Preferred a Battery Backup Solution To Harris' Existing Redundancy Implementation



**William
Mangione-Smith**
Netlist's Expert



- “[U]sing Amidi’s battery only results in **additional and unnecessary complexity**, with Harris’s 12V external source having to be stepped-down with a buck converter to 5V for Amidi’s battery, only to then be stepped back up with a boost converter to 12V. EX2031, ¶108.
- The ’918 patent notes that “batteries may require **maintenance**, may **need to be replaced**, are not environmentally friendly, and the status of batteries can be difficult to monitor.” EX1001, 4:56-58; *Id.*
- “Amidi’s battery backup solution would require a **substantial amount of on-board space**” EX2031, ¶108.
- “[A] battery backup solution would also be able to **provide backup power for only a finite period of time** based on the battery’s capacity. This would represent an inadequate solution for power interrupts which last longer.” *Id.*, ¶109.

TOPICS

GROUND 1-3

Harris Does Not Receive Power Via Edge Connections

Harris Does Not Receive The Recited Signals From the Host

A POSITA Would Not Have Used the Required # of (Buck) Converters

Ground 2 ASSUMES Separate Converters To Supply Each FBDIMM-Required Voltage

A POSITA Would Not Have Replaced Harris' Redundant Power

Additional Reasons Why Dependent Claims Are Not Obvious

GROUND 4-5

The Recited "Memory Module" Means A Main Memory Module

Spiers' PCI Card Is Not a Main Memory Module

POSITA Would Not Use DDR2/DDR3 or Recited # of (Buck) Converters

Additional Reasons Why Dependent Claims Are Not Obvious

Petition: Harris Allegedly Teaches Detecting Over/Under Voltages

The Petition

Additionally, Harris teaches *both* overvoltage *and* undervoltage protection of “+/- 15%.” EX1023, ¶[0013]. Thus, in the combination of Ground 2, a

Petition (918) at 62



SAMSUNG

Harris' $\pm 15\%$ Is a Design Tolerance, Not Detection of Over/Under Voltages

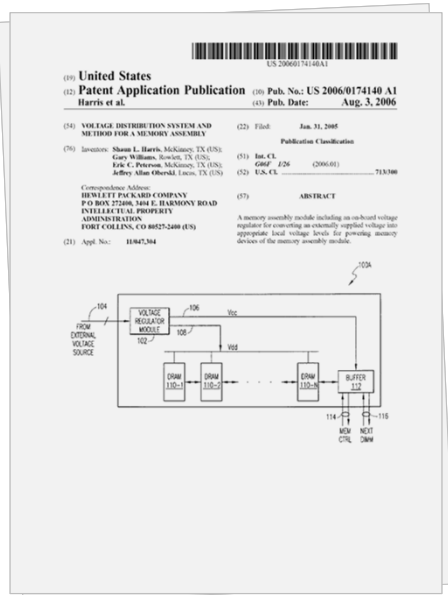
Engineering Council (JEDEC) standards. Further, since the +12V power supply is not used directly by DRAM devices or buffer/logic components of the memory assembly, a wide tolerance (e.g., around $\pm 15\%$) can be accommodated, allowing low cost power distribution for system boards

EX1023 (Harris), [0013]

low cost power distribution for system boards" EX1023, [0013]. A POSITA would understand that Harris' reference to " $\pm 15\%$ " refers to design tolerances, not to detecting when the input voltage happens to rise above a predetermined threshold.

EX2031 (Mangione-Smith Declaration), ¶116

And no trigger signal is produced in Harris if supply voltage exceeds design tolerance



Petition: Allegedly Well-Known to Detect Over/Under Voltages

The Petition

¶¶368-374. Indeed, such circuitry for *both* overvoltage *and* undervoltage protection was well known and commercially available:

Petition (918) at 62



SAMSUNG

Petitioner's Evidence Shows That Allegedly Suitable Regulators Did Not Detect Over-Voltage

Undervoltage, but no
Overvoltage detection



Step-Down DC-to-DC Controller

ADP1821

SPECIFICATIONS

$V_{VCC} = V_{PVCC} = V_{SHDN} = V_{FREQ} = 5\text{ V}$, SYNC = GND. All limits at temperature extremes are guaranteed via correlation using standard statistical quality control (SQC). $T_J = -40^\circ\text{C}$ to $+125^\circ\text{C}$, unless otherwise specified. Typical values are at $T_A = 25^\circ\text{C}$.


Table 1.


Parameter	Conditions	Min	Typ	Max	Unit
POWER SUPPLY					
Input Voltage		3.7		5.5	V
Undervoltage Lockout Threshold	V_{VCC} rising, $T_J = -40^\circ\text{C}$ to $+125^\circ\text{C}$	2.4	2.7	3.0	V
Undervoltage Lockout Threshold	V_{VCC} rising, $T_A = 25^\circ\text{C}$	2.5	2.7	2.9	V
Undervoltage Lockout Hysteresis	V_{VCC}		0.1		V
Quiescent Current	$I_{VCC} + I_{VCC}$, not switching		1	2	mA
Shutdown Current	SHDN = GND			10	μA
Power Stage Supply Voltage		1.0		24	V

EX1078, 1, 3.

SAMSUNG

Wide Input Voltage Tolerance Obviates the Need for Over-Voltage Detection

 **TEXAS INSTRUMENTS** TPS51020




SLUS564B – JULY 2003 – REVISED DECEMBER 2003

**DUAL, VOLTAGE MODE, DDR SELECTABLE, SYNCHRONOUS,
STEP-DOWN CONTROLLER FOR NOTEBOOK SYSTEM POWER**

FEATURES

- Wide Input Voltage Range: 4.5-V to 28-V

EX1040

 **FAIRCHILD**
SEMICONDUCTOR®

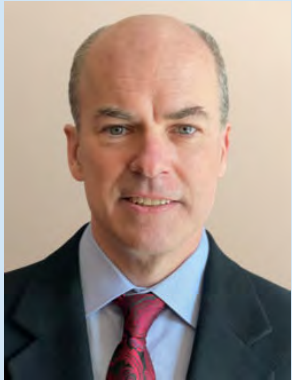
FAN5026
Dual DDR/Dual-Output PWM Controller

- Wide power input range: 3 to 16V

EX1041

SAMSUNG

High Upper Limit on Input Voltage Obviates the Need for Over-Voltage Detection



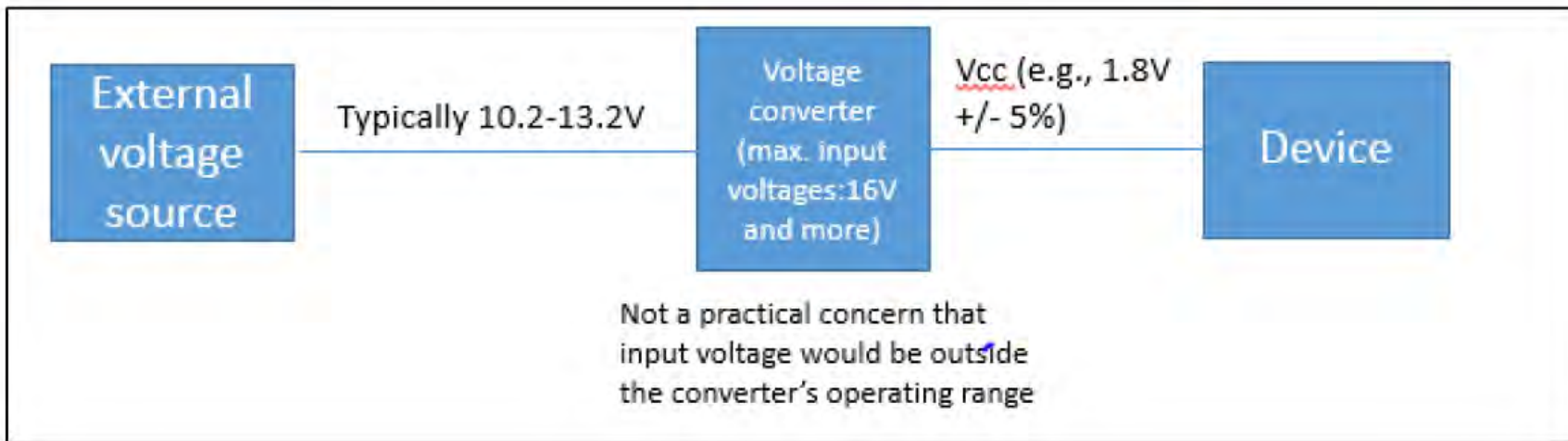
**William
Mangione-Smith**
Netlist's Expert



117. ... [V]oltage regulators that Samsung alleges are suitable for use with Harris **do not detect input overvoltage**, as Dr. Wolfe confirmed. See EX2030, 58:24-61:12; EX1040; EX1041.... An unregulated 12V voltage source with $\pm 15\%$ wide tolerance has an expected voltage range of 10.2 – 13.8V. The **28V upper limit** for the converters in EX1040 is well above the 13.8V upper range. So is the **16V upper limit** for the converters in EX1041. Indeed, even if the $\pm 15\%$ tolerance represents only a 3-sigma process, the upper limit for the converters in EX1040 would be 26.7 sigmas away; and the upper limit for the converters in EX1041 would be 6.7 sigmas away. That means **the probability that the input voltage would be above the permissible operating range of these converters is extremely low (6 sigmas means one in half a billion chance)**. As such, a POSITA would have no need to include input overvoltage detection for these regulators.

EX2031 (Mangione-Smith Declaration), ¶117.

Petitioner Has Not Established Any Reason to Detect Over-Voltage in the Harris+Amidi Combination



Petition: A POSA Would Allegedly Be Motivated to Switch to Amidi's Backup Power When Over-Voltage Is Detected Based On Hajeck

The Petition

EX1003, ¶¶185-187. In particular, in the combination for Ground 3, Amidi's voltage supervisory block would be modified to detect voltage anomalies and switch to the backup power not only “[i]f system supply 605 has a magnitude lower than reference voltage 675” as disclosed by Amidi (EX1024, 4:44-52), but also “when the voltage exceeds a certain level” as taught by Hajeck (EX1038,

Petition (918) at 77



SAMSUNG

Hajeck Does Not Suggest Switching To Backup Power In Response To Detecting An Over-Voltage

Hajeck's voltage detection 48 circuit sends a "busy signal" 38 back to the host 32 to prevent the host 32 from performing write operations to the memory subsystem 30 when voltage anomalies are detected. EX1038, 3:30-57

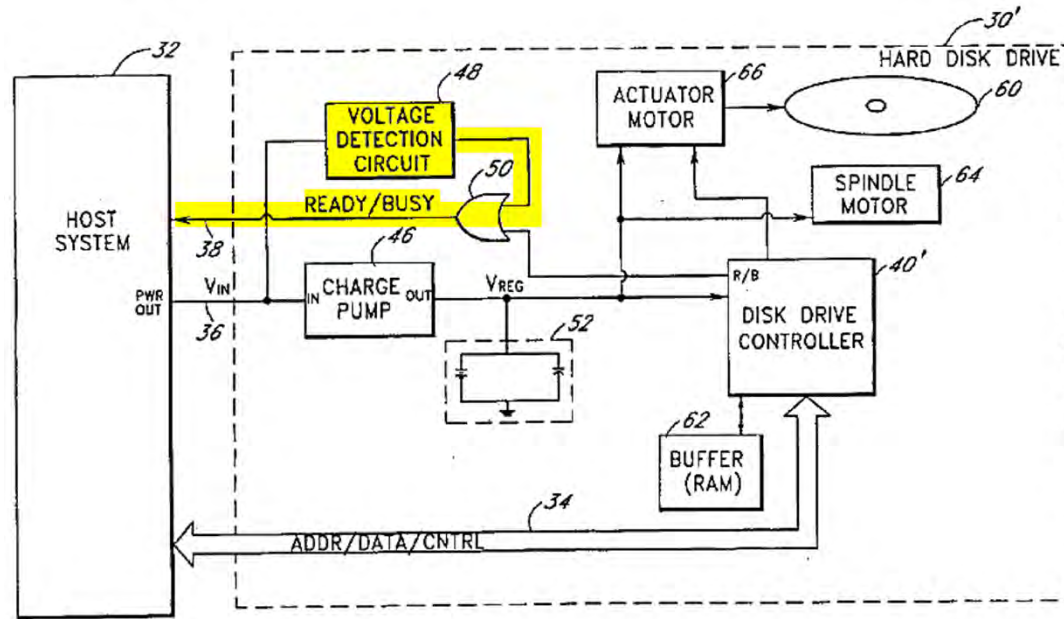
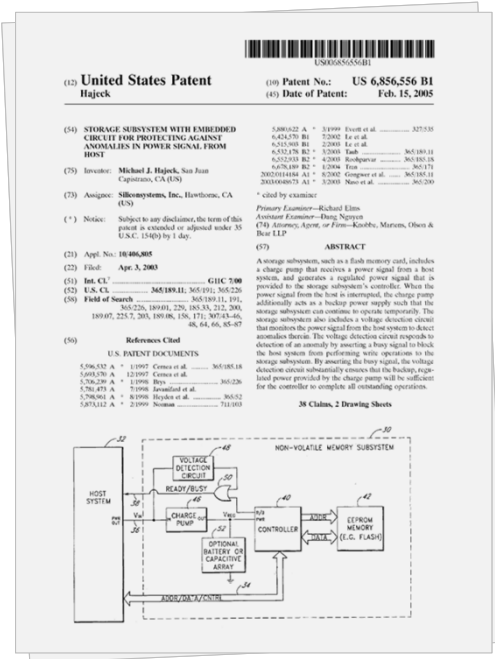


FIG. 2

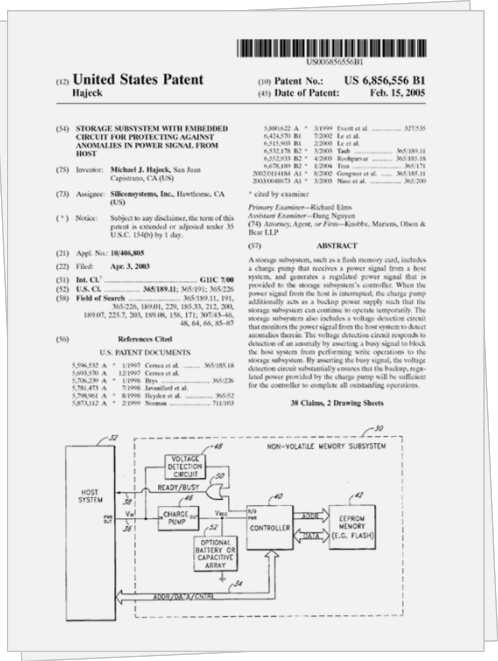
EX1038 (Hajeck), FIG. 2.

Hajeck Reduces The Risk Of Data Loss By Inhibiting New Write Operations, Not Switching To A Different Power Source

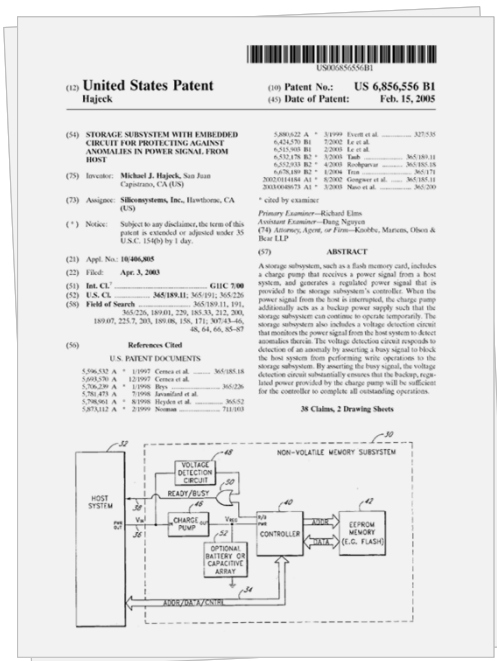
described below). Because new write operations are inhibited, and because the charge pump continues to provide a regulated power signal to the controller 40, the possibility of data corruption (e.g., as the result of incomplete write operations) is significantly reduced. The charge pump also serves to protect the controller 40 and other circuitry from damage caused by voltage surges and spikes.

EX1038 (Hajeck), 4:3-9

Hajeck expressly continues to provide regular power in the event of voltage anomalies



Hajeck Teaches to Use a Charge Pump To Protect Against Over-Voltages, Not To Switch to Backup Power



described below). Because new write operations are inhibited, and because the charge pump continues to provide a regulated power signal to the controller 40, the possibility of data corruption (e.g., as the result of incomplete write operations) is significantly reduced. The charge pump also serves to protect the controller 40 and other circuitry from damage caused by voltage surges and spikes.

EX1038 (Hajeck), 4:3-9

Hajeck Teaches Continued Operation With Same Power Source in Over-Voltage Condition

V_{IN} supplied by the host 32. In addition, the charge pump is preferably designed to protect against sustained voltage drops; for example, in one embodiment, the charge pump is capable of maintaining V_{REG} at 5.4 volts indefinitely as long as V_{IN} exceeds 0.7 volts. The charge pump 46 thus allows the memory subsystem 30 to continue to operate during certain types of power anomalies, including brief power interruptions, spikes and sustained voltage drops. In addition, the charge pump 46 protects the controller 40 from being damaged by spikes and surges in the power signal provided by the host.

(12) United States Patent
Hajeck

(10) Patent No.: US 6,856,556 B1
(45) Date of Patent: Feb. 15, 2005

(54) STORAGE SUBSYSTEM WITH EMBEDDED CIRCUIT FOR PROTECTING AGAINST ANOMALIES IN POWER SIGNAL FROM HOST

(75) Inventor: Michael J. Hajeck, San Jose
Capitola, CA (US)

(73) Assignee: SiliconSystems, Inc., Hawthorne, CA (US)

(*) Notice: Subject to any disclaimer, the term of this patent is extended or adjusted under 35 U.S.C. 154(a) by 1 day.

(21) Appl. No. 10,486,805
(22) Filed: Apr. 3, 2003

(51) Int. Cl. G11C 7/00
(52) U.S. Cl. 365/188.11; 365/191; 365/226

(56) Field of Search: 365/188.11, 191, 365/226, 189/01, 229, 365/39, 725, 206, 189/01, 225.7, 303, 189/08, 126, 171; 307/33-46, 46, 44, 46, 46-47

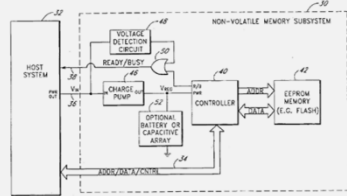
(50) References Cited
U.S. PATENT DOCUMENTS
5,966,532 A * 1/1997 Coma et al. 365/185.14
5,600,230 A * 12/1997 Coma et al. 365/185.14
5,766,236 A * 1/1999 Bays 365/226
5,786,475 A * 7/1999 Kozlowski et al.
5,786,961 A * 8/1999 Hayek et al. 365/226
5,875,112 A * 2/1999 Swanson 365/185.14

2,880,622 A * 3/1999 Everett et al. 327/551
4,624,370 B1 2/2001 Lu et al.
6,521,040 B1 2/2004 Lu et al.
6,521,076 B1 * 2/2004 Tsai 365/185.11
6,522,033 B2 * 4/2004 Rookipour 365/185.15
6,678,189 B2 * 2/2004 Tsai 365/171
2002/014184 A1 * 5/2002 Compaq et al. 365/185.11
2003/0040073 A1 * 2/2003 Nara et al. 365/226

* cited by examiner
Primary Examiner—Richard Elms
Assistant Examiner—Bing Nguyen
(74) Attorney, Agent, or Firm—Kasib, Marston, Olson & Best LLP

ABSTRACT
A storage subsystem, such as a flash memory card, includes a charge pump that receives a power signal from a host system, and generates a regulated power signal that is provided to the storage subsystem's controller. When the power signal from the host is interrupted, the charge pump additionally acts as a backup power supply such that the storage subsystem can continue to operate temporarily. The storage subsystem also includes a voltage detection circuit that monitors the power signal from the host system to detect anomalies therein. The voltage detection circuit responds to detection of an anomaly by asserting a busy signal to block the host system from performing write operations to the storage subsystem. By asserting the busy signal, the voltage detection circuit substantially ensures that the backup regulated power provided by the charge pump will be sufficient for the controller to complete all outstanding operations.

38 Claims, 2 Drawing Sheets



EX1038 (Hajeck), 3:6-15

Dr. Wolfe Agrees: Hajeck's Charge Pump Would Absorb Over-Voltages

“So something like a spike would be diluted in that reservoir and would not be passed through.”

EX2030 (Wolfe Deposition), 229:9-11.

“There will be some set of spikes and surges that can be absorbed by the charge pump.”

EX2030 (Wolfe Deposition), 230:11-13.

Andrew Wolfe
Samsung's Expert

The Samsung logo, consisting of the word "SAMSUNG" in white, uppercase letters inside a blue oval.

None Of The References Motivate Switching To Backup Power In Response To An Over-Voltage

- **Harris**
 - discloses only a design tolerance of +/- 15% for input voltage.
 - does not disclose detecting over-voltages or switching to backup power .
- **Amidi**
 - discloses switching to backup power only in response to power loss.
- **Hajeck**
 - does not disclose/suggest switching to backup power in response to an over-voltage because, in that condition, it inhibits write operations while continuing to provide regular power from Hajeck's charge pump.
 - discloses using a charge pump to protect against over-voltage.

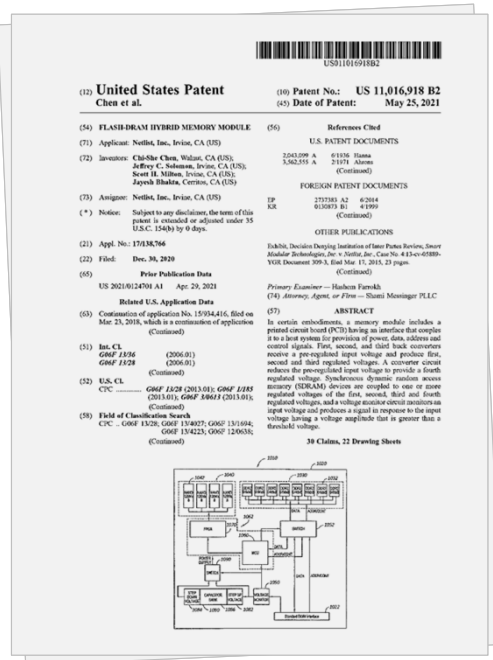
The alleged desire to switch to backup power supply to avoid data loss in an over-voltage condition is not found in any of prior art references, alone or in combination.



Claims 10-11, 15, 22: Non-volatile Memory Within The Logic Element

The '918 Patent

10. The memory module of claim 5, the plurality of components further comprising:
a logic element including a non-volatile memory, the non-volatile memory is configured to store configuration information.



The AMB in Harris+FBDIMM Is Alleged To Include Non-Volatile Memory

The Petition

9. Claim 10

Grounds 2A-2D teach “*claim 5, the plurality of components further comprising: a logic element [e.g., logic in Harris’s Buffer] including a non-volatile memory, the non-volatile memory is configured to store configuration information*”



SAMSUNG

Petitioner Has Not Established That an AMB Includes Non-Volatile Memory

Dr. Wolfe's testimony confirms Petitioner has not provided competent evidence that claims 10-11, 15, 22 are obvious:

Q. I'm asking you specifically whether you know whether there is any non-volatile memory in the advanced memory buffer.

MR. CHANDLER: Objection. Form.

THE WITNESS: I don't know whether or not there is any inside, no.

EX2030 (Wolfe Deposition), 293:1-6.

Andrew Wolfe
Samsung's Expert

SAMSUNG

Petitioner Has Not Established That an AMB Includes Non-Volatile Memory

Petitioner's reference to SPD for claim 15 fails to bridge the gap because SPD and AMB are two different components:

Q. But SPD is not AMB; is that right? Those are two separate components?

A. Those are two separate components --

Q. Okay.

A. -- on the same DIMM.

EX2030 (Wolfe Deposition), 292:21-25.

Andrew Wolfe
Samsung's Expert



SAMSUNG

The Petitions Rely on FBDIMM's S3 Sleep Mode

The 918 Petition

9. Claim 10

Grounds 2A-2D teach “*claim 5, the plurality of components further comprising: a logic element [e.g., logic in Harris’s Buffer] including a non-volatile memory, the non-volatile memory is configured to store configuration information [e.g., S3 Recovery Configuration Registers as required by S3 sleep mode, EX1027,*

10. Claim 11

Grounds 2A-2D teach “*claim 10, wherein, in response to the trigger signal [see claim 5, e.g., from a power disruption], the logic element writes information into the non-volatile memory [e.g., S3 configuration information as discussed above in claims 10 and 15, to allow sleep mode, thus conserving power during*



SAMSUNG

The Petitions Rely on FBDIMM's S3 Sleep Mode

The 054 Petition

4. Claim 5

Grounds 2A-2C teach, at least under Netlist's apparent interpretation, EX1073, p.62, "*claim 4, further comprising: a controller [e.g., logic for controlling S3 sleep mode, discussed above (pp.43-44)] coupled to the voltage monitor circuit [e.g., Amidi's voltage supervisory block, from [4.b]]; wherein, in response to the trigger signal [from [4.b], indicating a power disruption], the controller is configured to perform one or more operations including a write operation to transfer data to non-volatile memory [e.g., S3 configuration information is stored in non-volatile memory before entering S3 sleep mode].*"

EX1003, ¶¶322-340.

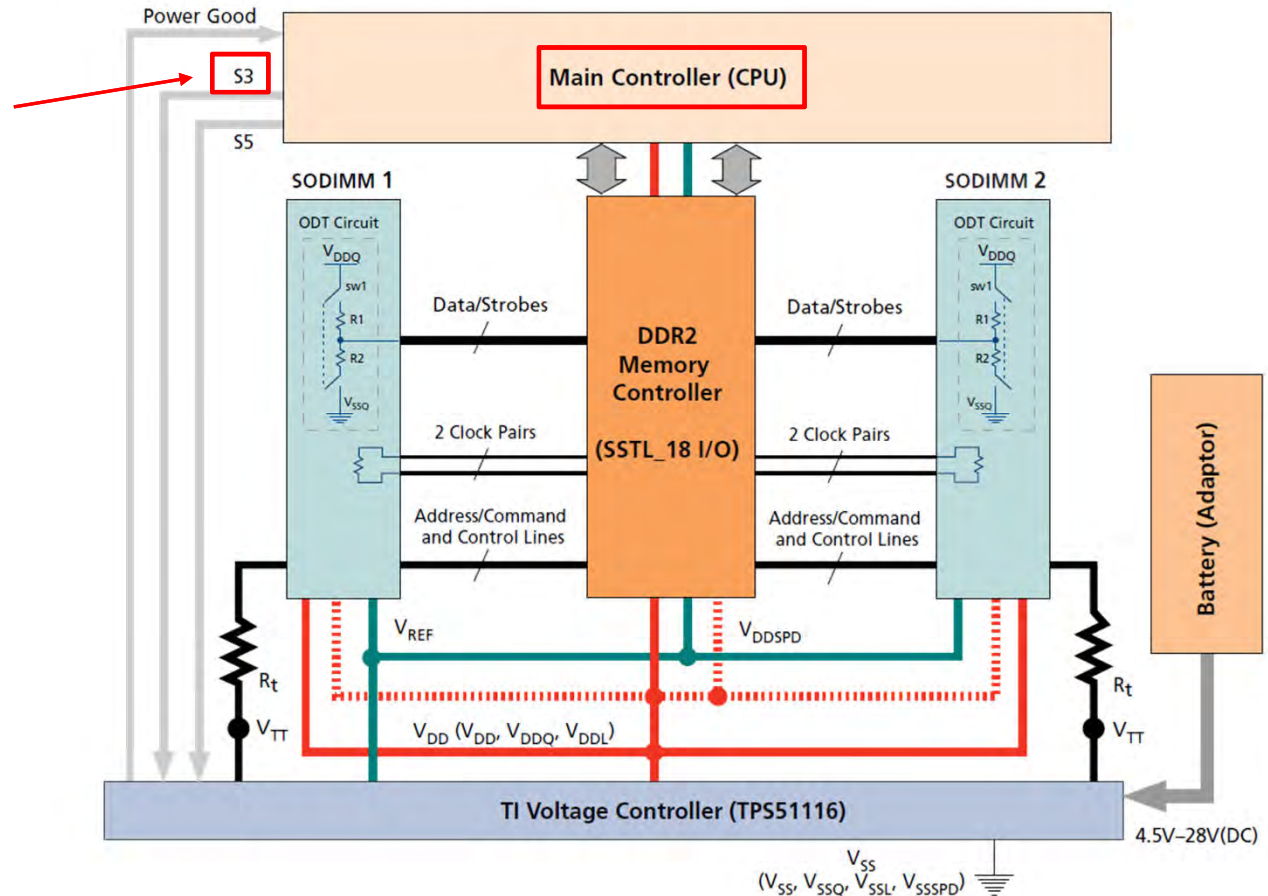


SAMSUNG

S3 Mode Is Controlled By The Main CPU, Not The AMB

Figure 2: Functional Block Diagram of a Dual-Channel, 2-Slot DDR2 Notebook

S3 mode is controlled by the main CPU, not by the AMB on DIMM or even the memory controller (orange)



Dr. Wolfe Confirmed: S3 Is Never Determined By The Memory Module

Andrew Wolfe
Samsung's Expert



SAMSUNG

Q. So for a standard-compliant FB-DIMM, the S3 state is entered into -- determined by the host, not by the memory module itself. Fair?

MR. CHANDLER: Objection to form.

THE WITNESS: It's always determined by something other than the memory module. If its

EX2030 (Wolfe Deposition), 283:18-23.

Because the CPU controls when S3 mode is entered, any alleged "logic element" on the module (e.g., AMB) cannot determine to enter into the S3 state upon detecting an over-voltage condition to execute the write operation in the claimed manner.

Petitioner Fails To Provide Any Competent Evidence That Harris+FBDIMM Could Operate In The Alleged Manner



**William
Mangione-Smith**
Netlist's Expert



39:62 & 40:13, 40:65-41:4, 41:5& 41:22-42:2. The controller for controlling S3 sleep mode, however, is in the host outside the memory module. See above. Moreover, I do not believe that the memory module can be predictably modified to also include a controller that can cause the module to enter an S3 state because S3 was traditionally “determined by something other than the memory module.” EX2030, 282:22-284:25. It is also unclear how the computer system could even properly operate if the memory module were allowed to just enter S3 state by itself.

EX2031 (Mangione-Smith Declaration), ¶125.

TOPICS

GROUND 1-3

Harris Does Not Receive Power Via Edge Connections

Harris Does Not Receive The Recited Signals From the Host

A POSITA Would Not Have Used the Required # of (Buck) Converters

Ground 2 ASSUMES Separate Converters To Supply Each FBDIMM-Required Voltage

A POSITA Would Not Have Replaced Harris' Redundant Power

Additional Reasons Why Dependent Claims Are Not Obvious

GROUND 4-5

The Recited "Memory Module" Means A Main Memory Module

Spiers' PCI Card Is Not a Main Memory Module

POSITA Would Not Use DDR2/DDR3 or Recited # of (Buck) Converters

Additional Reasons Why Dependent Claims Are Not Obvious

The '918/'054 Patents Consistently Describe Memory Modules as Connecting to The Memory Controller

OVERVIEW

Described herein is a memory module couplable to a memory controller of a host system. The memory module

EX1001, 3:66-67

In accordance with one embodiment and as shown in FIG. 4B, the FDHDIMM 400' receives control signals 408 from the MCH, where the control signals may include one or more control signals specifically for the DRAM 402' operation and one or more control signals specifically for the

EX1001, 12:44-48

FIGS. 5A and 5B are block diagrams of a memory module 500 that is couplable to a host system (not shown). The host system may be a server or any other system comprising a memory system controller or an MCH for providing and controlling the read/write access to one or more memory systems, wherein each memory system may include a plu-

EX1001, 12:52-57

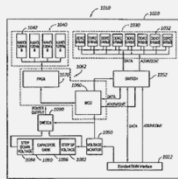
DEMONSTRATIVE EXHIBIT – NOT EVIDENCE

(12) United States Patent
Chen et al.

(11) Patent No.: US 11,016,918 B2
(45) Date of Patent: May 25, 2021

(54) FLASH-DRAM HYBRID MEMORY MODULE
(71) Applicant: Netlist, Inc., Irvine, CA (US)
(72) Inventors: Chi-Shu Chen, Walnut, CA (US); Jeffrey C. Robinson, Irvine, CA (US); Scott H. Milnes, Irvine, CA (US); Joseph Shukla, Corvallis, CA (US)
(73) Assignee: Netlist, Inc., Irvine, CA (US)
(* *) Notice: Subject to any disclaimer, the term of this patent is extended or adjusted under 35 U.S.C. 154(b) by 9 days.
(21) Appl. No.: 17/838,766
(22) Filed: Dec. 30, 2020
(65) Prior Publication Data
US 2021/0124701 A1 Apr. 29, 2021

Related U.S. Application Data
(56) References Cited
U.S. PATENT DOCUMENTS
2013/0161188 A1 6/19/13
2017/0181111 A1 2/17/18
(*) FOREIGN PATENT DOCUMENTS
EP 3737815 A2 6/20/14
EP 3105873 B1 4/1/19
(*) OTHER PUBLICATIONS
Eubank, Devices Displaying Indicators of Error Paths Review, Smart Module Technologies, Inc. v. State, Inc., Case No. 4:13-cv-01889-VGR Document 309-A, Filed Mar. 11, 2015, 12 pages.
Primary Examiner – Harkoon Farah
(74) Attorney, Agent, or Firm – Sham Messinger PLLC



The District Court: The Invention Is Directed to Memory Modules That Connect To the Memory Controller (i.e., Main Memory)



devices by the claims. To the contrary, as the Overview section explains, the invention “is cou-
plable to a memory controller of a host system,” ’918 Patent at 3:66–67 (emphasis added), not just
the host system as recited in the claims. *See also id.* at 1:66–67 (“[t]he present disclosure relates
generally to computer memory devices”). Thus, a skilled artisan would understand a “memory
module” is distinct from, and has essential structural requirements not necessarily found in, other
modular computer accessories. That includes the structure necessary to connect to a memory con-
troller. *See Memory Systems: Cache, DRAM, Disk*, Dkt. No. 76-17 at 319 (depicting, in FIG. 7.6,
a memory controller connected to two memory modules). Accordingly, the preambles are limiting.

EX2032 (Samsung’s Objections to Claim Construction Order), 28

The District Court: The Recited “Memory Module” Includes Structure Necessary To Connect To A Memory Controller



devices by the claims. To the contrary, as the Overview section explains, the invention “is cou-
plable to a memory controller of a host system,” ’918 Patent at 3:66–67 (emphasis added), not just
the host system as recited in the claims. *See also id.* at 1:66–67 (“[t]he present disclosure relates
generally to computer memory devices”). Thus, a skilled artisan would understand a “memory
module” is distinct from, and has essential structural requirements not necessarily found in, other
modular computer accessories. That includes the structure necessary to connect to a memory con-
troller. *See Memory Systems: Cache, DRAM, Disk*, Dkt. No. 76-17 at 319 (depicting, in FIG. 7.6,
a memory controller connected to two memory modules). Accordingly, the preambles are limiting.

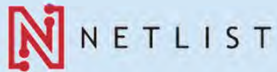
EX2032 (Samsung’s Objections to Claim Construction Order), 28

Court cited to same FIG. 7.6 of EX2034

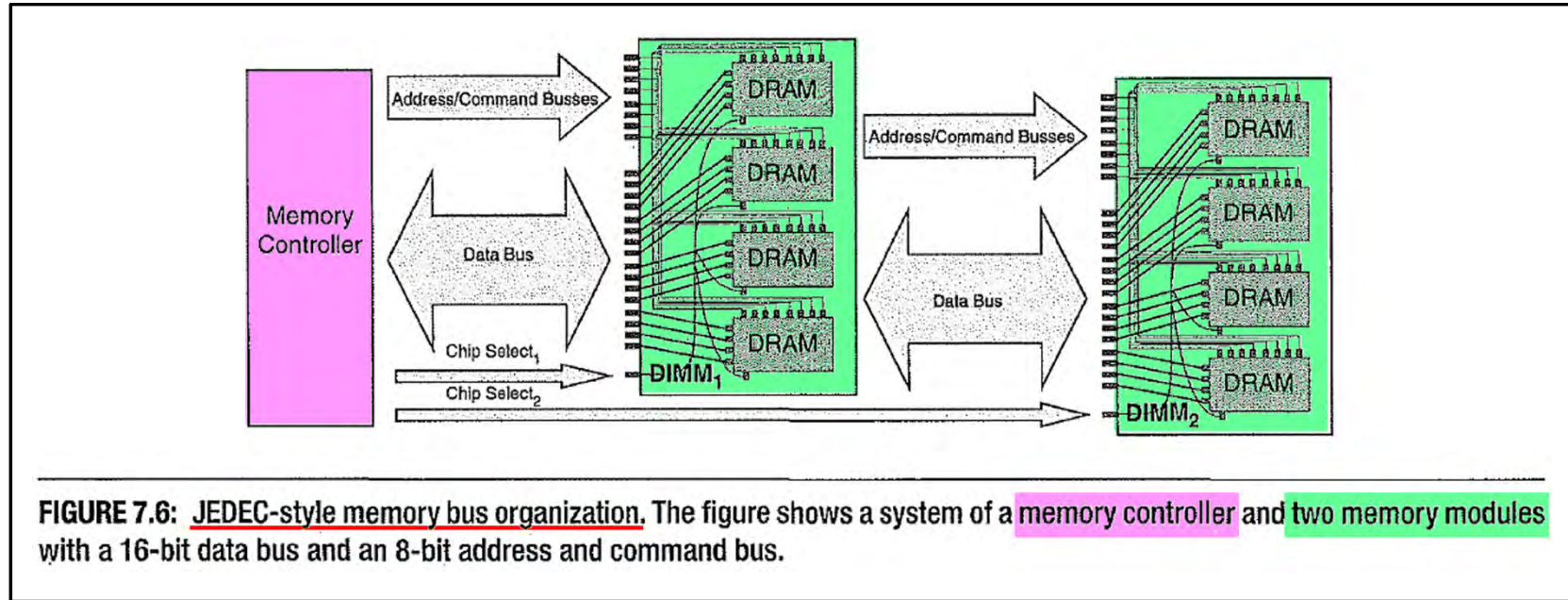
Memory Modules That Connect to The Memory Controller via Memory Buses Are Main Memory Modules



William Mangione-Smith
Netlist's Expert



JEDEC-Style Memory Architecture



EX2031 (Mangione-Smith Declaration), ¶153 (citing EX2034 (Memory Systems), at 319).

Dr. Wolfe: Main Memory Modules Connect To The Memory Controller

Andrew Wolfe
Samsung's Expert



SAMSUNG

Q. When you say "main memory modules," what do you mean?

A. Memory modules that are designed to connect to the primary memory controller for the purpose of holding general purpose code and data in a computer system.

EX2030 (Wolfe Deposition), 123:20-25.

Petitioner Did Not Object To the Court's Findings On The Meaning of "Memory Module"



SAMSUNG

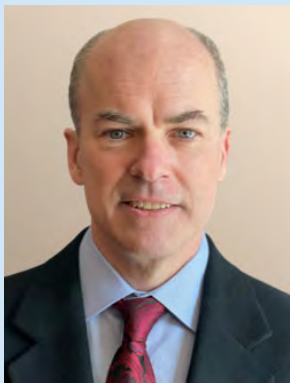
"A memory module"	
Defendants' Proposed Construction	Order
Preamble is non-limiting	Preamble is limiting

The Order erred in finding the preamble limiting. For the reasons stated in Samsung's claim construction brief, Samsung requests the Court adopt Samsung's construction. Dkt. 82 at 12-13. Each of the claims at issue recite a structurally complete invention, and as a result, the preambles are non-limiting statements of intended purpose. See *Catalina Mktg. Int'l, Inc. v. Coolsavings.com, Inc.*, 289 F.3d 801, 808 (Fed. Cir. 2002) (internal citations, quotations omitted).

EX2033 (Samsung's Objections to Claim Construction Order), 3.

Petitioner only objected to the Court's finding that the preamble is limiting, not to the Court's findings as what a "memory module means to a POSA.

The Recited “Memory Modules” Are Main Memory Modules That Connect to The Memory Controller



**William
Mangione-Smith**
Netlist's Expert



and data in a computer system.” EX2030, 123:14-25. I agree, and in my experience, at the time of the invention and in the context of the ‘918 patent, the term “memory module” would be understood by a POSITA to refer to a module that is to be inserted into a dedicated memory slots and that includes structures necessary to connect to a memory controller for use as memory. See ‘918, 3:66-67; see also below.

EX2031 (Mangione-Smith Declaration), ¶153.

Both the intrinsic and extrinsic evidence support interpreting “memory modules” as main memory modules that include structures to connect to a memory controller.

TOPICS

GROUND 1-3

Harris Does Not Receive Power Via Edge Connections

Harris Does Not Receive The Recited Signals From the Host

A POSITA Would Not Have Used the Required # of (Buck) Converters

Ground 2 ASSUMES Separate Converters To Supply Each FBDIMM-Required Voltage

A POSITA Would Not Have Replaced Harris' Redundant Power

Additional Reasons Why Dependent Claims Are Not Obvious

GROUND 4-5

The Recited "Memory Module" Means A Main Memory Module

Spiers' PCI Card Is Not a Main Memory Module

POSITA Would Not Use DDR2/DDR3 or Recited # of (Buck) Converters

Additional Reasons Why Dependent Claims Are Not Obvious

The Petition Relies on Spiers' PCI Card As The Recited "Memory Module"

The Petition

2. Independent Claim 1


a) *[1.a] Preamble*

To the extent the preamble is limiting, Grounds 4A-4C teach “[a] memory module comprising [e.g., Spiers’ backup device 144 (below) implemented in a PCI card including volatile memory (SDRAMs 190, yellow) and non-volatile memory (NAND Flash 194, green), and configured to store data in a memory system].” EX1003, ¶¶643-646; EX1025, ¶¶[0034, 37], Figs. 3, 5.



SAMSUNG

Spiers' Backup Device


 US 20060080515 A1

(19) **United States**
 (12) **Patent Application Publication** (10) Pub. No.: **US 20060080515 A1**
 Spiers et al. (41) Pub. Date: **Apr. 13, 2006**

(54) **NON-VOLATILE MEMORY BACKUP FOR NETWORK STORAGE SYSTEM** (52) U.S. CL. _____ 711/042, 714/14

(75) Inventors: **John Spiers**, Louisville, CO (US);
Mark LeFebvre, Libertyville, IL (US);
Mark C. Hayden, Fairfield, CA (US);
Mike A. Hayward, Boulder, CO (US)

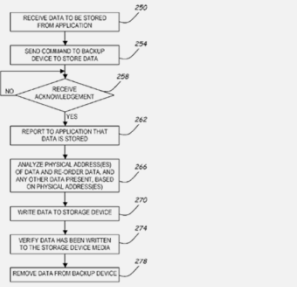
Correspondence Address:
KENNETH C. WINTERSON
HURLAND & HARE LLP
P. O. BOX 4749
DENVER, CO 80201-4749 (US)

(73) Assignee: **LEFTHAND NETWORKS, INC.**,
 Boulder, CO (US)

(21) Appl. No.: **10/741,901**

(22) Filed: **OCT. 12, 2004**

Publication Classification
 (51) Int. Cl. **G06F 12/00** (2006.01)



```

    graph TD
        250[RECEIVE DATA TO BE STORED FROM APPLICATION] --> 254[SEND COMMAND TO BACKUP DEVICE TO STORE DATA]
        254 --> 258{RECEIVE ACKNOWLEDGEMENT}
        258 -- NO --> 254
        258 -- YES --> 262[REPORT TO APPLICATION THAT DATA IS STORED]
        262 --> 266[ANALYZE PHYSICAL ADDRESSES OF DATA AND RE-CROSS DATA AND ANY OTHER DATA PRESENT BASED ON PHYSICAL ADDRESSES]
        266 --> 270[WRITE DATA TO STORAGE DEVICE]
        270 --> 274[VERIFY DATA HAS BEEN WRITTEN TO THE STORAGE DEVICE REGION]
        274 --> 278[RECOVER DATA FROM BACKUP DEVICE]
    
```

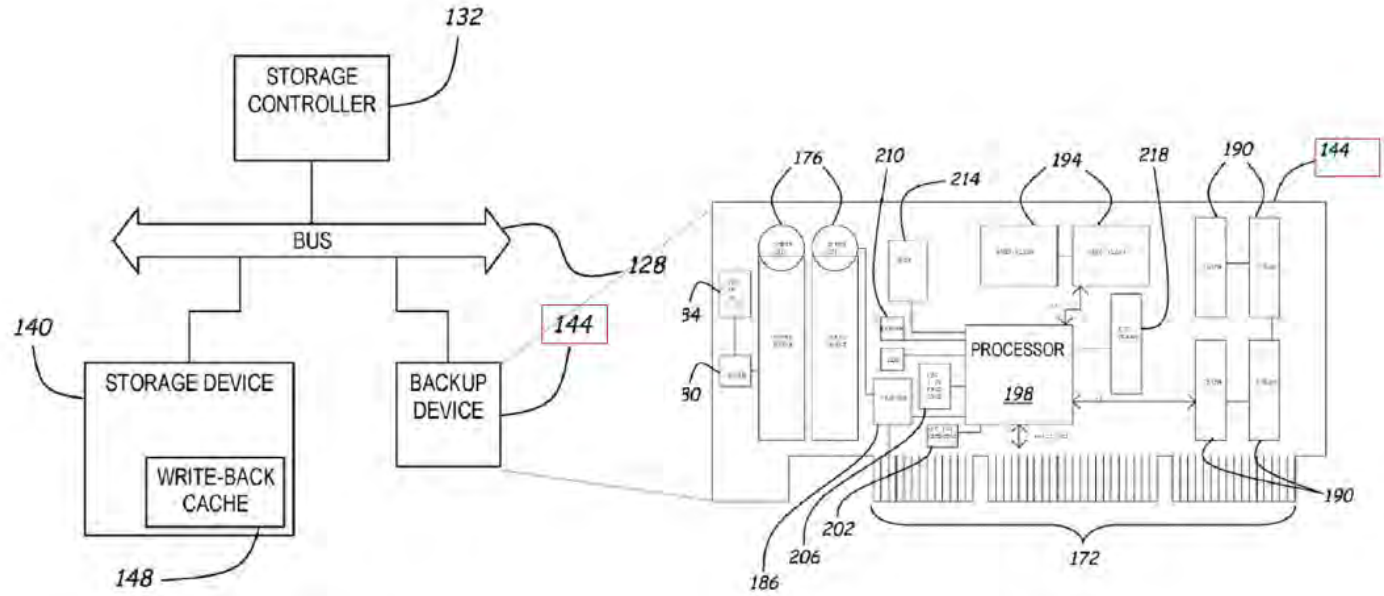


FIG.3

FIG.5

Dr. Wolfe: Spiers' PCI Card Is Allegedly A "Memory Module" Because It Includes Memories Mounted On It

Andrew Wolfe
Samsung's Expert



SAMSUNG

644. A Skilled Artisan would have understood that this backup device is a "memory module" because it includes a card (PCI card) with memories mounted on it and configured to store data received from the system, as shown in Figure 3 of Spiers reproduced below.

EX1003 (Wolfe Declaration), ¶644.

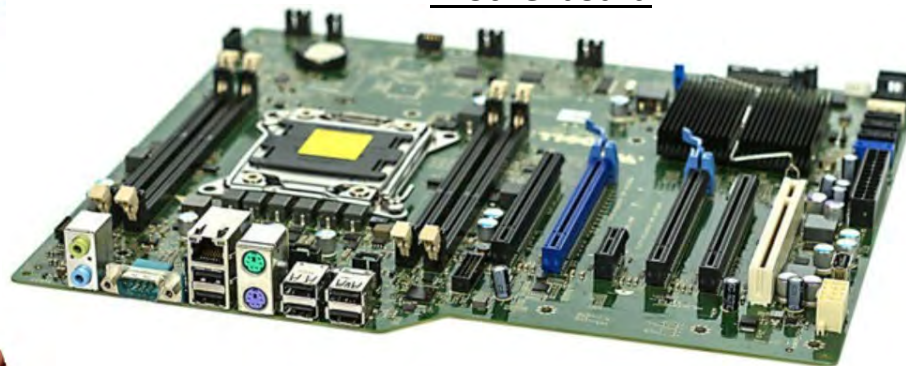
Every Graphics Card and System on Chip Is A Memory Module Under Dr. Wolfe's Interpretation

Under Dr. Wolfe's Interpretation, These Are "Memory Modules" Because They Have Memories Mounted On Them

Graphics Card



Motherboard



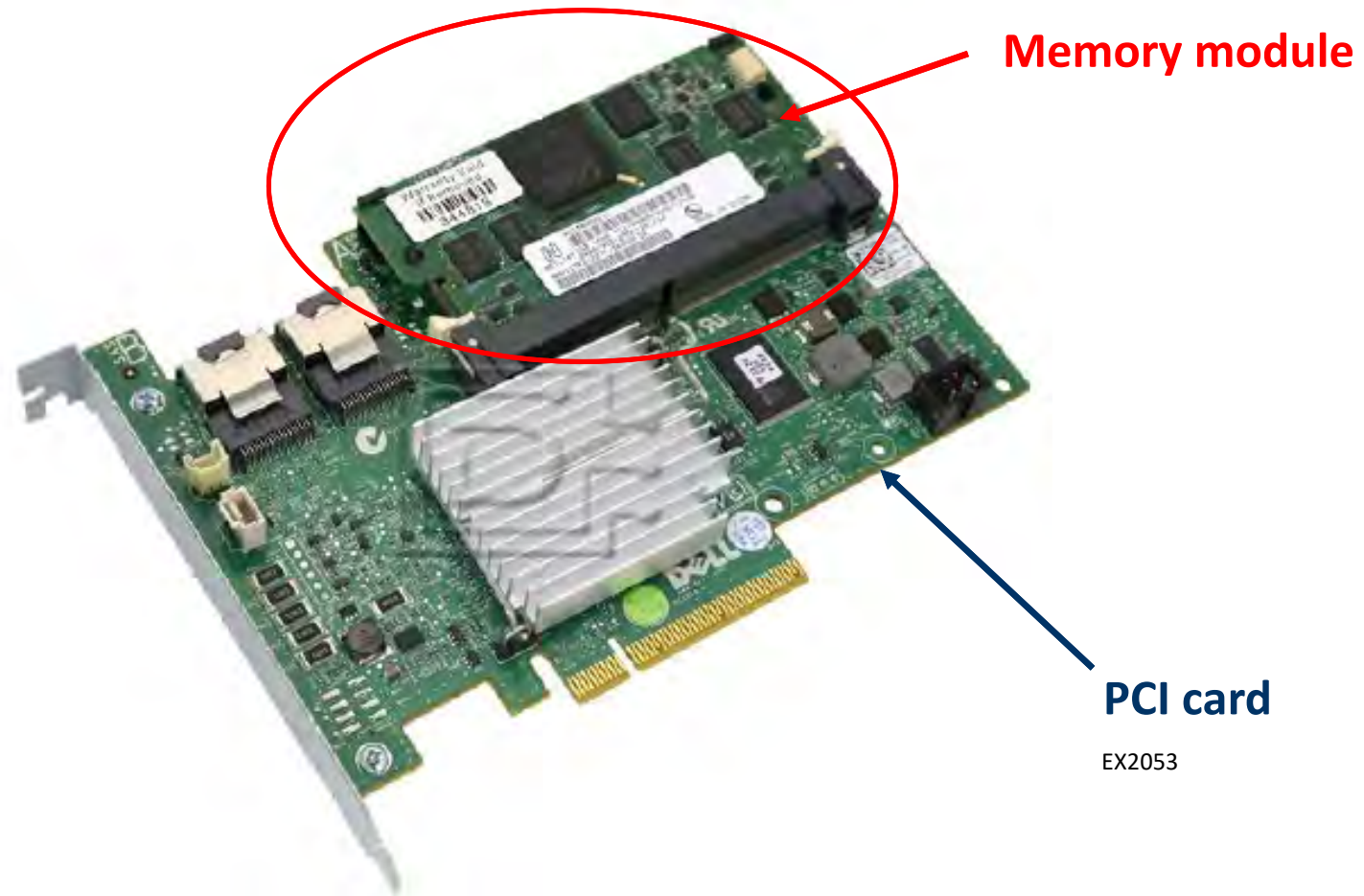
Gaming Console



Andrew Wolfe
Samsung's Expert

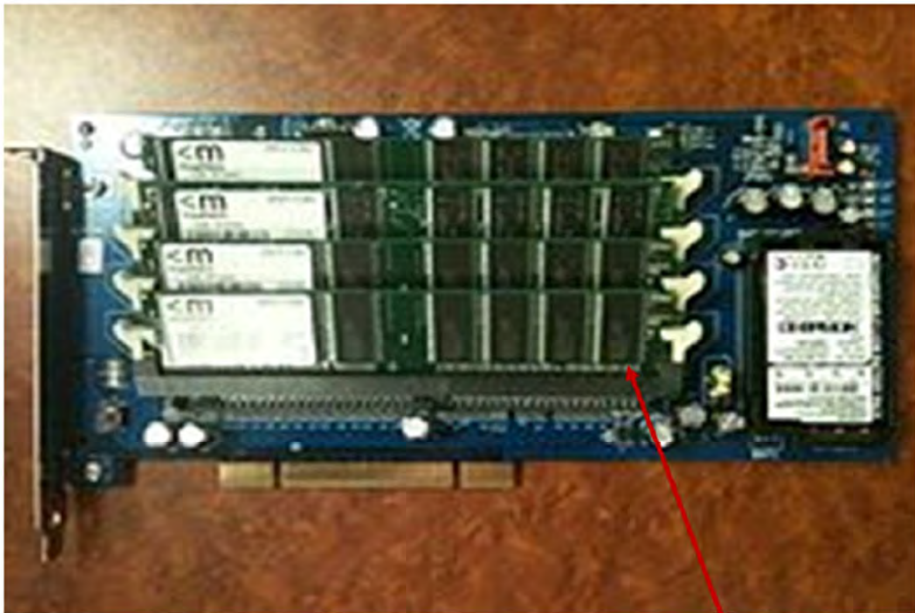
SAMSUNG

Memory Module on a PCI Card is a Separate Component

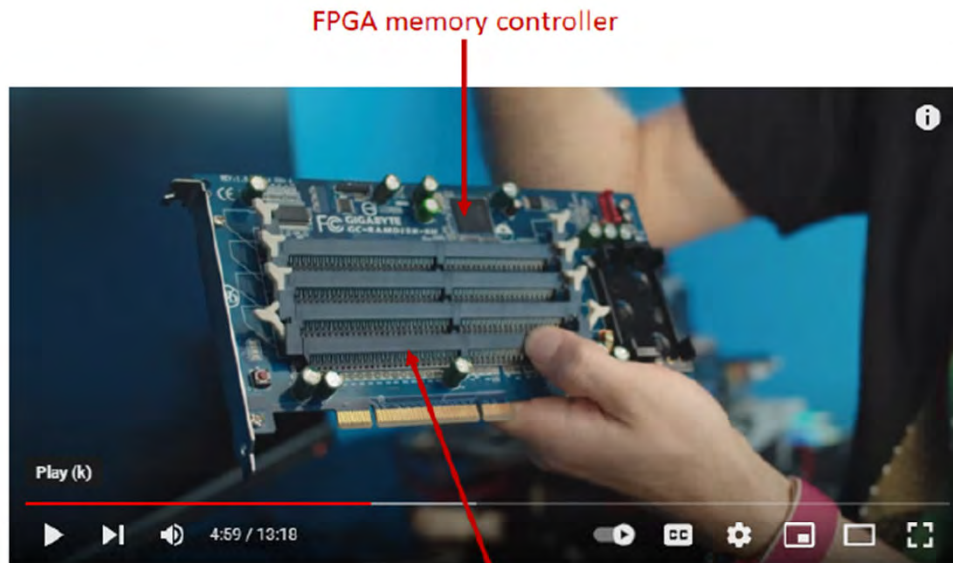


EX2053

A PCI Card includes Memory Modules and Other Components



4 slots on PCI populated with 4 DIMMs



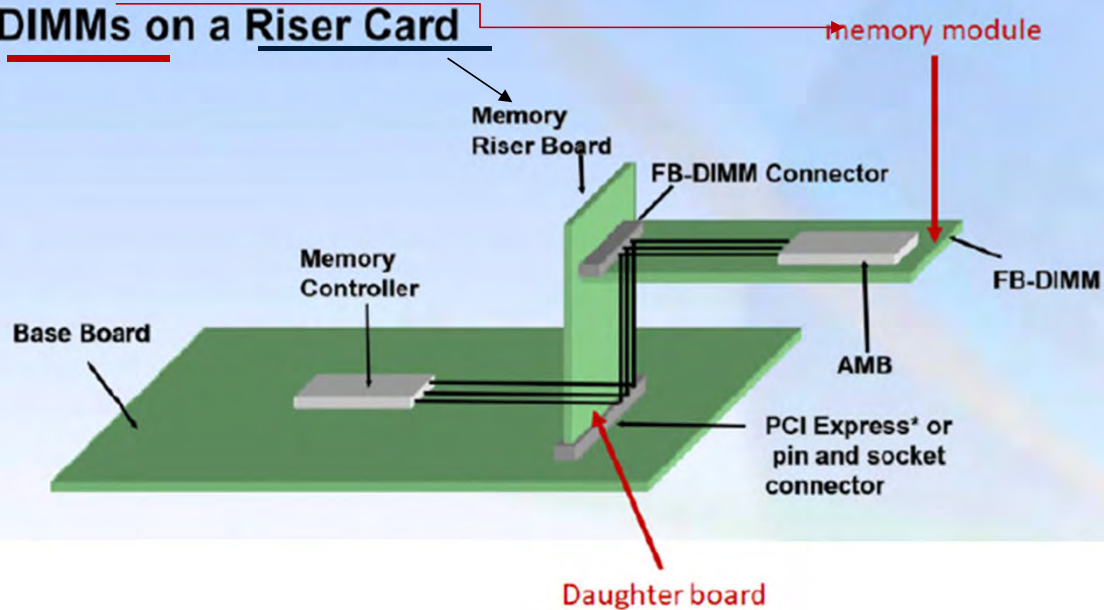
FPGA memory controller

4 slots on PCI for up to 4 DIMMs

Memory Module on a Card is a Separate Component

FB-DIMM Topologies

DIMMs on a Riser Card



William Mangione-Smith



Q. Is the memory riser board part of that memory module?

A. No, it's not.

EX1075, 223:24-225:9 (Mangione-Smith)

Spiers' PCI Card Is Not a "Memory Module"



- Spiers' PCI card does not connect to a memory controller (or include structure necessary to connect to a memory controller).
- Even Under Petitioner's theory, Spiers' PCI card is not a "memory module" because it is not "a circuit board that connects to a host computer that includes memory." Reply 2.

Spiers' PCI Card Is Not a "Memory Module"



- **Spiers' PCI card does not connect to a memory controller (or include structure necessary to connect to a memory controller).**
- Even Under Petitioner's theory, Spiers' PCI card is not a "memory module" because it is not "a circuit board that connects to a host computer that includes memory." Reply 2.

Spiers' PCI Card Does Not Connect To A Memory Controller

Andrew Wolfe
Samsung's Expert



SAMSUNG

- Dr. Wolfe confirmed (and the Reply does not dispute) that:**
- “in the context of an ordinary microprocessors,” **a memory controller is “the interface that provides the timing and control signals to memory.”** EX2030, 213:24-214:4.
 - in Spiers, the **storage controller 132 does not provide timing or control signals** to either the SDRAM or NAND flash on Spiers' PCI card. *Id.*, 214:17-215:24.

Dr. Mangione-Smith confirmed the same. EX2031, ¶129

Spiers' PCI Card Does Not Connect To A Memory Controller

Andrew Wolfe
Samsung's Expert



SAMSUNG

Q. What is a memory controller?

A. Again, it depends on context, but in the context of an ordinary microprocessor, it's **the interface that provides the timing and control signals to memory.**

EX2030, 213:24-214:4 (objections omitted)

Spiers' PCI Card Does Not Connect To A Memory Controller

Q. Does the **storage controller 132** provide **timing and control signals** to the NAND flash on the PCI card?

A. **No.**

EX2030, 214:23-215:2 (objections omitted)

Andrew Wolfe
Samsung's Expert

SAMSUNG

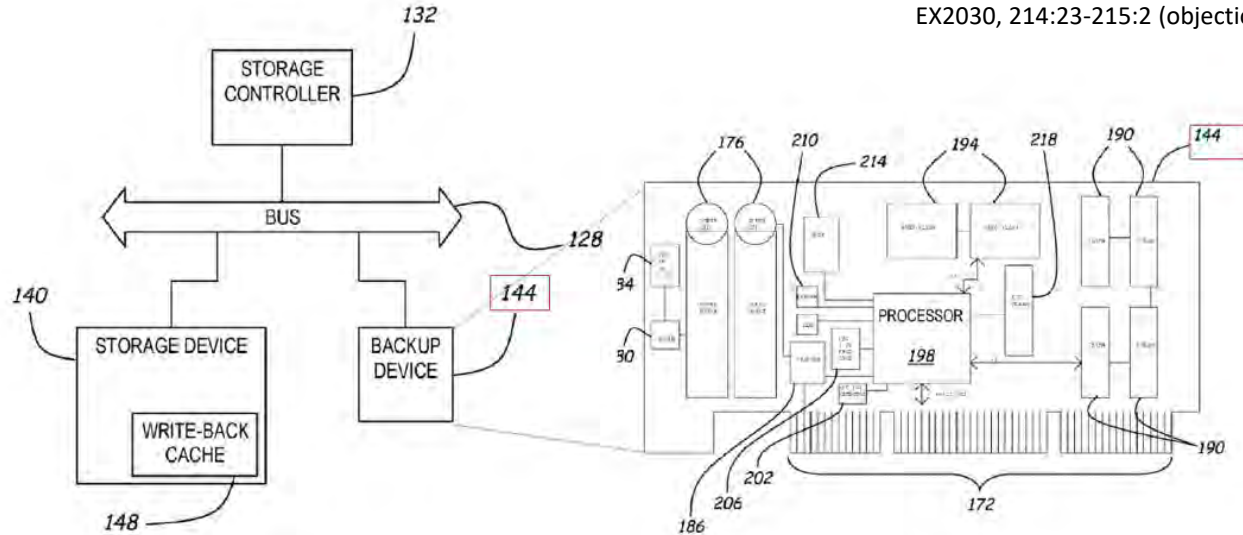


FIG. 3

FIG. 5

Spiers' PCI Card Does Not Connect To A Memory Controller

Andrew Wolfe
Samsung's Expert



SAMSUNG

Q. Okay. So does the **memory controller within the storage controller 132** provide the timing and control signals to the NAND flash on the PCI card?

A. No.

Q. Does the **memory controller within the storage controller 132** provide the timing and control signals to the SDRAM on the PCI card?

A. No.

EX2030, 215:14-24 (objections omitted)

Dr. Wolfe Confirmed That Spiers' Storage Controller Is Not A Memory Controller For The Memory On The PCI Card

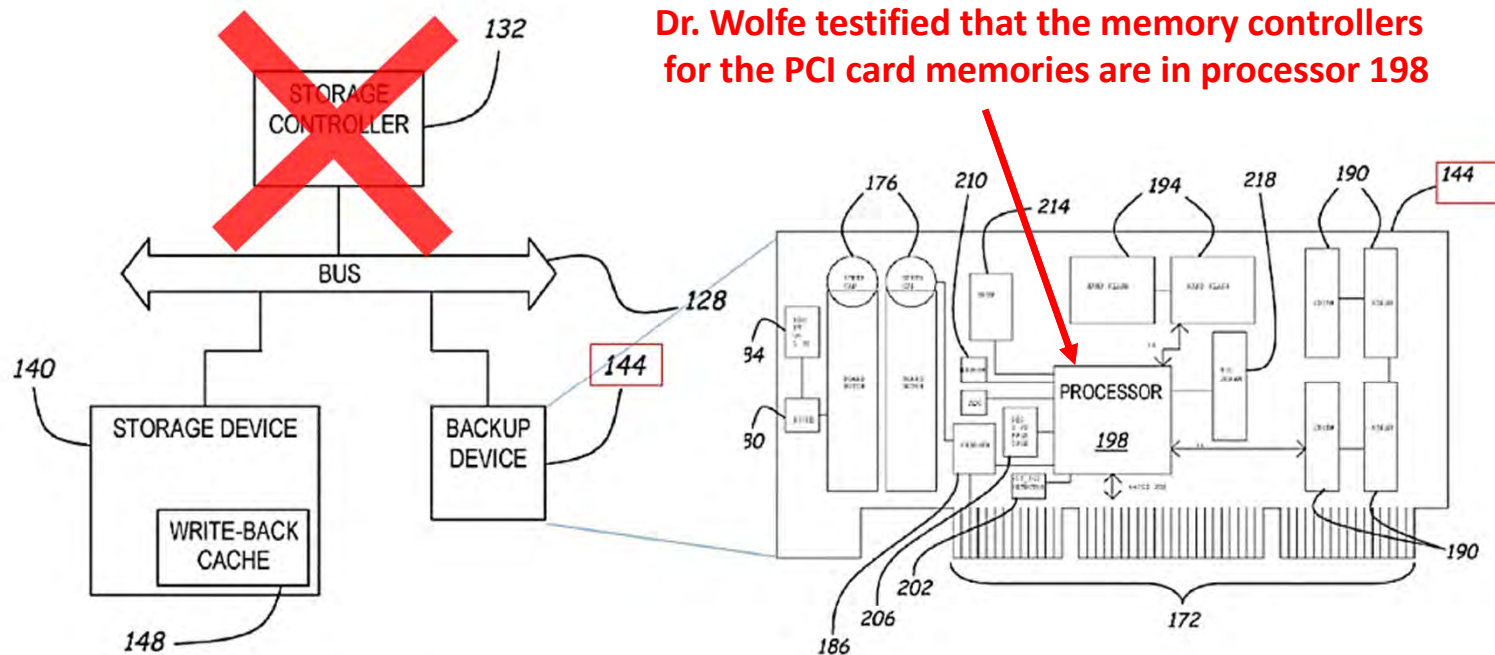


FIG.3

FIG.5

Neither Spiers nor Petitioner identify any other memory controller in Spiers.

Petitioner's Alleged Voltage Converters Are Not On Spiers' Memory Modules

Petitioner's alleged converters providing regulated voltages VCC, VDD, VDDQ, VTT, etc.

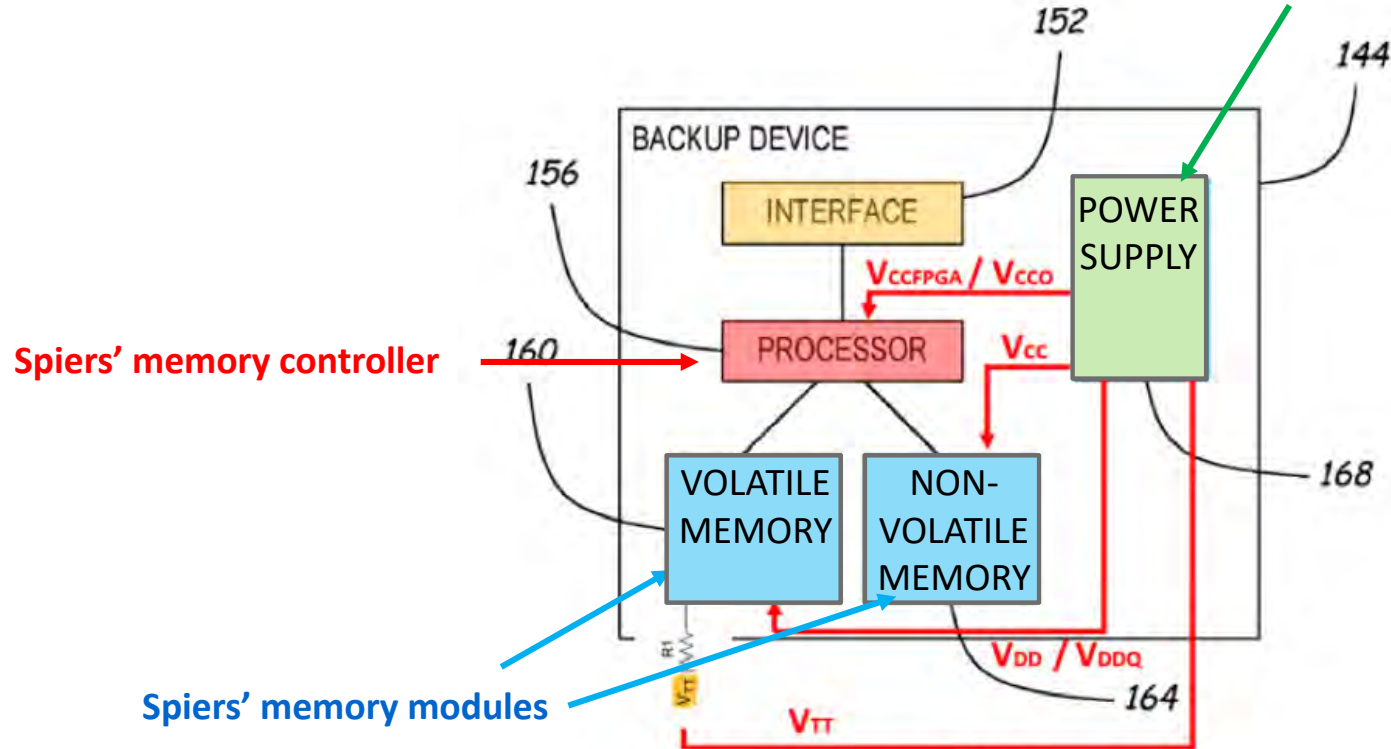


FIG. 4

Spiers' PCI Card Process Is System Memory Controller

Andrew Wolfe
Samsung's Expert



SAMSUNG

Q. And so the only memory controller that provides the timing and control signals to the SDRAM and the NAND flash on the PCI card is the memory controller within processor 198 on the PCI card; is that correct?

A. There would likely be multiple memory controllers within 198, one for the NAND flash and one for the SDRAM.

Q. Okay. So the memory controllers that provide the timing and the control signals to the memories on the PCI card, are those residing within processor 198? Is that fair?

A. Yes.

EX2030, 216:2-17 (objections omitted)

Spiers' Converters Are Not On The Memory Modules

RED:
Memory controller for the PCI
card memories in processor 198

Blue:
Spiers' memory modules

Green:
Alleged converters

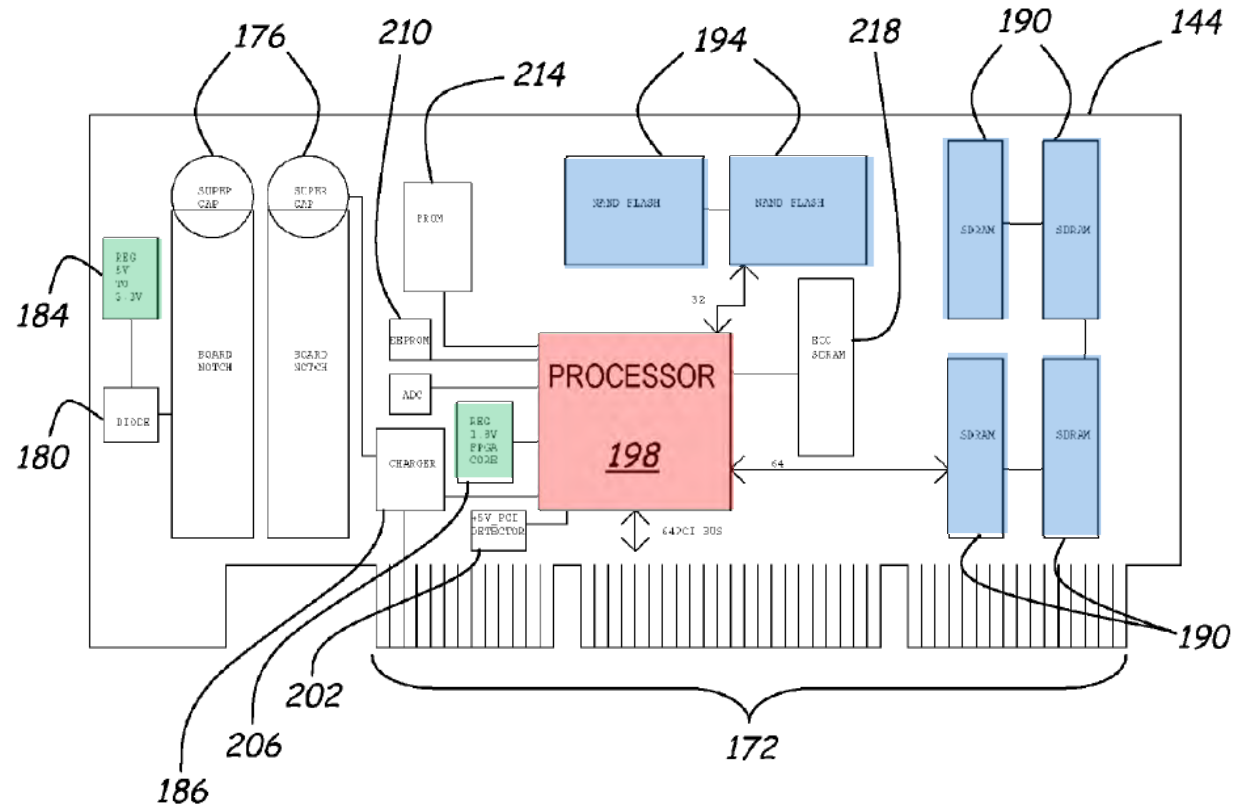


FIG. 5

Spiers' PCI Card Does Not Need To Connect To A Memory Controller

Andrew Wolfe
Samsung's Expert



SAMSUNG

Dr. Wolfe confirmed (and the Reply does not dispute) that:

- the **memory controllers** that provide the timing and control signals to the memory on Spiers' PCI card **reside only in the microprocessor 198 on the PCI card.**

EX2030, 216:2-17, 214:6-10

Dr. Mangione-Smith confirmed the same. EX2031, ¶129

Spiers' PCI Card Does Not Connect To A Memory Controller

Andrew Wolfe
Samsung's Expert



SAMSUNG

Q. And so the only memory controller that provides the timing and control signals to the SDRAM and the NAND flash on the PCI card is the memory controller within processor 198 on the PCI card; is that correct?

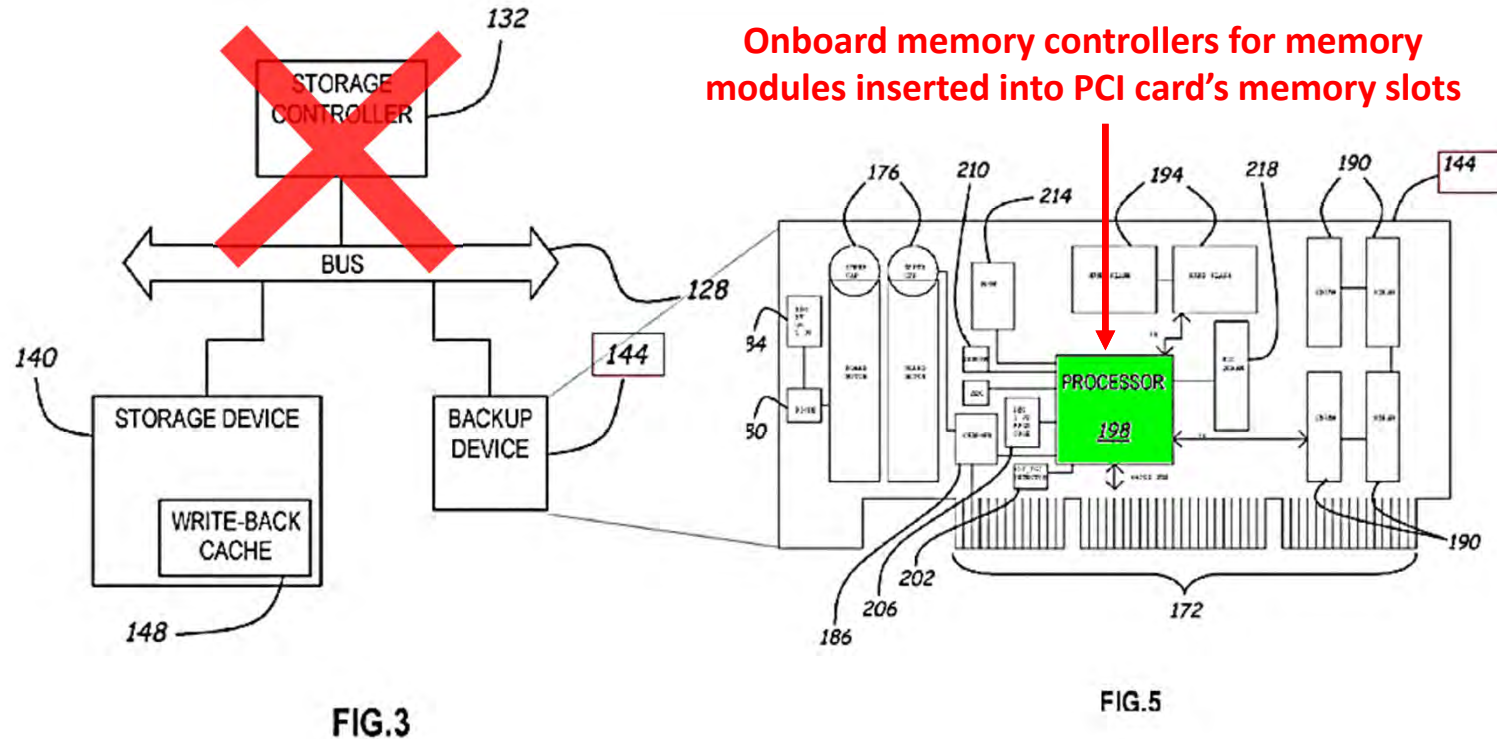
A. There would likely be multiple memory controllers within 198, one for the NAND flash and one for the SDRAM.

Q. Okay. So the memory controllers that provide the timing and the control signals to the memories on the PCI card, are those residing within processor 198? Is that fair?

A. Yes.

EX2030, 216:2-17 (objections omitted)

The Memory Controllers For Spiers' Memories Reside On The PCI Card



Onboard memory controllers for memory modules inserted into PCI card's memory slots

Because Spiers' PCI Card contains onboard memory controllers, Spiers' PCI card is not a "memory module" because it does not connect to a memory controller (nor need to)

Spiers' PCI Card Is Not a "Memory Module"



- Spiers' PCI card does not connect to a memory controller (or include structure necessary to connect to a memory controller).
- **Even under Petitioner's new reply theory, Spiers's PCI card is not a "memory module" because it is not "a circuit board that connects to a host computer that includes memory." Reply (054) at 2.**

Petitioner's New Construction of Memory Module In Reply

“Netlist misleadingly quotes statements by Dr. Wolfe about “*main* memory modules,” POR 3-4, but Dr. Wolfe explained that in the context of *this* patent, a “memory module” is *not* limited to main memory or to any specific connection, EX2060, 125:12-127:13 (“memory module” is “a circuit board that connects to a host computer that includes memory”); *see also* EX2056, 100:15-101:19 (similar).”

Reply (054) at 2.

Spier's PCI Card Is Not a "Memory Module"

In Spier's PCI card, the memory is included on the separate SDRAM/NAND module cards, not on the PCI card.

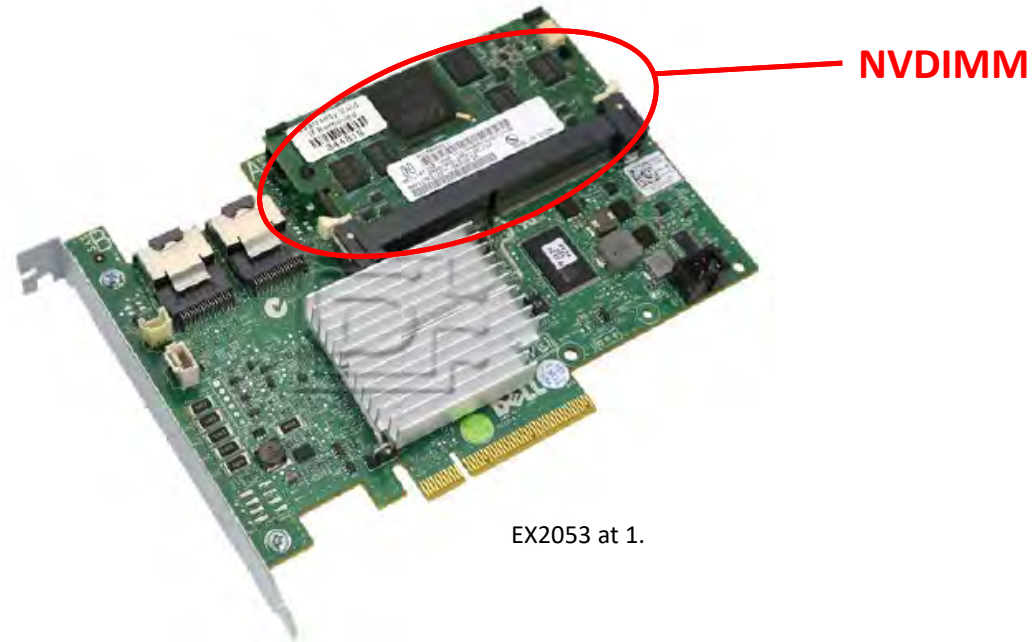


4 slots on PCI populated with 4 DIMMs



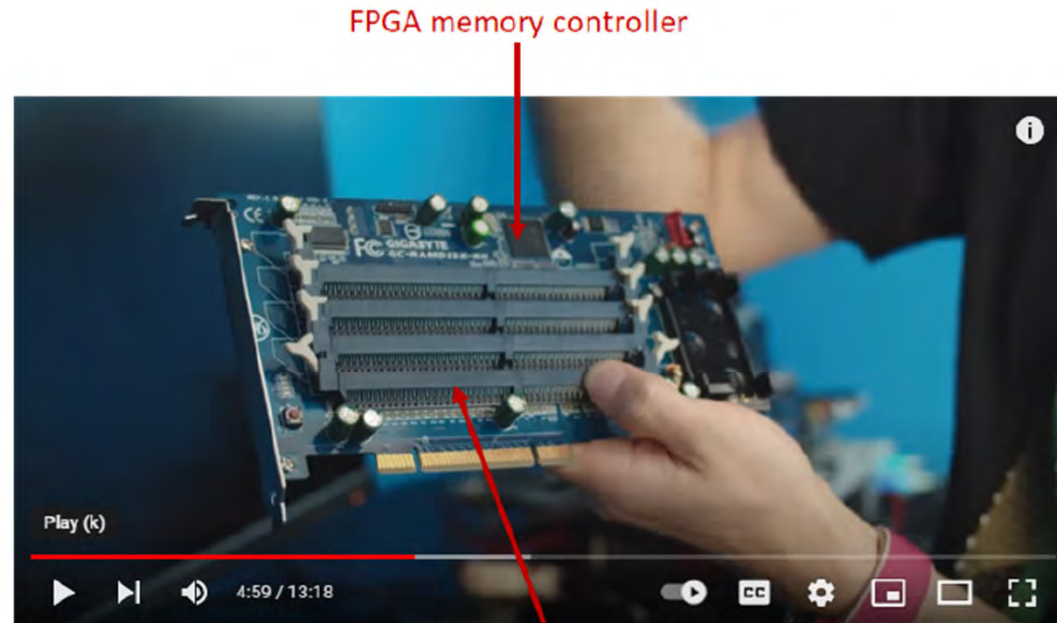
Spiers' PCI Card Is Not a "Memory Module"

A PCI-Express card with a Netlist NVDIMM.



The "memory module" is the NVDIMM, not the PCI card).

Spiers-Type PCI Cards Were Known To Include Onboard Memory Controllers And DIMM Slots

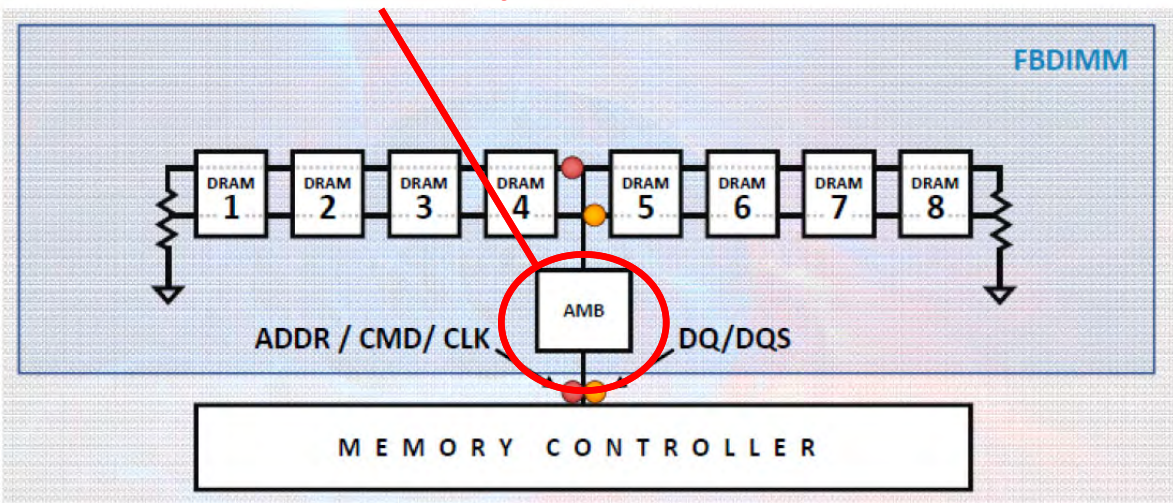


Spiers' PCI card is no more a memory module than a graphics card containing DRAM memory, a motherboard having memory slots filled by DIMMs, or a computer with DRAM modules.

AMBs Do Not Satisfy Petitioner's Definition of Memory Controller



AMB Does Not Satisfy Dr. Wolfe's Definition

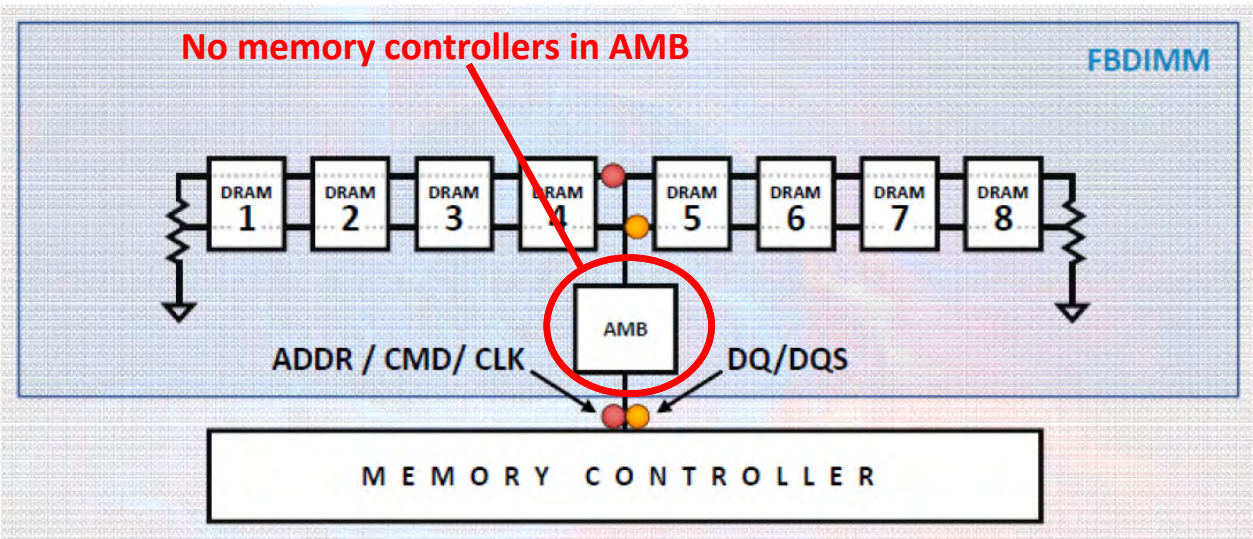


Andrew Wolfe
Samsung's Expert



- Q. What is a memory controller?
- A. Again, it depends on context, but in the context of an ordinary microprocessor, it's the interface that provides the timing and control signals to memory.

AMBs Do Not Satisfy Petitioner's Definition of Memory Controller



Dr. Wolfe confirmed that:

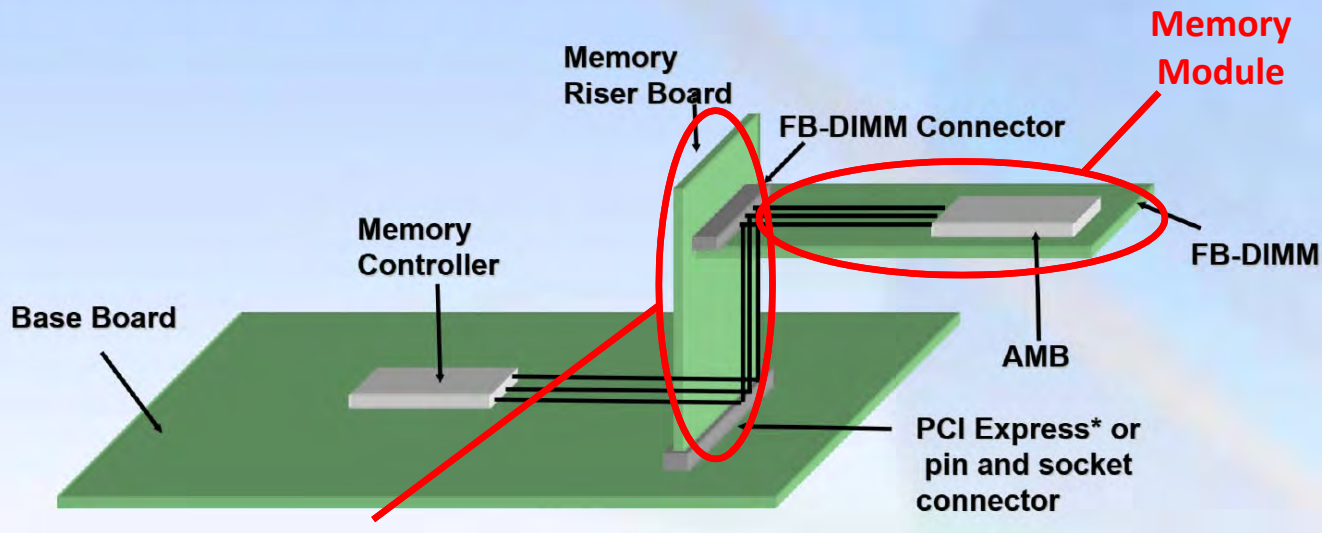
- “the **memory controllers** that provide the timing and control signals to the memory on Spiers’ PCI card **reside only in the microprocessor 198 on the PCI card.**”

EX2030, 216:2-17, 214:6-10

Petitioner's Reply Argument Fails: Unlike Spiers' PCI Card, The PCI Riser Board Does Not Have A Memory

FB-DIMM Topologies

DIMMs on a Riser Card



No memory on riser board

EX1075 (Mangione-Smith) 223:24-225:9 (discussing EX2101, p.14, "Q: Is the memory riser board part of that memory module? A: No, it's not.").

TOPICS

GROUND 1-3

Harris Does Not Receive Power Via Edge Connections

Harris Does Not Receive The Recited Signals From the Host

A POSITA Would Not Have Used the Required # of (Buck) Converters

Ground 2 ASSUMES Separate Converters To Supply Each FBDIMM-Required Voltage

A POSITA Would Not Have Replaced Harris' Redundant Power

Additional Reasons Why Dependent Claims Are Not Obvious

GROUND 4-5

The Recited "Memory Module" Means A Main Memory Module

Spiers' PCI Card Is Not a Main Memory Module

POSITA Would Not Use DDR2/DDR3 or Recited # of (Buck) Converters

Additional Reasons Why Dependent Claims Are Not Obvious

Ground 4 Requires Modifying Spiers With DDR2/DDR3 Modules

Ground 4: Spiers in view of Amidi, with DDR2 or DDR3 DRAMs

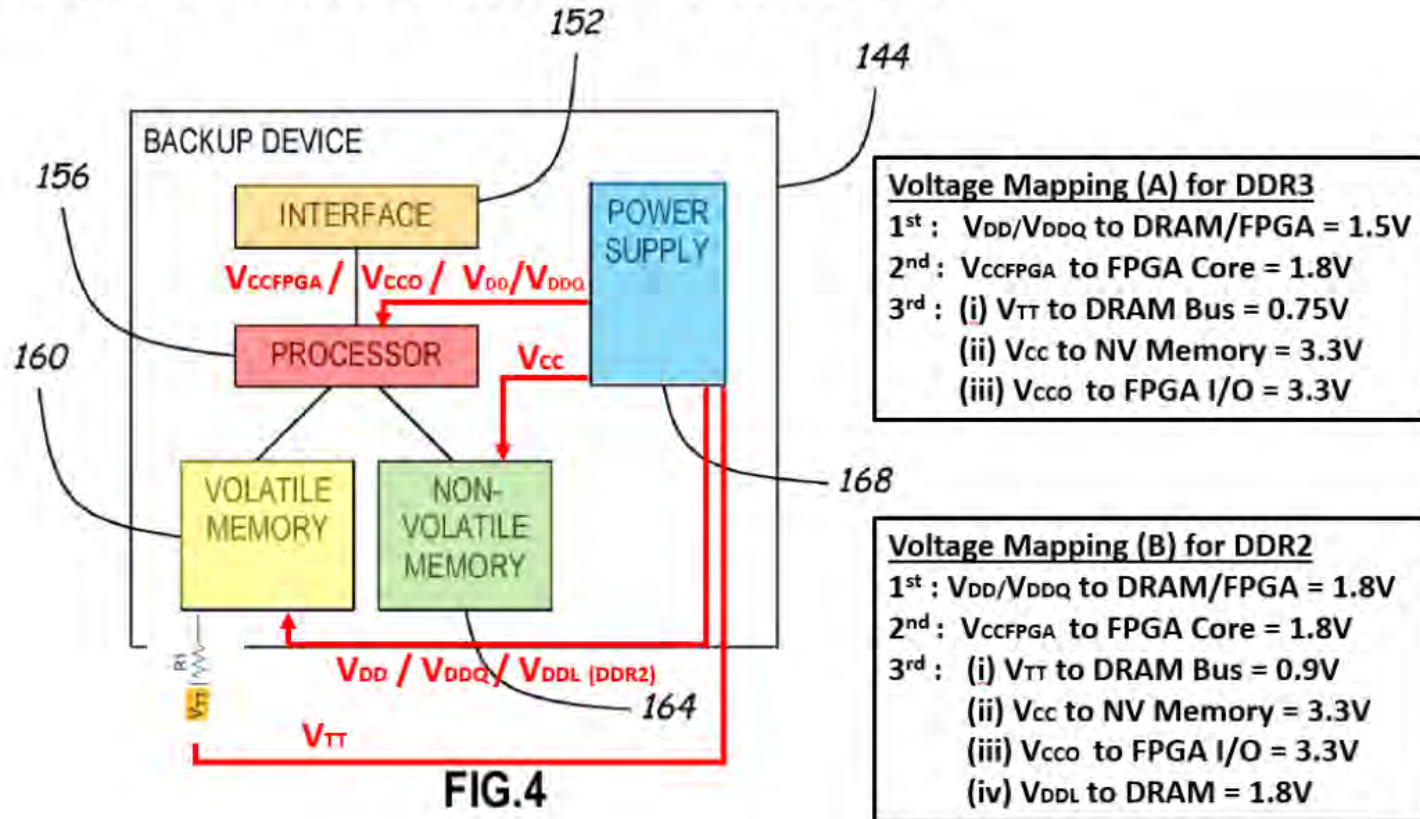
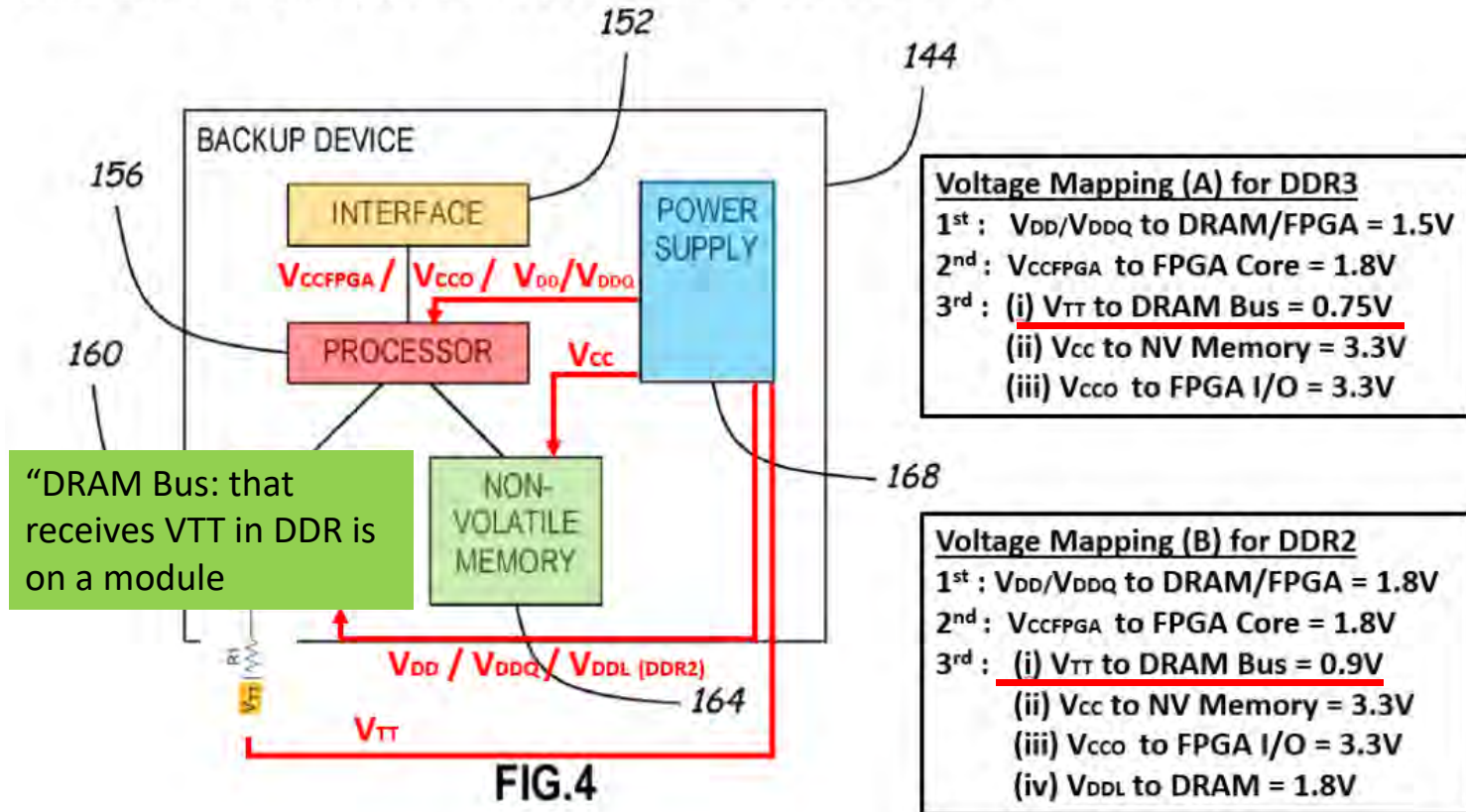


FIG. 4

Ground 4 Requires Modifying Spiers With DDR2/DDR3 Modules

Ground 4: Spiers in view of Amidi, with DDR2 or DDR3 DRAMs



JEDEC STANDARD

FBDIMM: Advanced Memory Buffer (AMB)

3.3 Command / Address Outputs

The DDR2 command and address signals are terminated to 0.9V on the DIMM. In order to reduce power, this termination is performed using series resistors to a V_{tt} power supply, which is generated by voltage regulators on the system board and provided to the DIMM via connector pins. This power supply must be capable of sourcing and syncing current.

EX 1027, at 20.

Petition Incorporates JEDEC Specifications Into Grounds 4/5

DDR2/DDR3 not
in proposed
combinations

B. Identification of Challenge (§42.104(b))

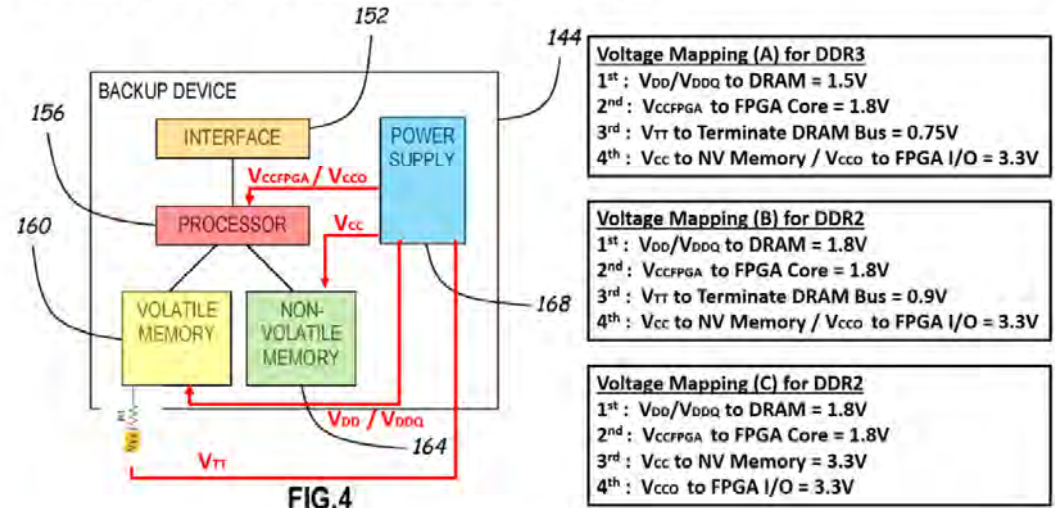
Petitioner challenges claims 1-30 of the 918 Patent as follows:

Ground	Claims Challenged	35 U.S.C. §	References
1	1-3, 8, 14-15, 23	103(a)	Harris + FBDIMM Standards
2	1-30	103(a)	Ground 1 + Amidi
3	1-30	103(a)	Ground 2 + Hajeck
4	1-30	103(a)	Spiers+Amidi
5	1-30	103(a)	Ground 4 + Hajeck

Discussing JEDEC
Specifications

a fourth voltage amplitude [“4th”/“fourth” below],” when backup device 144 is implemented with DDR3 or DDR2 DRAMs as shown in Voltage Mappings A and B-C, respectively, below:

Ground 4: Spiers in view of Amidi, with DDR2 or DDR3 DRAMs



See supra pp. 78-81 EX1003, ¶¶655-700.

Petition Incorporates JEDEC Specifications Into Grounds 4/5

660. As previously explained, a Skilled Artisan would understand that JESD79-3A specifies a VDD/VDDQ power supply voltage of 1.5 volts for DDR3 DRAMs (i.e., the “*first regulated voltage*” for Mapping A of Grounds 4 and 5). Ex. 1046 at p.10. Similarly, she would understand that JESD79-2B specifies a VDD/VDDQ of 1.8 volts for DDR2 DRAMs (i.e., the “*first regulated voltage*” for Mappings B and C of Grounds 4 and 5). Ex. 1026 at p.7.

EX 1003 (Wolfe), ¶1660.

Spiers' Figure 4 Embodiment Does Not Use Regulators (And Is Not Relied On)

Patent Owner's argument assumes that Spiers is limited to a PCI interface, but a PCI backup device is described as one embodiment in Spiers.

Ex. 1025 ¶ 19. Spiers also discloses an “interface 152” in more general terms, which does not appear limited to a PCI interface. *Id.* ¶ 36. Patent Institution Decision (918) at 44.

Petitioner does not rely on the FIG. 4 embodiment for any independent claims

[0036] Referring now to FIG. 4, a block diagram illustration of a backup device 144 of an embodiment is now described. In this embodiment, the backup device comprises an interface 152, a backup device processor 156, a volatile memory 160, a non-volatile memory 164, and a power supply 168. The interface 152 may be any type of interface and is utilized to communicate with the storage controller 132. The interface 152 is connected to the processor 156, which controls operations within the backup device 144. Connected to the processor 156 are the volatile memory 160 and the non-volatile memory 164. The volatile memory 160, in one embodiment, is SDRAM utilized to store data from the storage controller 132 during typical write operations. The non-volatile memory 164, in one embodiment, is flash memory, and is utilized in the event of a power failure detection. As is understood, flash memory is a type of nonvolatile memory that may be erased and reprogrammed in units of memory referred to as blocks or pages. The processor 156, in this embodiment, upon detecting a power failure, switches the backup device 144 to the power supply 168, and moves the data in the volatile memory 160 to the non-volatile memory 164. After the data from the volatile memory 160 is stored in the non-volatile memory 164, the processor 156 shuts down the backup device 144. The power supply 168, in one embodiment, includes one or more capacitors that are charged when the backup device 144 is powered up. In the event of a power interruption, the backup device 144 receives power from the capacitor(s) when moving the data. After the data is securely stored in the non-volatile memory 164, the power is switched off from the capacitor(s). In another embodiment, the power supply 168 includes one or more batteries. As will be understood, any type of power supply 168 may be utilized, so long as power may be supplied to the backup device 144 for a sufficient time period to move the data to the non-volatile memory 164. EX1025 (Spiers) at [0036].

Spiers' PCI interface Is The Data Transfer Bottleneck – No Reason To Use Faster DDR2/DDR3 In Place of Spiers' SDRAM



**William
Mangione-Smith**
Netlist's Expert



145. As such, during a power failure (or during data restore), the rate at which data is transferred from the SDRAM to the NAND is not limited by the SDRAMs. Therefore, for both data transfer between the host and SDRAM via the PCI interface during normal operation, as well as data transfer between SDRAM and NVRAM during power interruption, the bottleneck in data transfer is not SDRAMs.

EX2031 (Mangione-Smith Declaration), ¶145.

The Reply does not dispute Dr. Mangione-Smith's detailed calculations (EX1003, ¶¶141-145) showing that Spiers' PCI interface was the bottleneck for data transfer

Dr. Mangione-Smith's Detailed Unrebutted Detailed Calculations Showing Spiers' PCI Interface Is The Bottleneck For Data Transfer



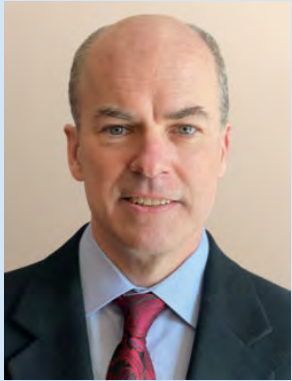
**William
Mangione-Smith**
Netlist's Expert



142. Given that the clock speed of PCI is up to 66 MHz, a 66MHz PCI card having a 64-bit wide bus⁷ has a peak data transfer rate of 528 MB/s, because there are 8 bits per byte, so 64 bits equals $64/8 = 8$ bytes. So, if we transmit 8 bytes at the rate of 66 MHz, this translates to a peak data transfer rate of $66\text{M transfers/s} \times 8 \text{ byte/transfer} = 528 \text{ MB/s}$. See EX2016 [2006 EURESYS Tech Notes] at 4 (66MHz, 64 bit PCI card, the maximum for a PCI card, has a peak data rate of 528 MB/s and a practical data rate of 360 MB/s). Some references put the peak transfer rate at a slightly higher value of 532 MB/s. EX2029 at 6. This is because 66MHz is not a precise number; and the actual clock speed is slightly higher.

EX2031 (Mangione-Smith Declaration), ¶142.

Continue Dr. Mangione-Smith's Detailed Unrebutted Detailed Calculations Showing Spiers' PCI Interface Is The Bottleneck For Data Transfer

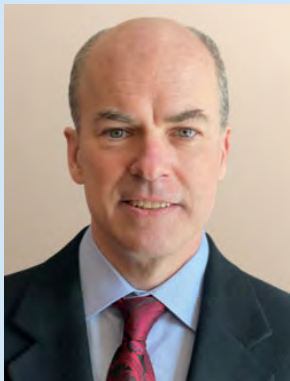


**William
Mangione-Smith**
Netlist's Expert



143. Compared to PCI bus peak transfer rate of 528 MB/s, at the time of the invention, SDRAMs were operating in the range of 66-166 MHz. See EX2012 [NXP 2007 Note] (describing 66-133 MHz SDRAMs); EX2014 [Qimonda PC166 datasheets] at 3 (166MHz SDRAMs); EX2017 [Qimonda] at 3 (same). These clock rates correspond to maximum transfer rates of 533-1328 MB/s. This is obtained by multiplying the SDRAM operating speed (i.e. 66.66⁸- 166 MHz) by 8, since 8 bytes are transmitted in each transfer. See EX2012 [BeyondBits2article17.pdf (nxp.com)], Table 1) (maximum transfer rates for PC66, PC100 and PC133 SDRAMs are 533 MB/s, 800 MB/s and 1066 MB/s respectively, or 8 times the clock rates); EX2018 [Transcend FAQ296] (100-166MHz SDRAM provides data transfer rate of 0.8-1.3 GB/s or 800-1300 MB/s). As such, Spiers' SDR SDRAM's data rate would exceed that of Spiers' PCI interface. That is, when data is transferred between a host and SDRAM via PCI, the bottleneck is at the PCI interface and not at the SDR SDRAMs.

Continue Dr. Mangione-Smith's Detailed Unrebutted Detailed Calculations Showing Spiers' PCI Interface Is The Bottleneck For Data Transfer



**William
Mangione-Smith**
Netlist's Expert



144. I also note that SDRAM's data rate also far exceeds that of NAND flash. For example, according to Petitioner's submitted evidence, NAND flash can program "[t]he content of each 2,112-byte page ... in 300 μ s." EX1049, p. 7. This translates to a data rate of about 7 MB/s, i.e., $2,112 \text{ byte} \div 300\mu\text{s} = 7\text{MB/s}$.

145. As such, during a power failure (or during data restore), the rate at which data is transferred from the SDRAM to the NAND is not limited by the SDRAMs. Therefore, for both data transfer between the host and SDRAM via the PCI interface during normal operation, as well as data transfer between SDRAM and NVRAM during power interruption, the bottleneck in data transfer is not SDRAMs.

EX2031 (Mangione-Smith Declaration), ¶144-145.

No Evidence that the Application Suitable for Usage of DDR

NP

Joaquín Romo

DDR Memories

Comparison and overview

We realize that one of the most important aspects of a computer is its capability to store large amounts of information in what we normally call "memory." Specifically, it's random access memory (RAM), and it holds volatile information that can be accessed quickly and directly. And considering the ever-growing system need for speed and efficiency, understanding double-data-rate (DDR) memory is important to system developers.

With improvements in processor speeds, RAM memory has evolved into high-performance RAM chips called DDR synchronous dynamic RAM (SDRAM). It doubles the processing rate by making a data fetch on both the rising and falling edge of a clock cycle. This is in contrast to the older single-data-rate (SDR) SDRAM that makes a data fetch on only one edge of the clock cycle.

In addition to well-known computer applications, DDR memories are widely used in other high-speed, memory-demanding applications, such as graphic cards, which need to process a large amount of information in a very short time to achieve the best graphics processing efficiency. Blade servers using many blades, or single-purpose boards, covered by a single, more efficient power supply also need fast memory access. This allows the blades to quickly transmit reliable information among each other and create greater opportunities to reduce power consumption. Memory devices are also required in networking and communications applications with tasks ranging from stream address lookups to traffic shaping, policing, and buffer management.

This article describes the main characteristics of DDR memories as well as the specifications of power supplies required for these types.

DDR Memory Characteristics

DDR memory's primary advantage is the ability to fetch data on both the rising and falling edge of a clock cycle, doubling the data rate for a given clock frequency. For example, in a DDR20 device the data transfer frequency is 200 MHz, but the bus speed is 100 MHz.

DDR1, DDR2 and DDR3 memories are powered up with 2.5, 1.8 and 1.5V supply voltages respectively, thus producing less heat and providing more efficiency in power management than normal SDRAM chips, which use 3.3V.

Temperatization is another characteristic of DDR memories.

Memory temperatization is given through a series of numbers, such as 2-3-2-6-T1, 3-4-4-8 or 2-3-2-5 for DDR1. These numbers indicate the number of clock pulses that it takes the memory to perform a certain operation—the smaller the number, the faster the memory.

The operations that these numbers represent are the following: CL - SRCD - RSP - SRAS - CMD. To understand them, you have to keep in mind that the memory is internally organized as a matrix, where the data is stored at the intersection of the rows and columns.

- CL: Column address strobe (CAS) latency is the time it takes between the processor asking memory for data and memory returning it.
- SRCD: Row address strobe (RAS) to CAS delay is the time it takes between the activation of the row (RAS) and the column (CAS) where data is stored in the matrix.
- RSP: RAS precharge is the time between disabling the access to a row of data and the beginning of the access to another row of data.
- SRAS: Active to precharge delay is how long the memory has to wait until the next access to memory can be initiated.
- CMD: Command rate is the time between the memory chip activation and when the first command may be sent to the memory. Sometimes this value is not informed, it usually is T1 (1 clock speed) or T2 (2 clock speeds).

Table 1 is a comparison of clock and transfer rates for the SDRAM memory chips that can be found in today's computers, including DDR, DDR2, DDR3 and future DDR3 modules.

Netlist Ex 2013

Samsung, Netlist

IP2022_0096

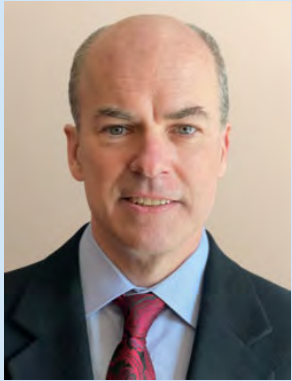
79 | www.patent.gov.br/ptdocs

Typical Applications of DDRx Memories

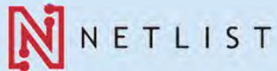
Market analyses indicate that DDR is currently utilized in over 50 percent of all electronic systems, and usage is expected to increase to 80 percent over the next several years. **DDR is not, and will never be, an “all things to all designs” technology. DDR memory is well suited for those designs that have a high read to write ratio. Quad-data-rate memory, for example, is designed for applications that require a 50 percent read/write ratio.**

EX2012, p. 73

Spiers' Application Has High Write-to-Read Ratio



**William
Mangione-Smith**
Netlist's Expert



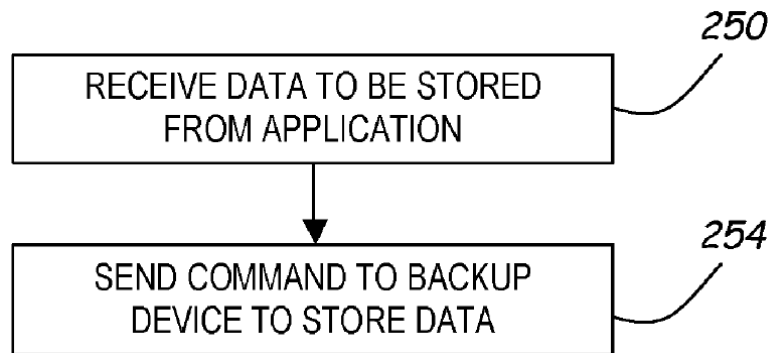
147. DDR2/DDR3 is not an “all things to all designs technology,” but was specifically designed for high *read-to-write* ratio applications. See EX2012 [[BeyondBits2article17.pdf \(nxp.com\)](#)] at 73 (“DDR memory is well suited for those designs that have a high read to write ratio.”) **In contrast, Spiers’ application has high write-to-read ratio, or a *low read-to-write ratio*.** First, writes to SDRAM in

EX2031 (Mangione-Smith Declaration), ¶147.

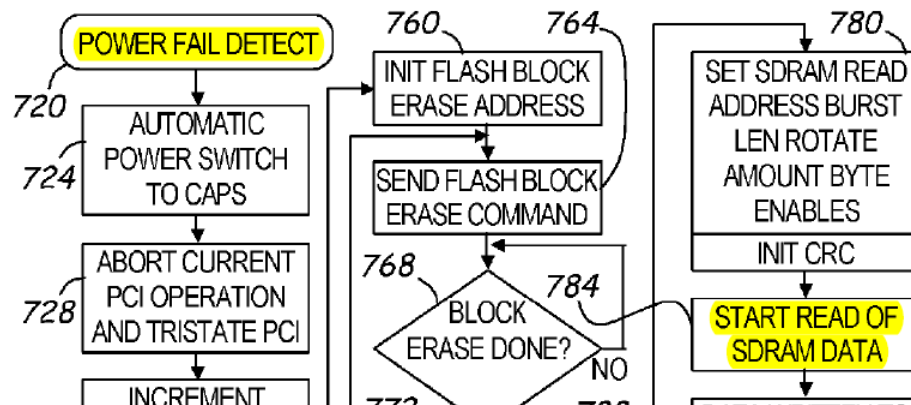
- Dr. Mangione-Smith explained that Spiers’ SDRAM is only read in case of a restore or a power interruption (which is rare), but writes occur with every system write (which is frequent). Id., ¶147

Spiers' Application Has A High Write-to-Read Ratio

Spiers' sends all received data to be stored (written) to the backup device



Spiers' reads SDRAM data only to restore (e.g, following power failure)



[0040] Referring now to the flow chart diagram of FIG. 6, the operational steps performed by a NAS device of an embodiment of the present invention are now described. In this embodiment, the NAS device receives data to be stored from an application, as noted at block 250. At block 254, the NAS device sends a command to the backup device to store the data. The NAS device, at block 258, determines if the

[0054] Referring now to FIG. 14, the operational steps performed by the backup device upon detection of a power failure are now described. As discussed previously, the

Petitioner's New PCI-X Reply Argument



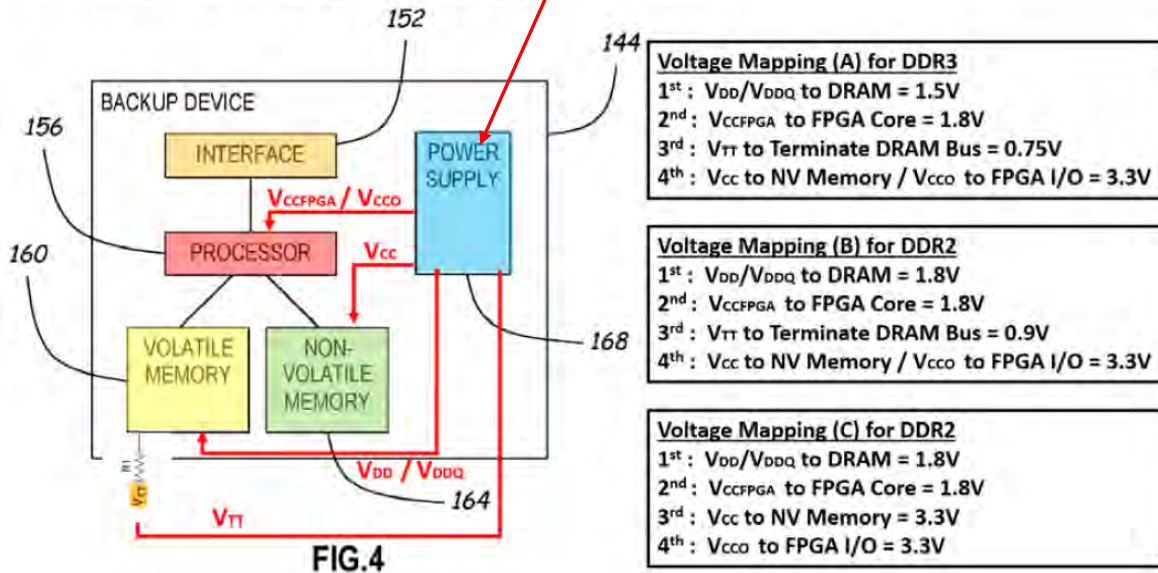
- The Petition's analysis and Spiers' disclosure are specific to PCI, and **neither mentions PCI-X**.
- Requires a new modification of Spiers, which is **impermissible**
- Even with an improper new modification of Spiers to use PCI-X, there is **no evidence showing all limitations are met with PCI-X**.
 - Dr. Wolfe provides details only about how a PCI bus satisfies various limitations. EX1003, ¶¶604-608

Petitioner Only Suggests Incorporating Regulators On The PCI Card, Not On The DDR2/DDR3 Memory Modules

Regulators providing alleged regulated voltages are not on Spiers' "volatile memory" or "non-volatile memory" modules

'918 Patent, Claim 1

Ground 4: Spiers in view of Amidi, with DDR2 or DDR3 DRAMs



1. A memory module comprising:
 - a printed circuit board (PCB) having an interface configured to fit into a corresponding slot connector of a host system, the interface including a plurality of edge connections configured to couple power, data, address and control signals between the memory module and the host system;
 - a first buck converter configured to provide a first regulated voltage having a first voltage amplitude;
 - a second buck converter configured to provide a second regulated voltage having a second voltage amplitude;
 - a third buck converter configured to provide a third regulated voltage having a third voltage amplitude;
 - a converter circuit configured to provide a fourth regulated voltage having a fourth voltage amplitude; and

No Reason for Buck Converter for VTT

Petition at 90

“[I]t would have been obvious to a POSITA to use “buck converter[s]” to provide each of these regulated voltages from the +5V power supply in order to achieve high efficiency, reliability, and flexible power conversion, as discussed previously.”

- **Cited EX1046, p.109 and EX1026, p.7 “relate to when there is AC output measurement and/or device-under-test condition”**
 - VTT can also be generated via passive termination (no regulator used) (FBDIMM used VTT for power saving)
- **Cited FBDIMM not suitable for PCI (Spiers’ 4 memory modules would require more than 35W if FBDIMM, while PCI card can only provide up to 25W)(EX1031, p. 137; EX2047, p. 20; EX2031, ¶150)**
- **Commercially available dual buck for DDR1, not DDR2/DDR3 VDD & VTT**
 - EX1047: DDR1 VTT termination, but DDR2/DDR3 uses on-die-termination, not motherboard termination as in DDR1

Alleged Reasons for Multiple Converters for 1.8V Inapplicable to Spiers

No evidence
of analog
voltages

FBDIMM
does not run
at hundreds
of amperes

Many devices share standard voltage levels (such as 3.3 V), while others may require device-specific voltages. In addition, a particular standard voltage level may have to be independently furnished in numerous places. For example, separate analog- and digital supplies, such as 3.3 V_{ANALOG} and 3.3 V_{DIGITAL}, may be required. Generating the same voltage numerous times may be necessary to improve efficiency (e.g., memory rails running at hundreds of amperes) or to meet sequencing requirements (3.3 V_A and 3.3 V_B needed by separate devices at different times). All of

EX1062 (Power-Supply Management—Principles, Problems, and Parts) at 13.

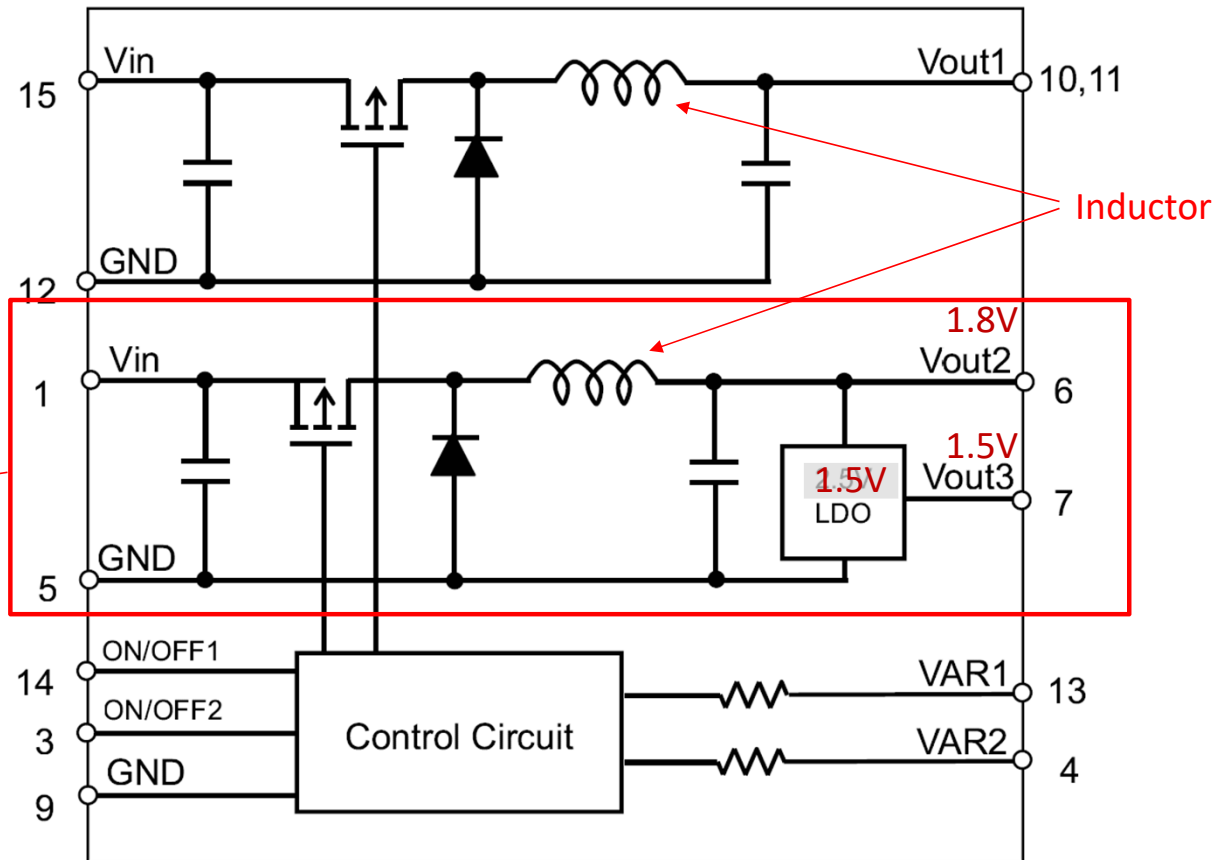
VDD, VDDL, and VDDQ are each
supplied to the same devices

No Need for Multiple Buck Converters for 1.8V and 1.5V

A buck converter needs “an LC-filter just after the power switch ...”
EX2020, p.22. Thus, the number of inductors reflects the number of buck converters.

See EX1078, 12 (LC filter); EX1075, 129:13-19.

Single Buck Converter



EX1048, 2 (shows two buck converters, each with its own inductor).

Evidence Shows Using LDO for 5V-1.8V and 5V-3.3 Conversion

The Petition

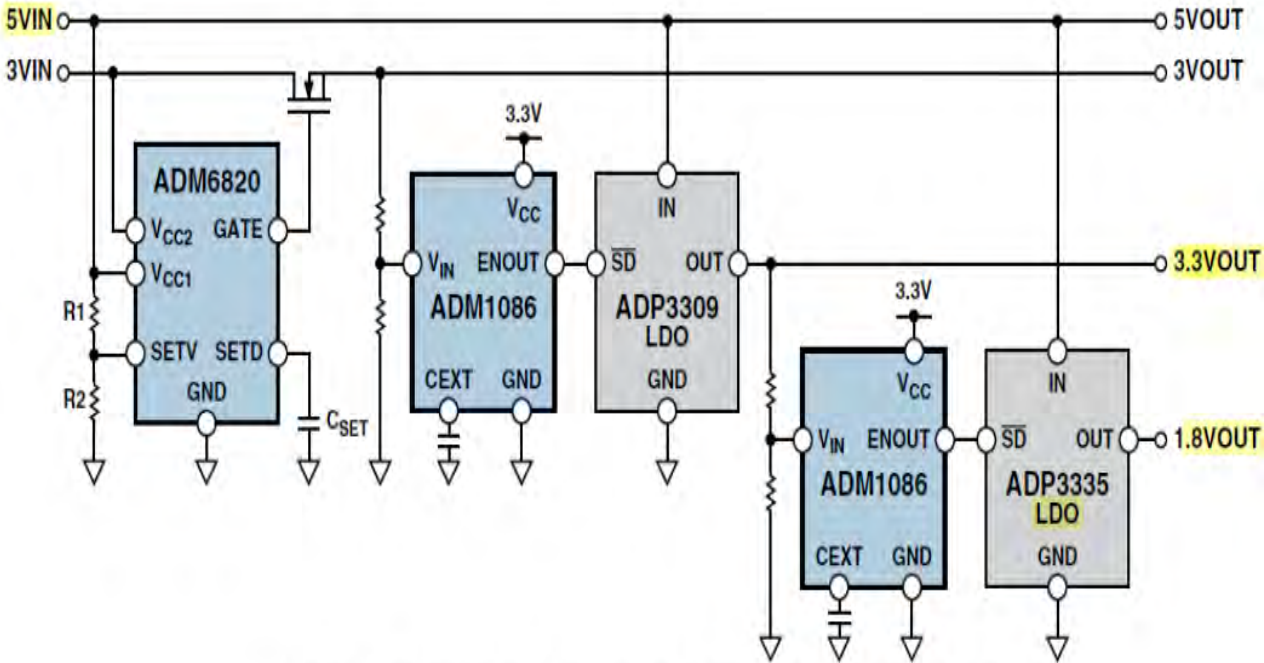


Figure 3. Sequencing a four-supply system with monitoring ICs.

	Voltage Mappings (Grounds 4-5)		
	<u>A</u>	<u>B</u>	<u>C</u>
“first”:	$V_{DD}/V_{DDQ}=1.5V$	$V_{DD}/V_{DDQ}=1.8V$	$V_{DD}/V_{DDQ}=1.8V$
“second”:	$V_{CCPGA}=1.8V$	$V_{CCPGA}=1.8V$	$V_{CCPGA}=1.8V$
“third”:	$V_{TT}=0.75V$	$V_{TT}=0.9V$	$V_{CC}=3.3V$
“fourth”:	V_{CC} or $V_{CCO} = 3.3V$	V_{CC} or $V_{CCO} = 3.3V$	$V_{CCO}=3.3V$

“it would have been obvious to a POSITA to use “buck converter[s]” to provide each of these regulated voltages from the +5V power supply in order to achieve high efficiency, reliability, and flexible power conversion”

Petition at 87. 90.

Buck Converter Unsuitable for 5V-3.3V Backup Regulator

Unrebutted:

- Voltage oscillation in low load condition (EX2021, 5; EX2031, ¶¶157-159)
- Start-up time too long to maintain the content in the DRAM cells
 - Dr. Wolfe admits that “the **start time of a buck converter** ... may be **thousands of microseconds.**” EX1003, ¶818; EX1041, 10 (buck converter initialization and soft start measured “**in seconds**”); EX2022
 - **SDRAM**’s standard refresh rate, however, is **15.6μs**. EX2025, 1; EX2031, ¶176

Petitioner’s own evidence also shows buck converters are unsuitable:

- EX1048 has an “Input Voltage Range” of “4.5 to 13.2V.”
- During backup, super-cap’s voltage may drop below 4.5V, at which point buck converter would stop operating. EX2031, ¶164 (voltage drops during super-cap discharge)
- LDO would operate for entire 3.3V-5V range (EX2031, ¶159)(LDO operation not impacted by low voltage)

TOPICS

GROUND 1-3

Harris Does Not Receive Power Via Edge Connections

Harris Does Not Receive The Recited Signals From the Host

A POSITA Would Not Have Used the Required # of (Buck) Converters

Ground 2 ASSUMES Separate Converters To Supply Each FBDIMM-Required Voltage

A POSITA Would Not Have Replaced Harris' Redundant Power

Additional Reasons Why Dependent Claims Are Not Obvious

GROUND 4-5

The Recited "Memory Module" Means A Main Memory Module

Spiers' PCI Card Is Not a Main Memory Module

POSITA Would Not Use DDR2/DDR3 or Recited # of (Buck) Converters

Additional Reasons Why Dependent Claims Are Not Obvious

Dependent Claim 13 – Dr. Wolfe Relies On The +5V PCI Supply Voltage During Normal Operation

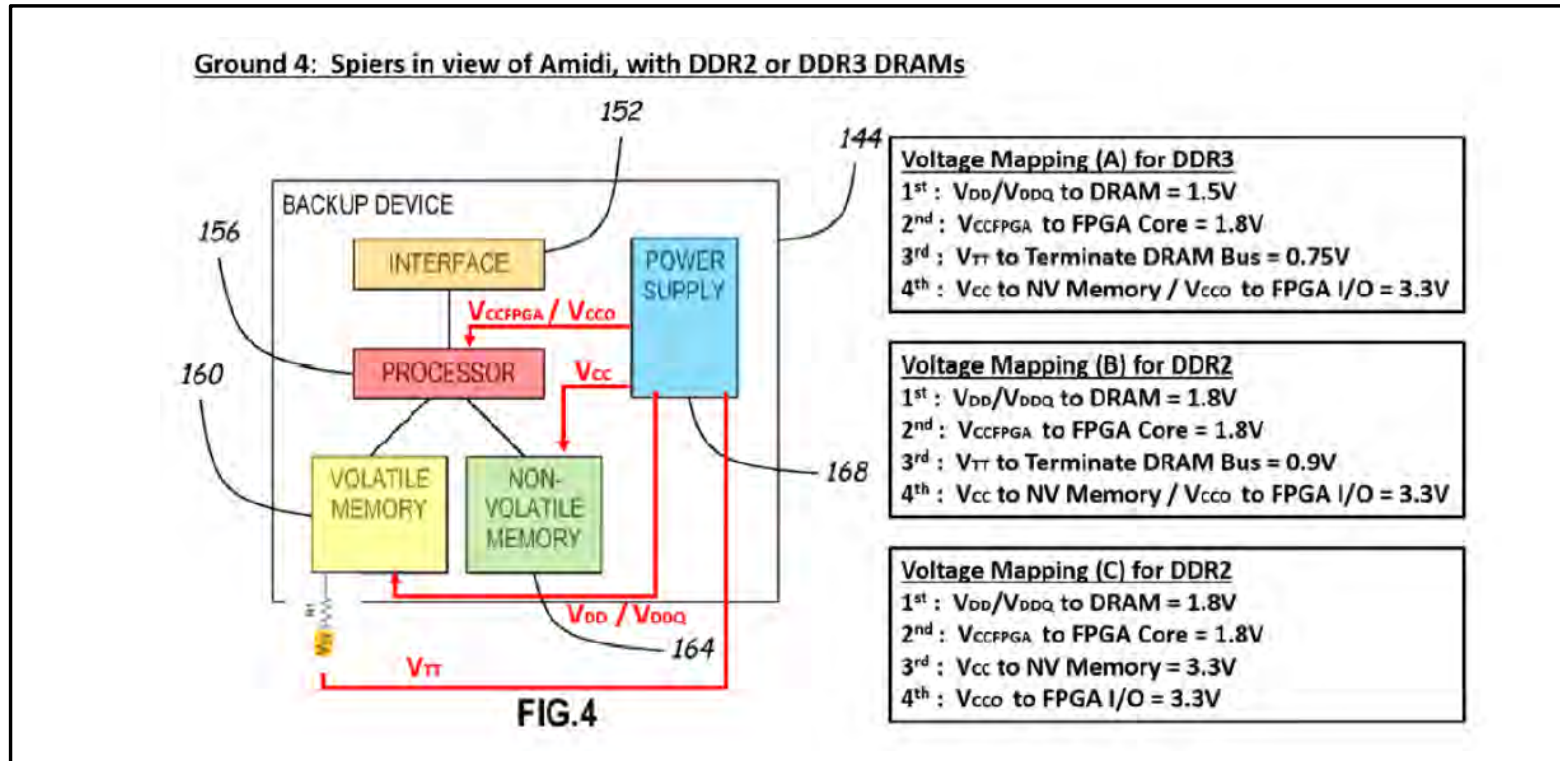
13. The memory module of claim 5, wherein the power input voltage is coupled to the first, second, and third buck converters and the converter circuit.

863. For the reasons discussed above with reference to claim limitations [1.c] (“a first buck converter . . .”), [1.d] (“a second buck converter . . .”), [1.e] (“a third buck converter . . .”), [1.f] (“a converter circuit . . .”) and claim 5, Spiers in view of Amidi teaches and discloses to a Skilled Artisan that the +5V power input voltage is coupled to the “first,” “second,” and “third buck converter[s]” and the “converter circuit” when the voltage amplitude of the input voltage is in a normal operating range. *Supra* ¶¶655-666 (claim limitation [1.c]), ¶¶668-676 (claim limitation [1.d]), ¶¶677-687 (claim limitation [1.e]), ¶¶689-700 (claim limitation [1.f]), ¶¶764-780 (claim 5).

EX1003, ¶863.

Dr. Wolfe's Analysis of Claim 13 Is Inconsistent With His Voltage Mappings

Dr. Wolfe's reliance on Spiers' +5V PCI supply voltage for the "power input voltage" of claim 13 is inconsistent with the voltage mappings below, where the power supply Element 168 is used during **power failure**. EX1003, ¶¶ 657-659; EX1025, [0036].



Dependent Claims 5-7, 8-14, 16-22, 24-27, 30 Are Not Obvious

- Same reason as for Ground 1-3
- Input over-voltage not an anomaly that would have caused DRAM data loss
 - Upper limit for converters' input voltage is much higher than the expected tolerance range
- Hajeck's charge pump continues to operate when over-voltage occurs